

Development of Large Area Microchannel Plate Photodetectors

for the Large Area Picosecond Photodetector Development Collaboration

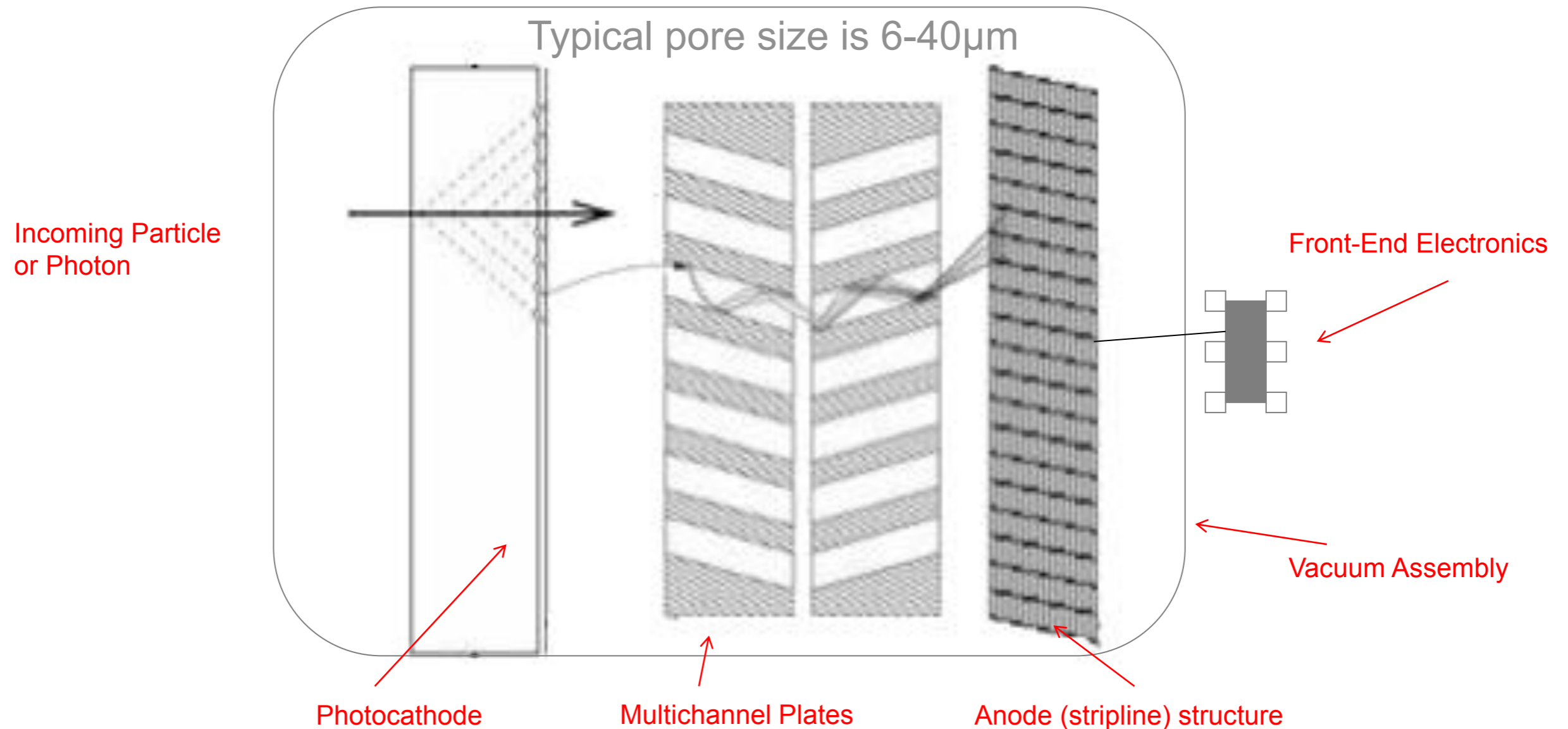
Bob Wagner, Argonne National Laboratory

Antiproton Physics at the Intensity Frontier

Fermilab

Friday 18 Nov 2011

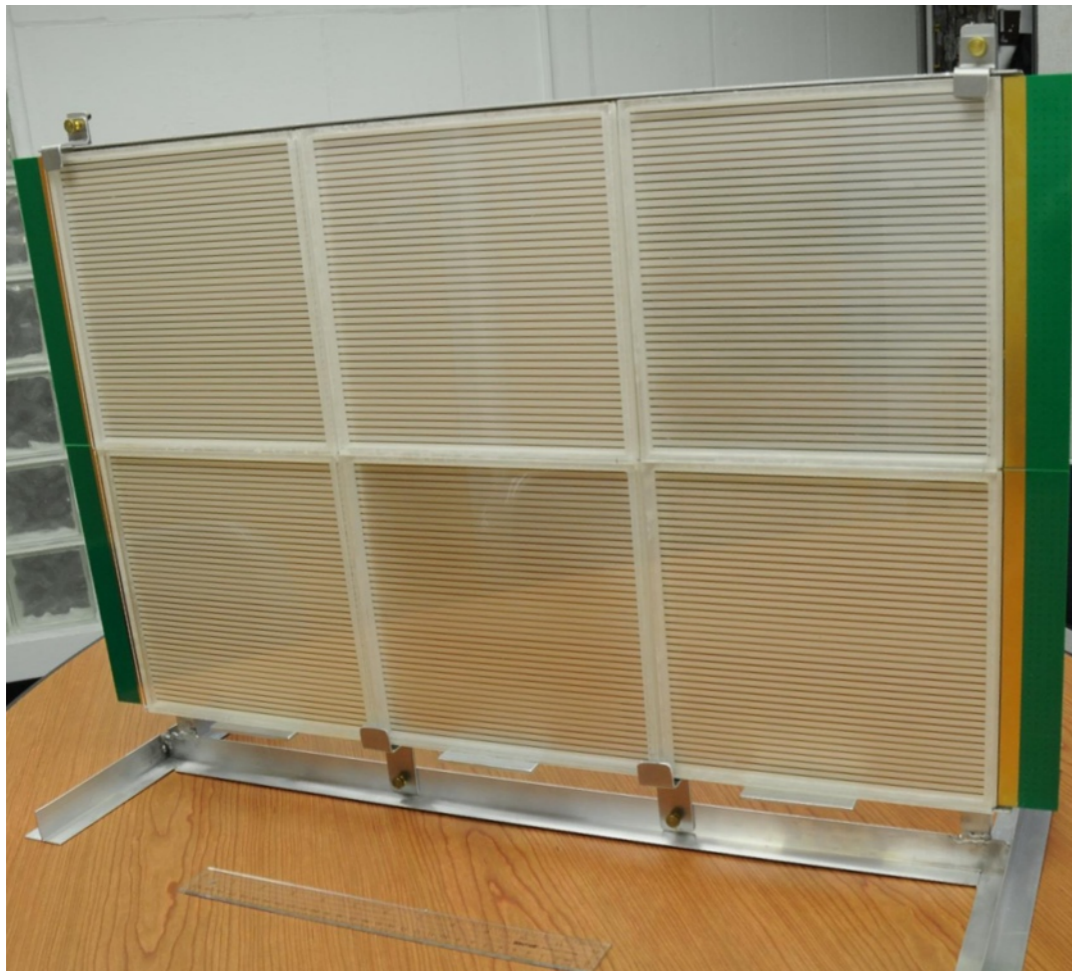
Microchannel Plate Photomultipliers



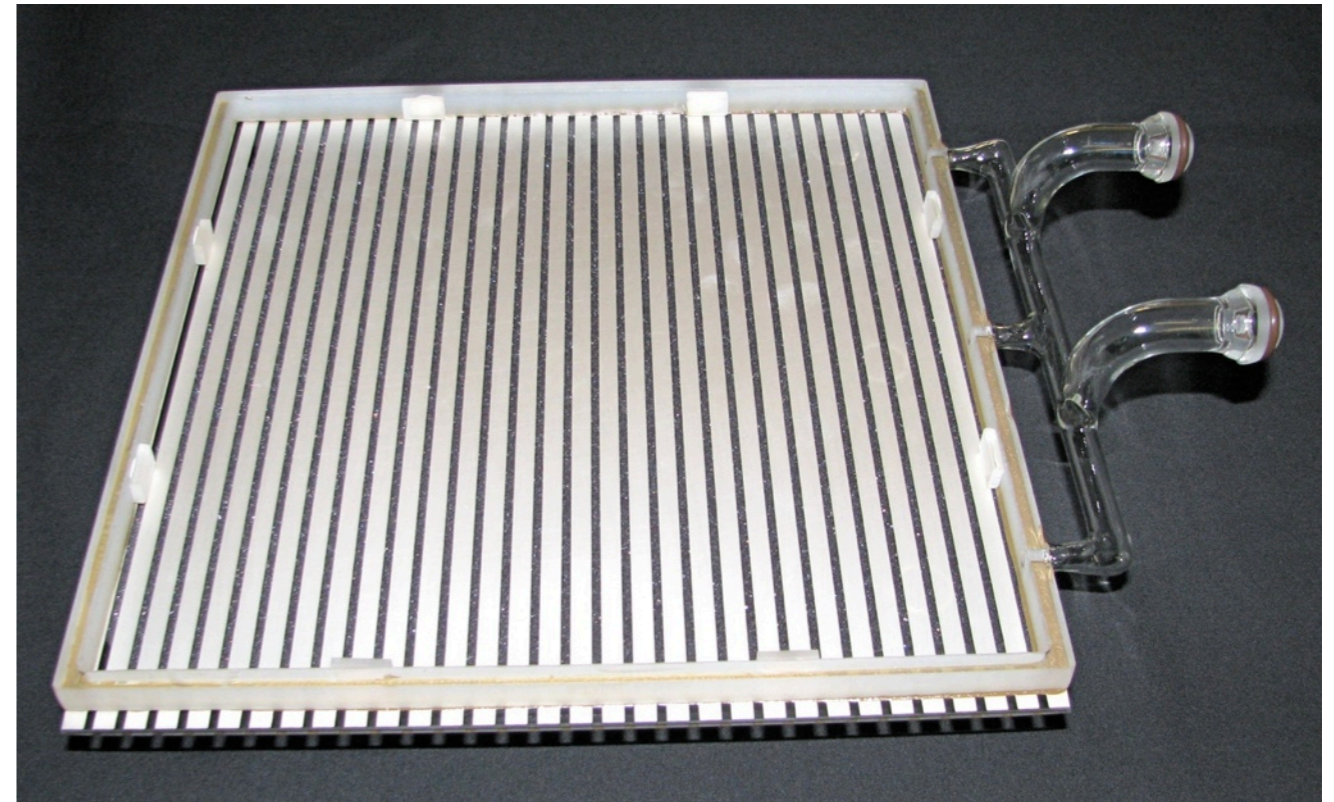
Multiple plates to increase gain

Chevron arrangement to inhibit positive ion freeback to photocathode

MCP-PMT Module & Readout Concept



2×3 array of MCP Tiles
for paneling detector, e.g.
water Cherenkov tank



Strip readout pattern

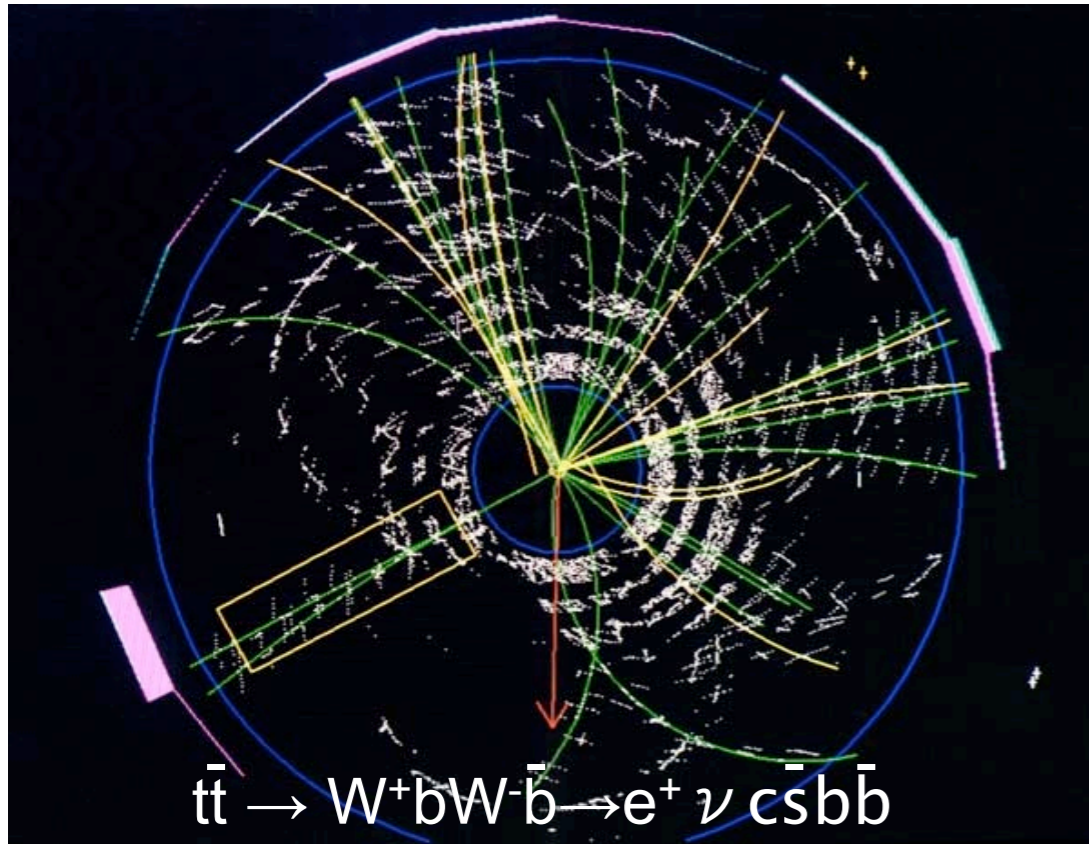
3.8mm strips, 5mm pitch (40 strip anode)

4.6mm strips, 6.8mm pitch (30 strip anode)

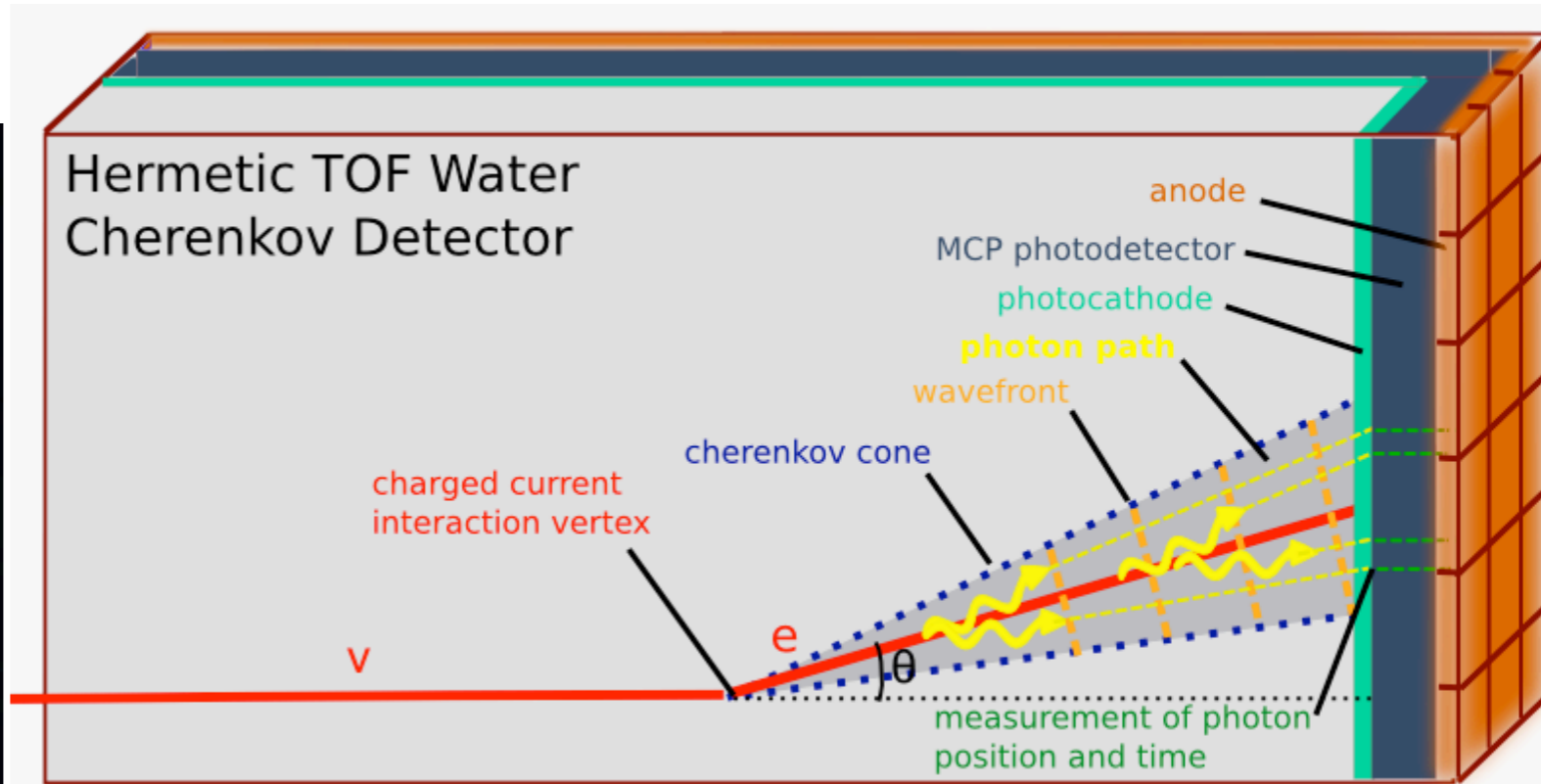
Coordinate readout:

- Time difference along strip
- Charge division for \perp direction

Motivation



Complete particle measurement: E, p + m(PID)
1ps time & 1mm space resolution, \$100k/m²



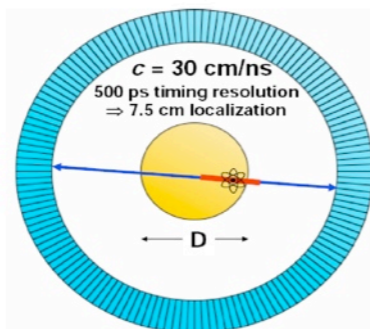
Water Cherenkov neutrino detector (LBNE) ~80-90% coverage and 3-d photon vertex reconstruction
100ps time & 10mm space resolution, \$10k/m²

TOF (Effective Efficiency) Gain for Whole-Body PET (35 cm)

Hardware	Δt (ps)	TOF Gain
BGO Block Detector	3000	0.8
LSO Block (non-TOF)	1400	1.7
LSO Block (TOF)	550	4.2
LaBr ₃ Block	350	6.7
LSO Side Coupled	250	9.3
LSO Small Crystal	210	11.1
LuI ₃ Small Crystal	125	18.7
LaBr ₃ Small Crystal	70	33.3

• **Incredible Gains Predicted**
• **Nothing Else Can Give Us Gains of This Size!**

Time-of-Flight in PET



- Can localize source along line of flight.
- Time of flight information reduces **noise** in images.
- Variance reduction given by $2D/c\Delta t$.
- 500 ps timing resolution \Rightarrow 5x reduction in variance!

• Time of Flight Provides a **Huge** Performance Increase!
• Largest Improvement in Large Patients

Bill Moses (LBNL)
Large Area Picosecond
Photodetector Workshop,
Clermont-Ferrand, Jan 2010

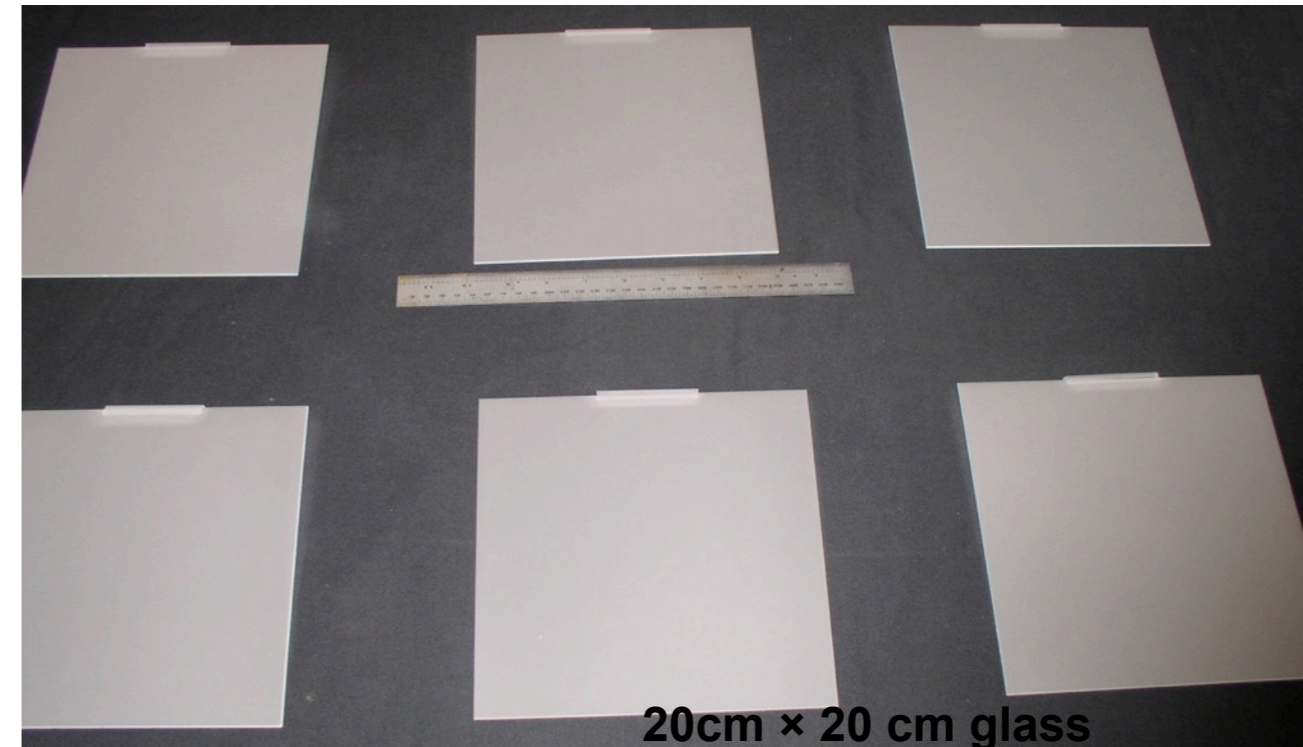
LAPPD Project Scope

Large, Cheap, Fast Microchannel Plate Photomultiplier

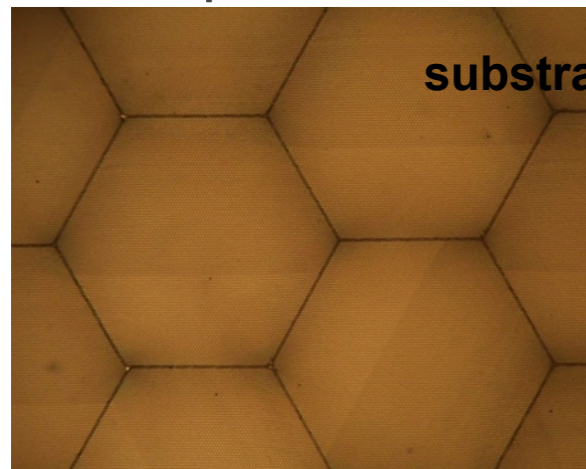
- ▶ 20×20 cm² active area (development on 3.3cm diam. disk)
- ▶ Novel, inexpensive MCP substrate
 - Borofloat glass capillary substrates (20–40μm pores, L/D ~60–40)
 - Anodic aluminum oxide (AAO) (research ended) -- ceramic
- ▶ Pore activation via Atomic Layer Deposition (ALD)
 - Separate material for resistive and secondary emission layers
 - Optimize resistive and emissive layers via study of range of materials
- ▶ Customized anode readout
 - Strip line double-ended readout for picosecond timing & water Cherenkov
 - Pad readout for energy and/or coarse spatial resolution -- gamma-ray telescope camera, dual readout calorimeters, medical imaging
- ▶ High quantum efficiency photocathode --- $\geq 25\%$
 - Alkali (baseline), multialkali
 - “III–V” materials, e.g. GaAs, GaN
 - Systematic program of photocathode development and analysis
- ▶ Waveform sampling switched capacitor array ASIC for readout
- ▶ Use simulation to vet and tune design

Glass Capillary Substrate Development

- Borosilicate glass capillary substrates from Incom, Inc. (Charlton, MA, USA)
- Technology development on 32.8mm diameter disk substrates
 - 20 μ m (L/D=60) & 40 μ m (L/D=40) pore size
- 20cm \times 20cm plates for working detector
 - (18) 40 μ m pore substrates delivered
 - (35) 20 μ m pore substrates delivered
 - Baseline is 20 μ m pore
- All substrate pores have 8 $^\circ$ bias w.r.t axis \perp to substrate
 - Used in pair chevron configuration to reduce positive ion feedback damage to photocathode



20cm \times 20 cm glass substrates October, 2011



substrate detail 2010



substrate detail August, 2011

photo credit: Joe Gregar, Argonne

photo credit: Jason McPhate, SSL

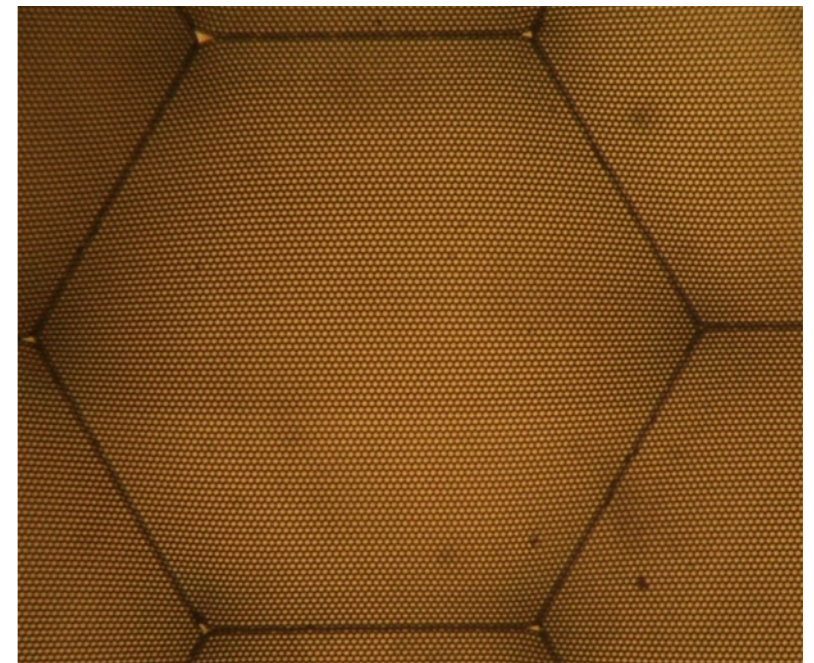
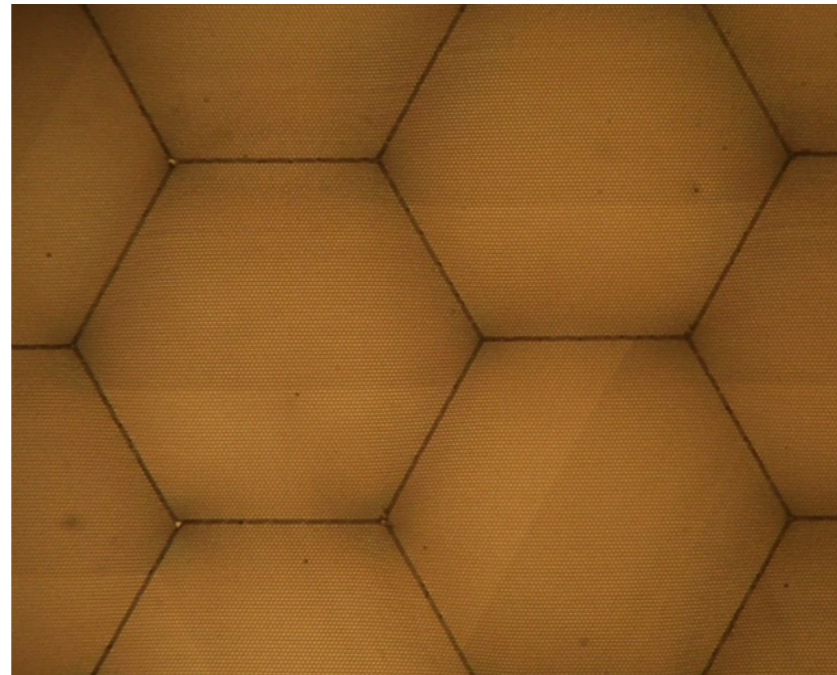
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Advances in Glass Capillary Array Development

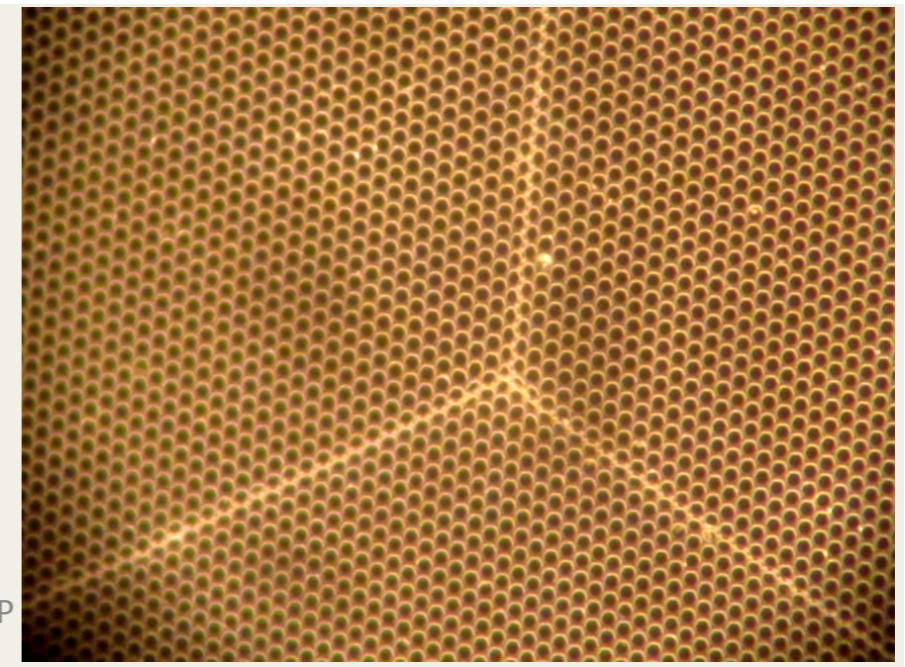
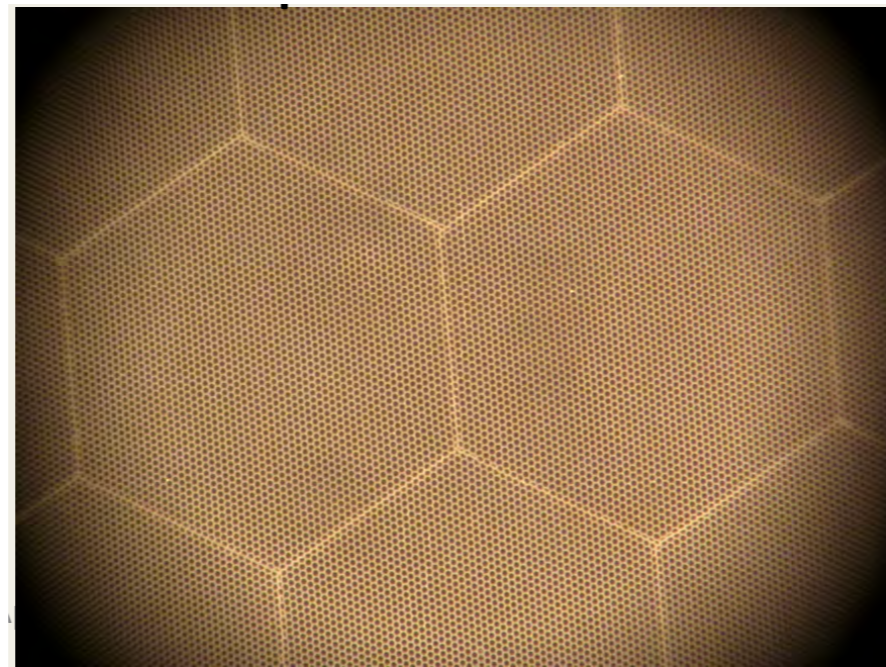
1st Batch vs. Present Batch 20 μ m pores

- Multifiber stacking evident
- Triple point gaps
- Pore crushing at multifiber boundaries



Batch 1

- Triple point gaps eliminated
- Minimal pore distortion
- Still some stacking issues



Batch 2

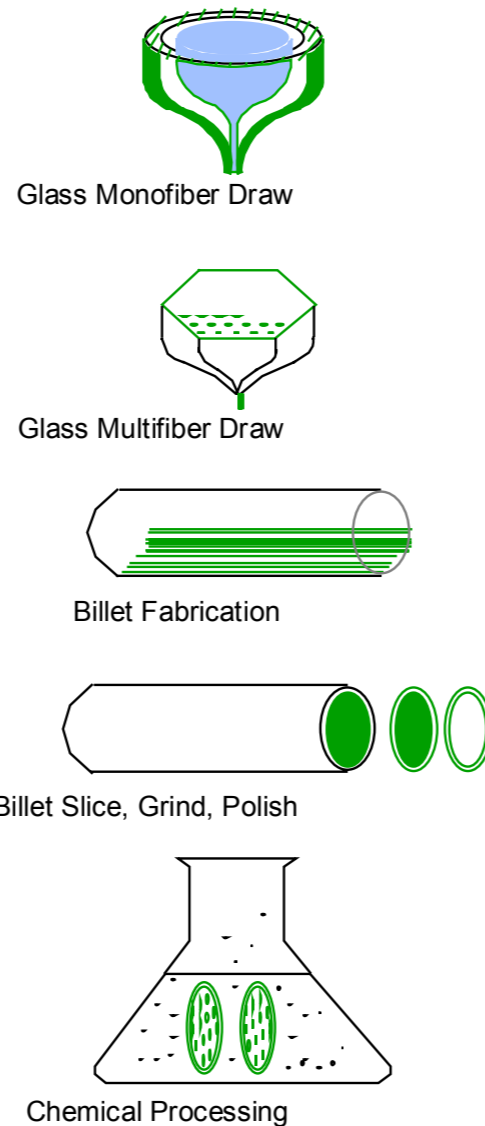
Commercial Microchannel Plate Fabrication

Graphic Credit: B. Laprade & R. Starcher, Burle (2001)

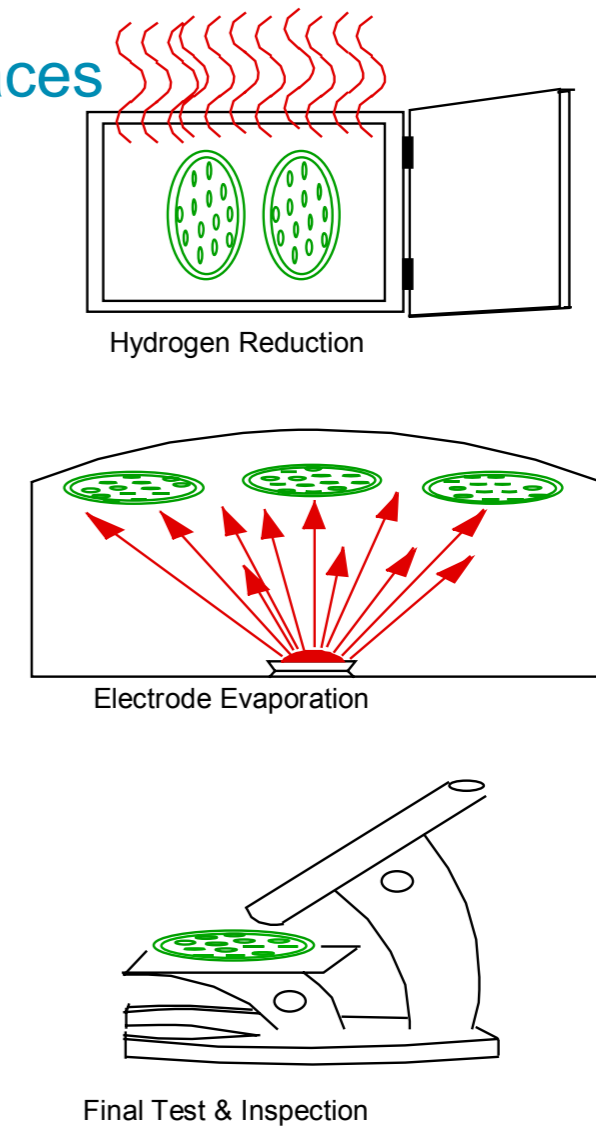
Glass is gravity-fed via cylindrical furnace

Glass is typically lead glass tube with solid soft glass core
Borosilicate glass capillaries are hollow core

Chemical processing to remove soft core glass
hollow core glass capillaries skip this step

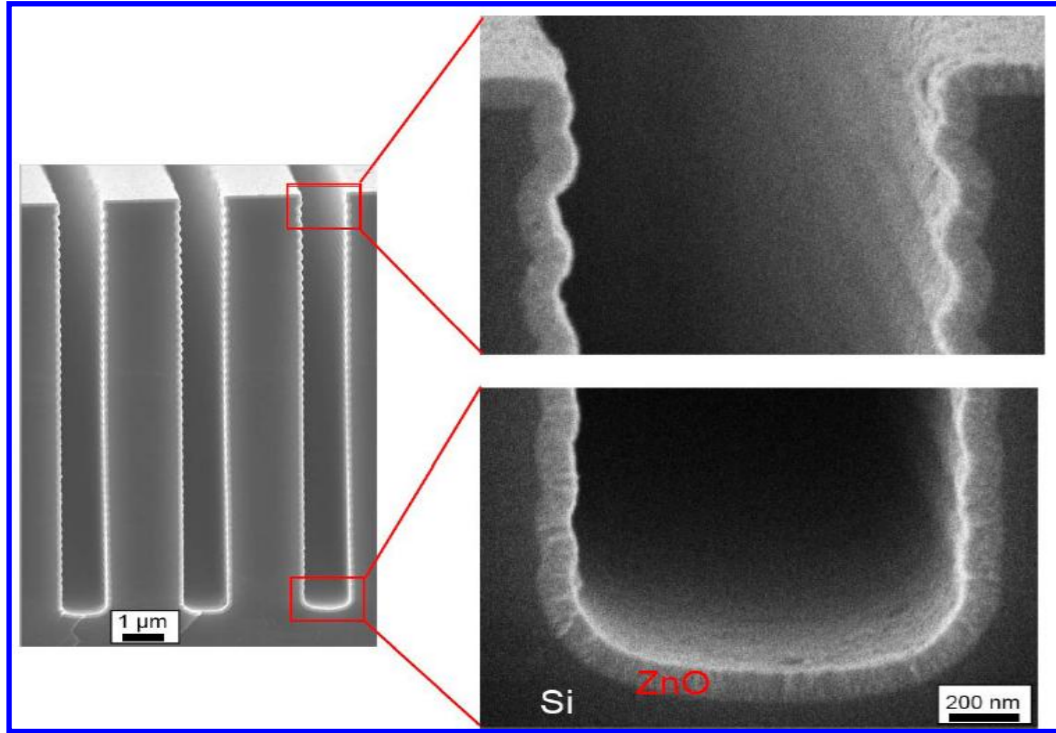


ALD replaces this step



Before sealing in tube, plate must be subjected to prolonged exposure to electrons at low voltage to outgas H_2 and other material
ALD process greatly reduces scrub time (to zero?)

Pore Activation via Atomic Layer Deposition



ALD Thin Film Materials

H																				He	
Li	Be																				Ne
Na	Mg																				Ar
K	Ca	Sc	Ti	V	Cr	Mn	Fe	Co	Ni	Cu	Zn	Ga	Ge	As	Se	Br					Kr
Rb	Sr	Y	Zr	Nb	Mo	Tc	Ru	Rh	Pd	Ag	Cd	In	Sn	Sb	Te	I					Xe
Cs	Ba	La	Hf	Ta	W	Re	Os	Ir	Pt	Au	Hg	Tl	Pb	Bi	Po	At					Rn
Fr	Ra	Lr	Rf	Db	Sg	Bh	Hs	Mt													
			Ce	Pr	Nd	Pm	Sm	Eu	Gd	Tb	Dy	Ho	Er	Tm	Yb	Lu					
			Th	Pa	U	Np	Pu	Am	Cm	Bk	Cf	Es	Fm	Md	No	Lw					

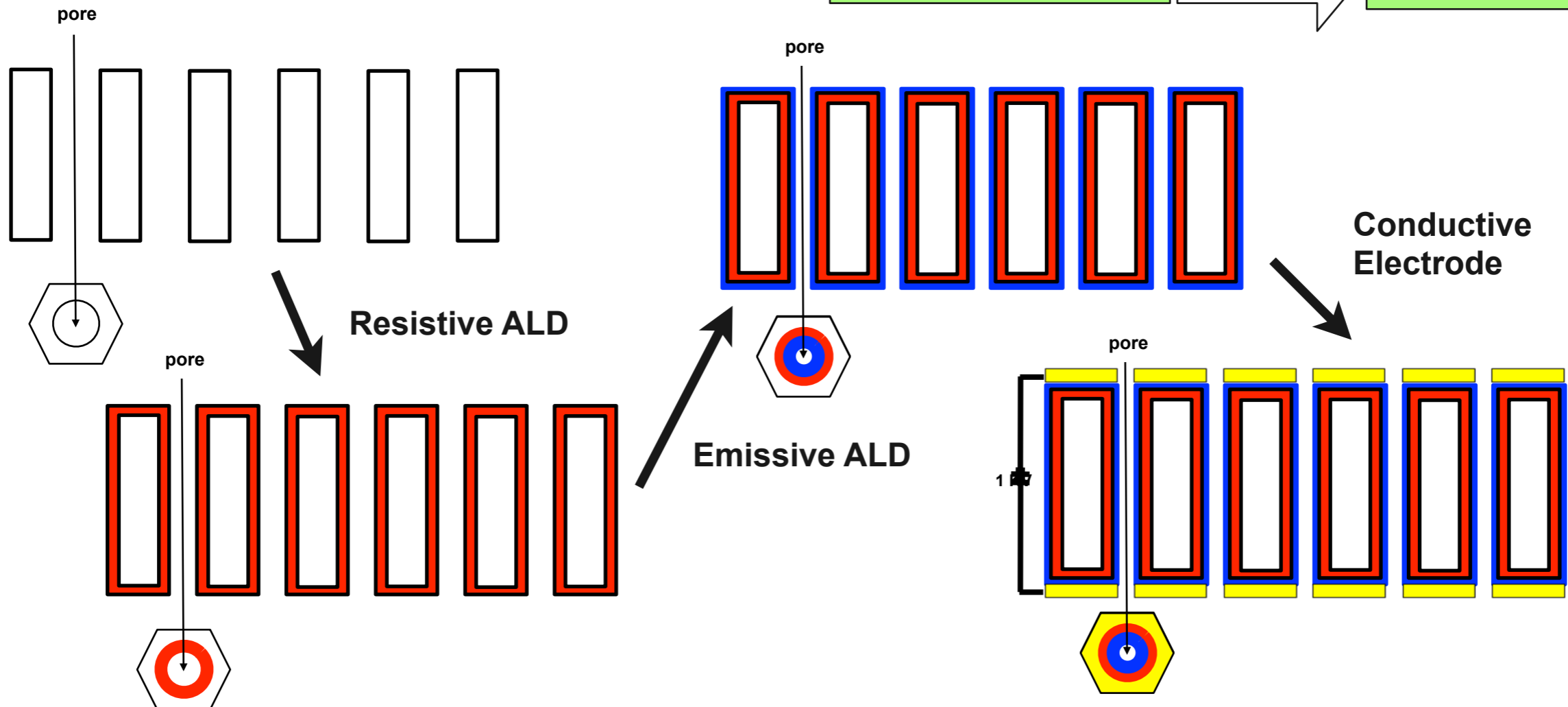
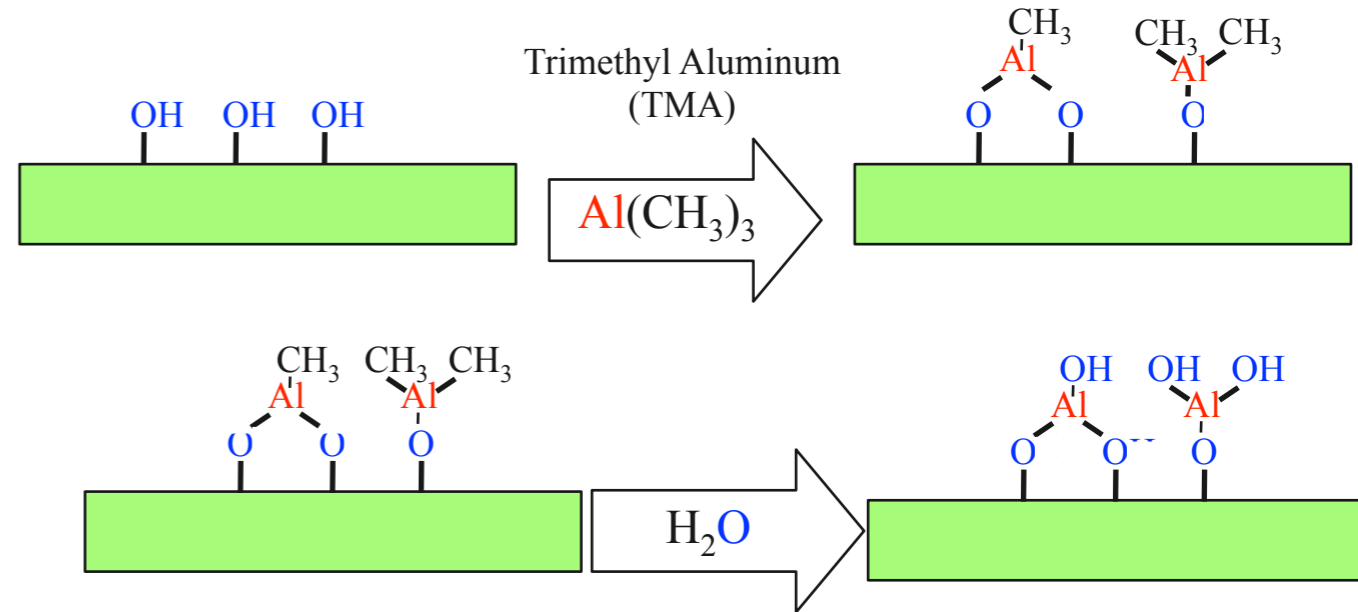
- Oxide
- Nitride
- Phosphide/Arsenide
- Sulphide/Selenide/Telluride
- Element
- Carbide
- Fluoride
- Dopant
- Mixed Oxide

- Conformal, self-limiting process
- Molecular mono-layer thickness control
- Large variety of applicable materials

Pore Activation via Atomic Layer Deposition (ALD)

Example:

- OH on surface provide reaction sites
- Trimethyl aluminum reacts liberating methane, forms Al_2O_3 layer. Leaves methyl group inhibiting further reaction on surface
- Exposure to H_2O removes methyl group. Leaves OH sites for next reaction



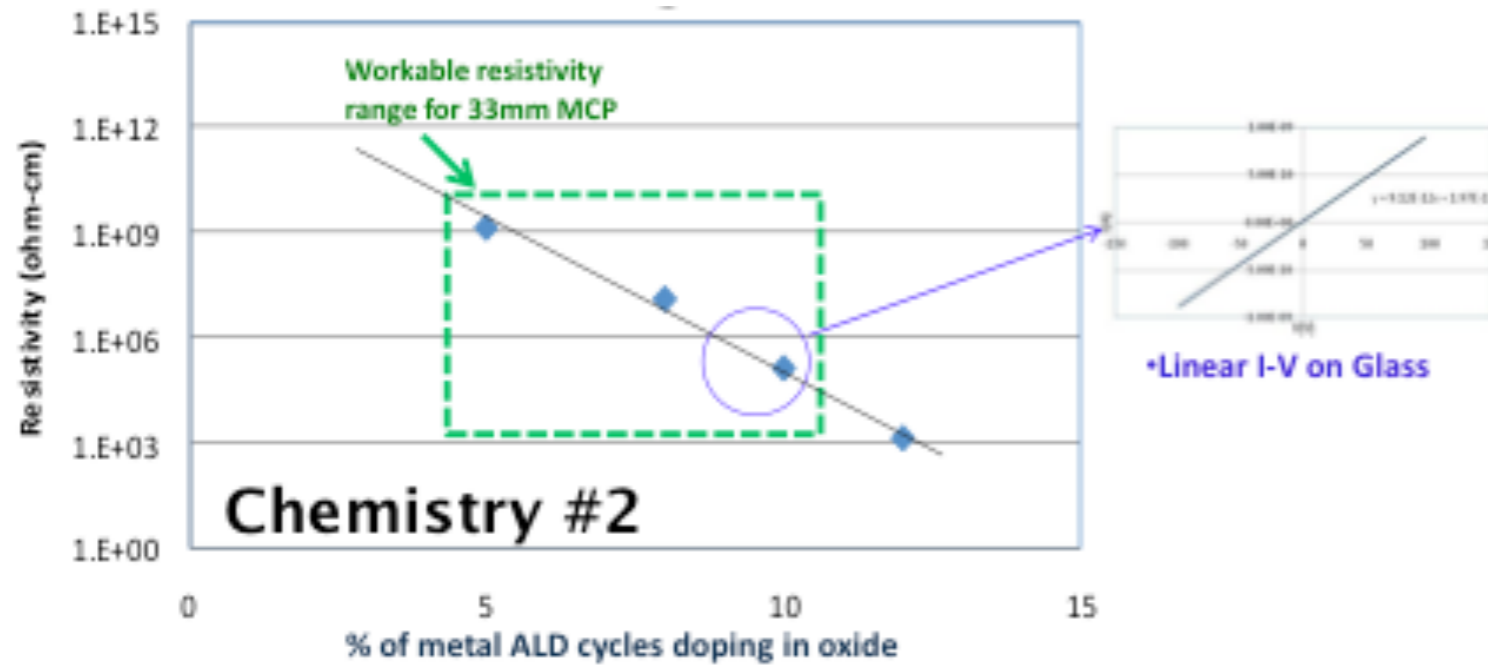
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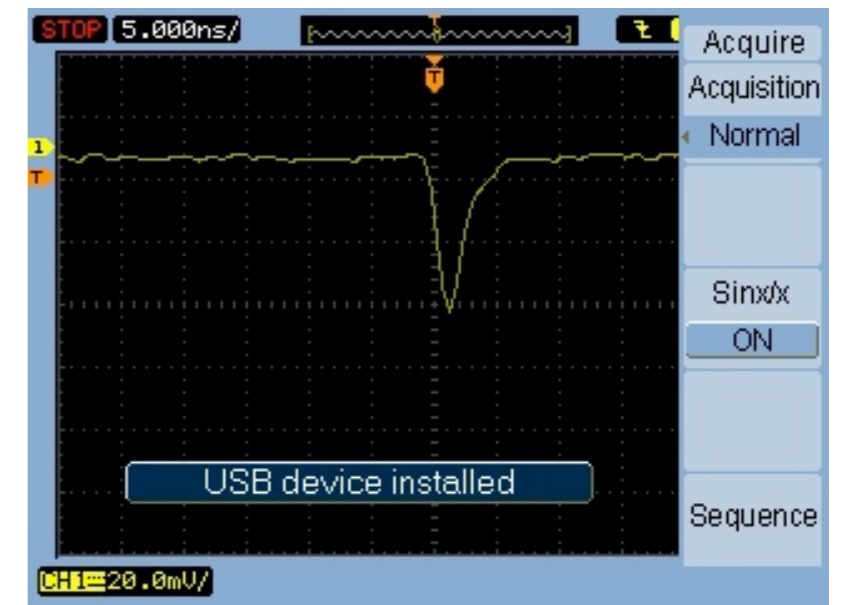
ALD Functionalization of Micro-Channel Plates

New ALD chemistries for resistive coating developed at Argonne

Resistance is reproducibly tunable

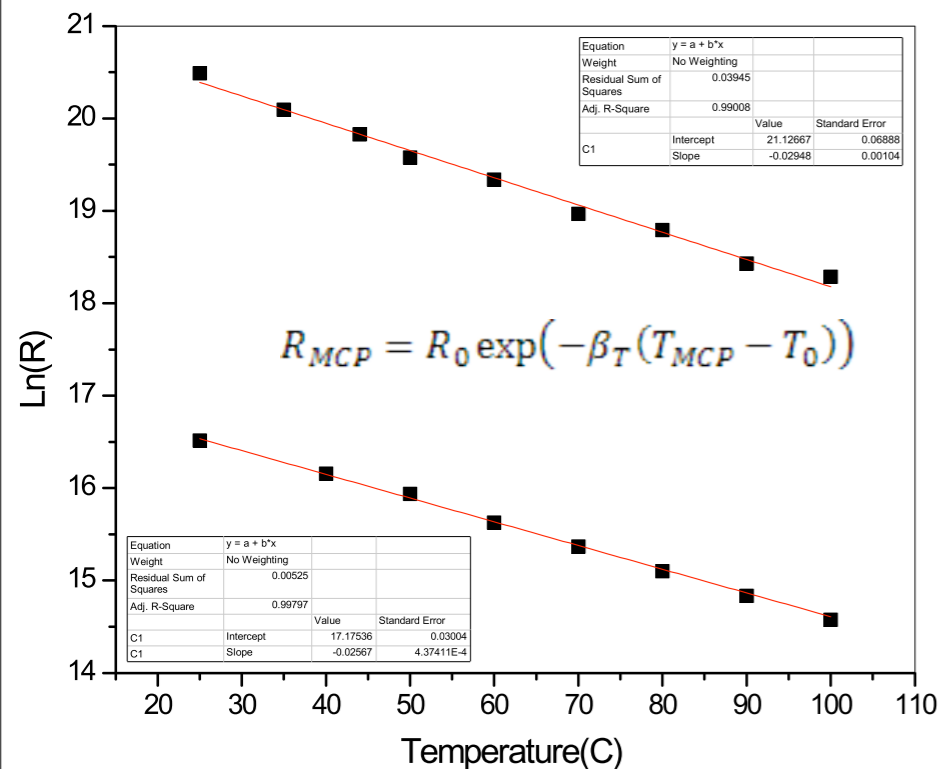


Al₂O₃ Secondary Emission Layer



Signal from MCP pair coated with new resistive layer + Al₂O₃ emissive layer

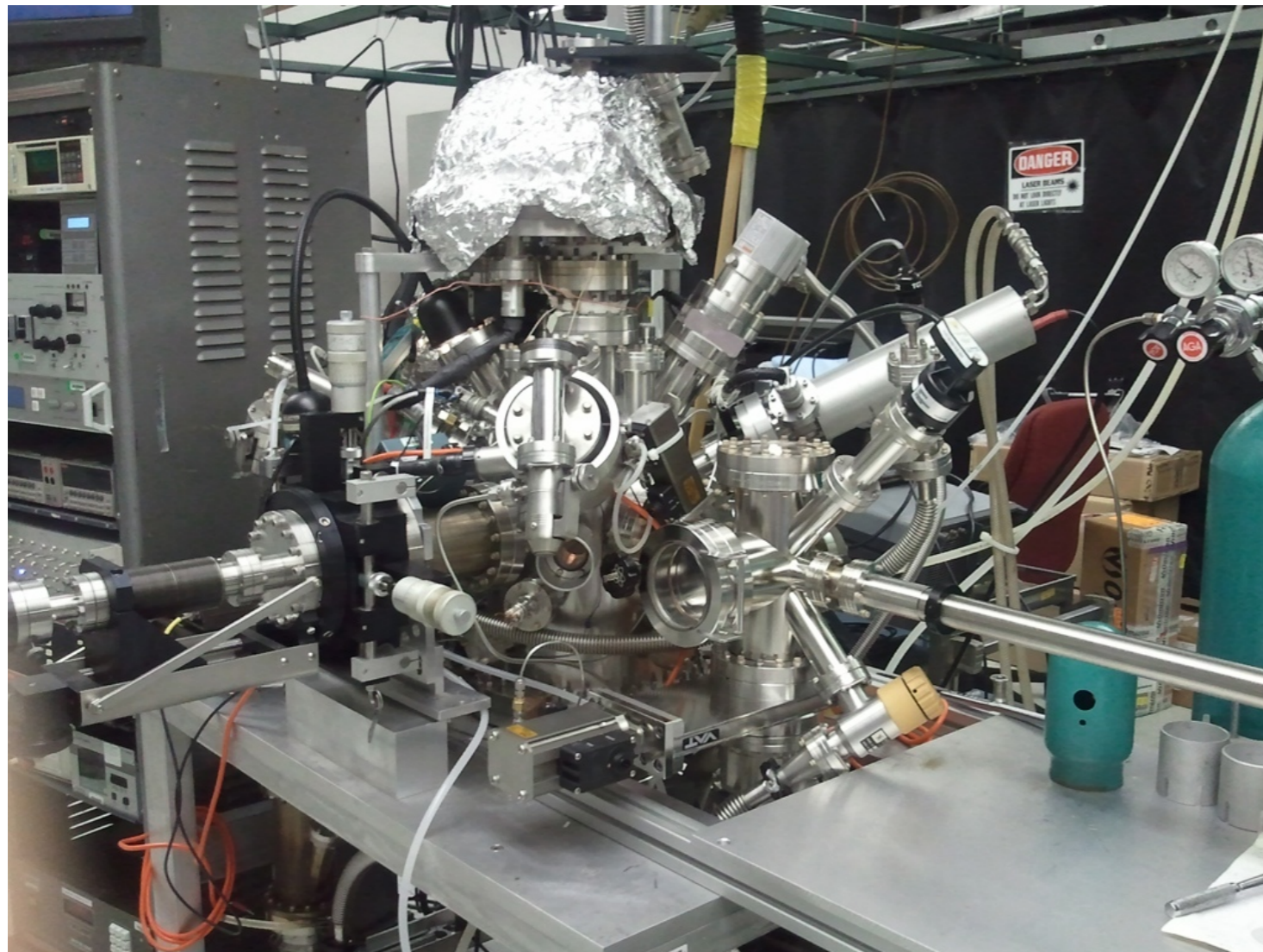
image credit: M. Wetstein



$\beta_T = -0.02$ for commercial MCP (literature)
 $= -0.027$ "New Chemistry 1"

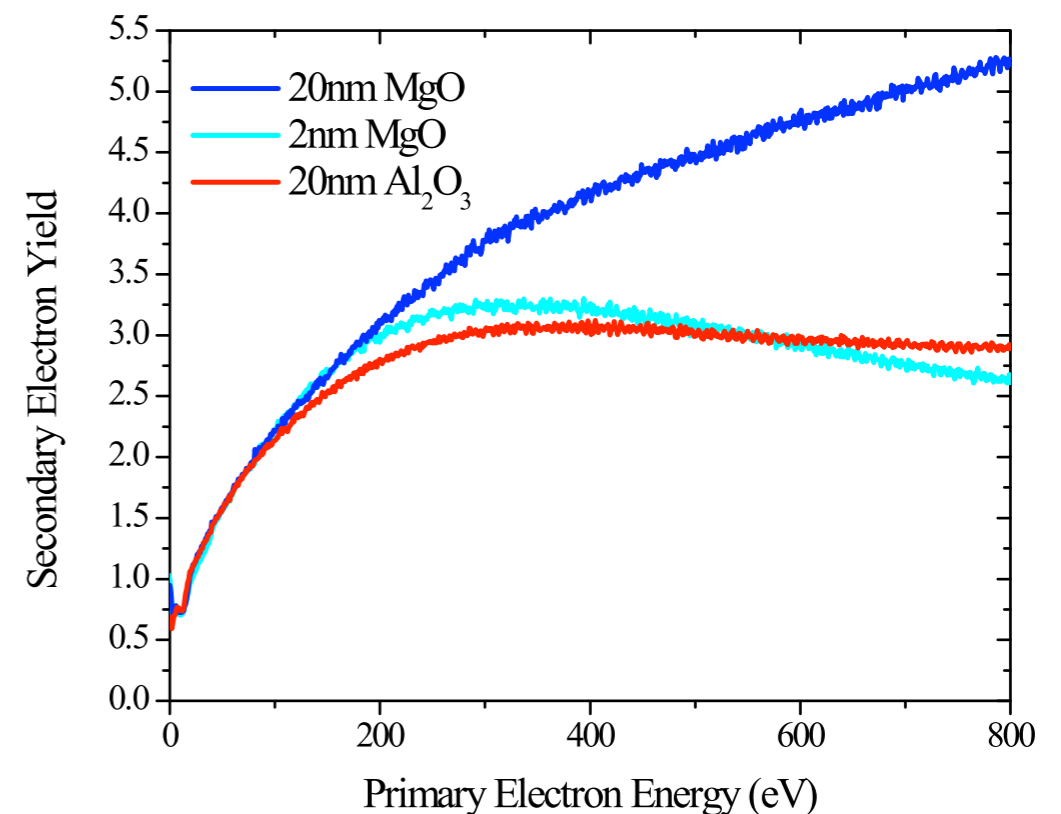
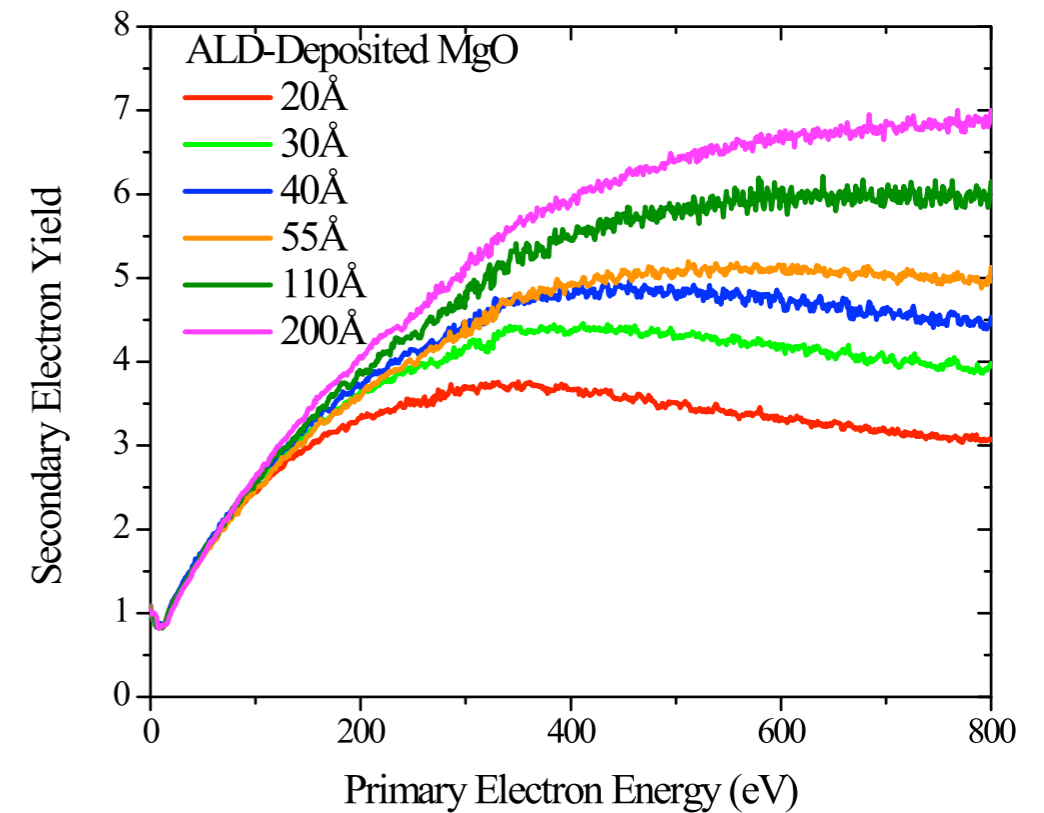
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Secondary Emissive Materials Characterization



Characterization Chamber

- UV Photoelectron Spectrometer
- X-ray Photoelectron Spectrometer
- Low Energy Electron Diffraction

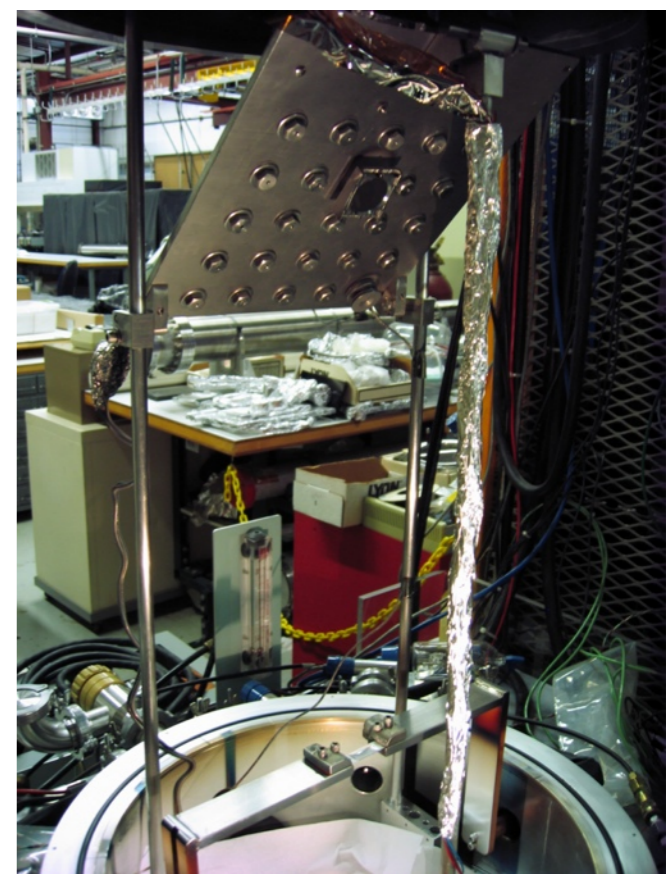
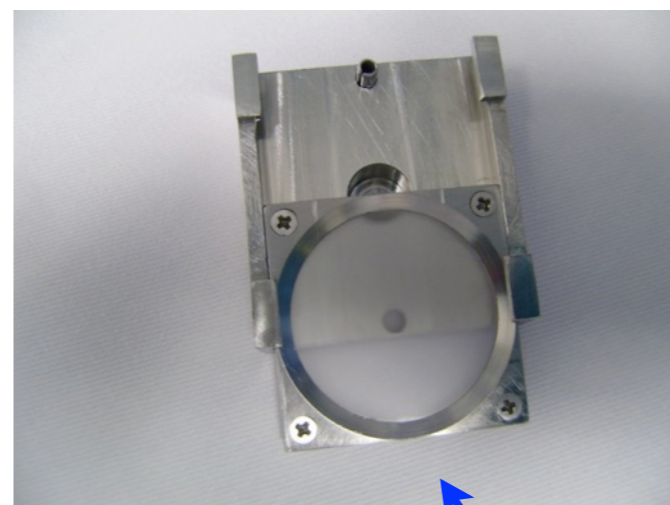
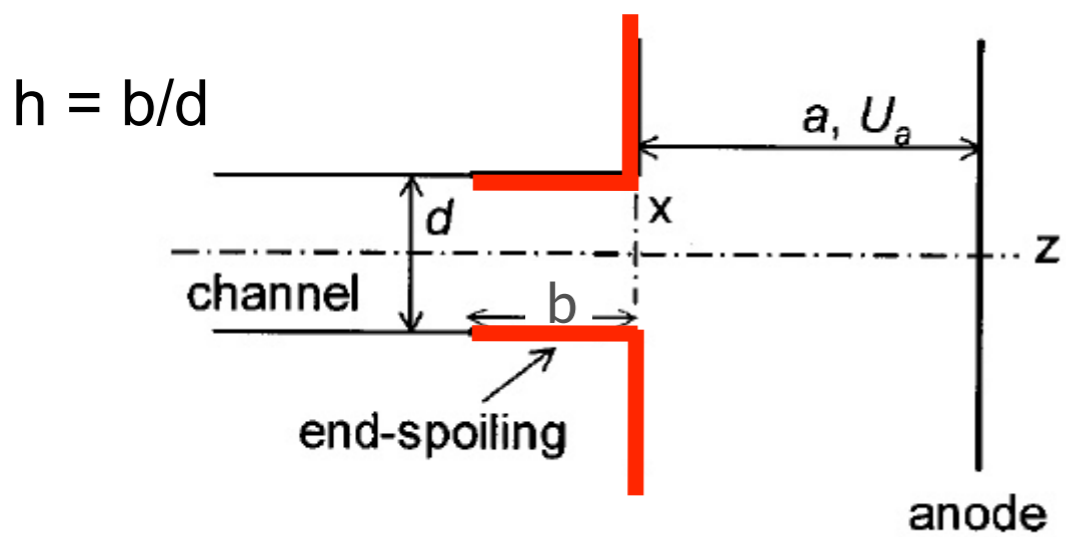


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Electroding system at Fermilab for 33mm MCPs

Electroding - End Spoiling



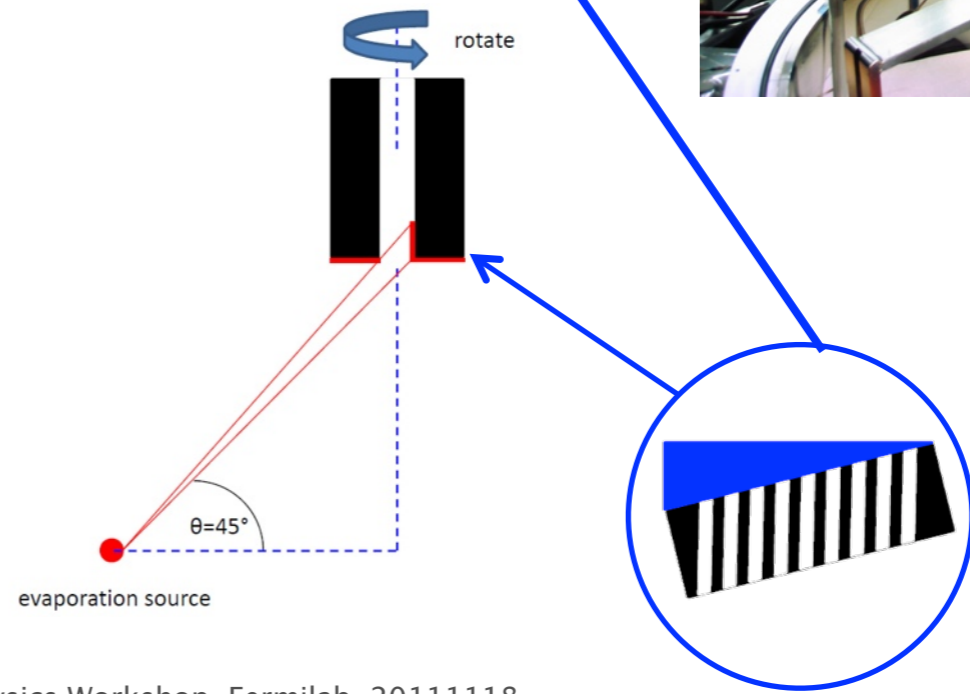
Line-of-sight evaporation

End-spoiling on output

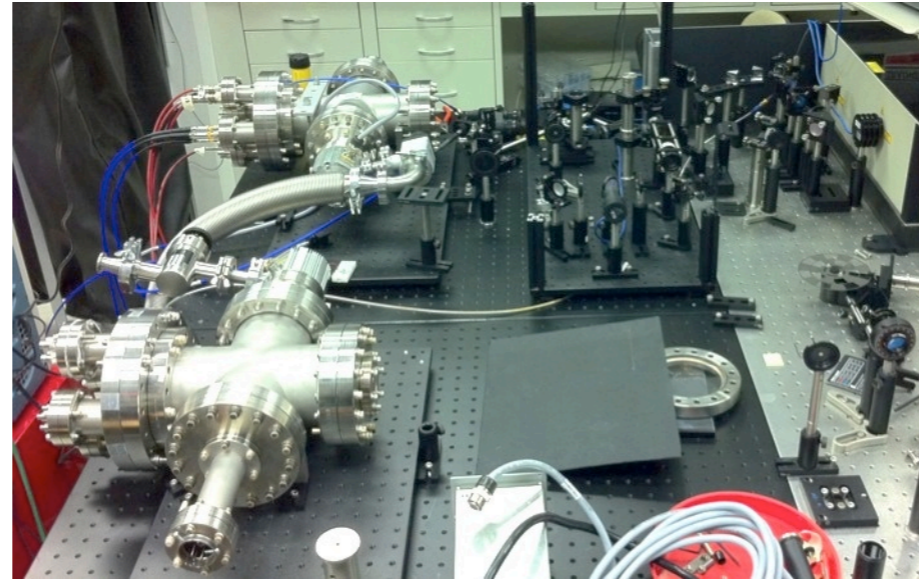
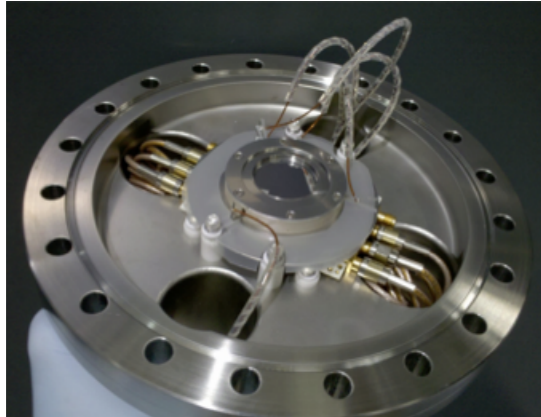
- ▶ Increases spatial resolution
- ▶ Decreases gain
- ▶ Trade-off $h = 1-2$

End-spoiling on input $\sim h = 0.5-0.8$

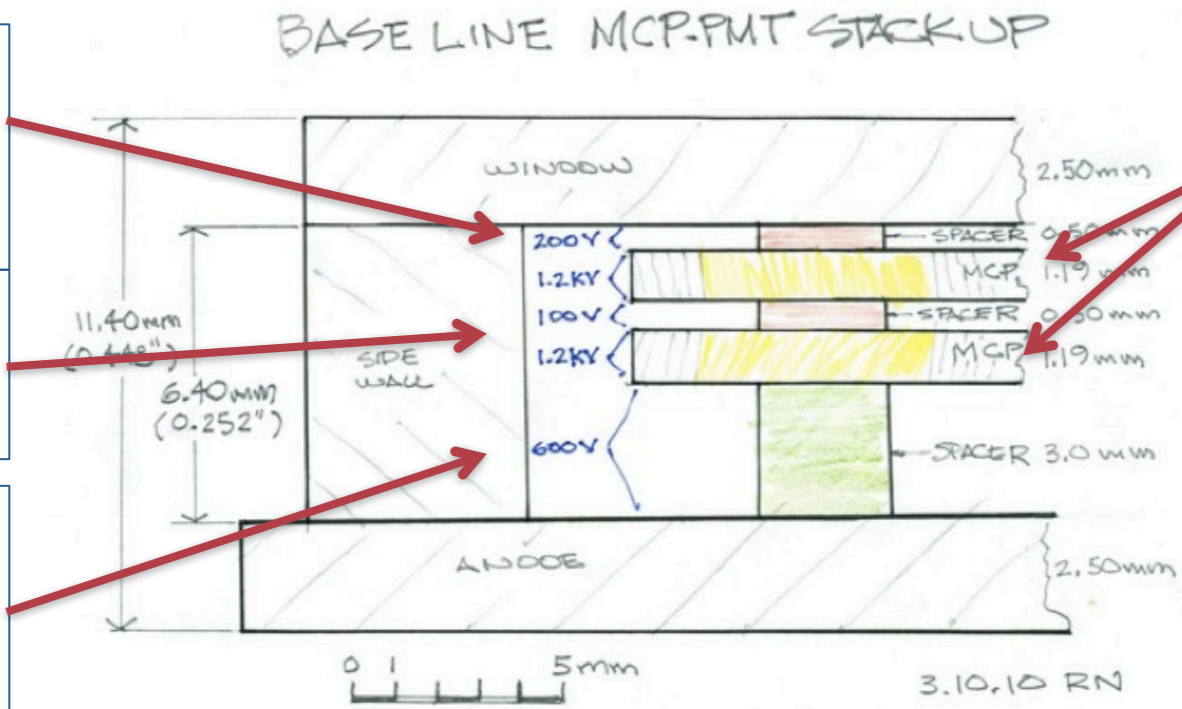
Electroding system for 8"×8" MCPs nearing completion



MCP Testing at Argonne -- APS UV Laser Facility



- Gap 1: "first strike"
Impacts on variability of transit time and amplification
- Gap 2: Impact on saturation of MCP pair, spatial spread of signal
- Gap 3: spatial and temporal spreading of the charge cloud. Space charge effects. Interface with anode.

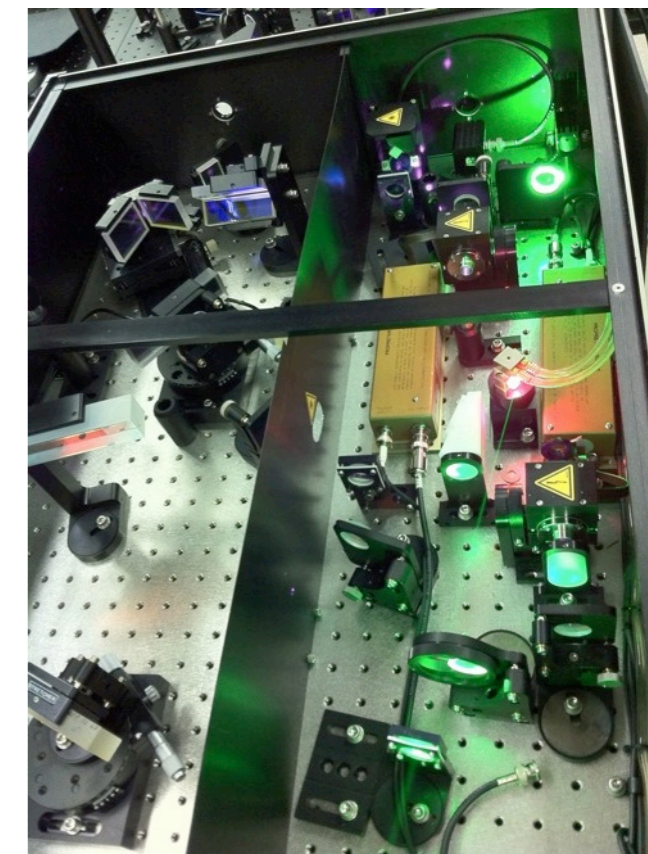
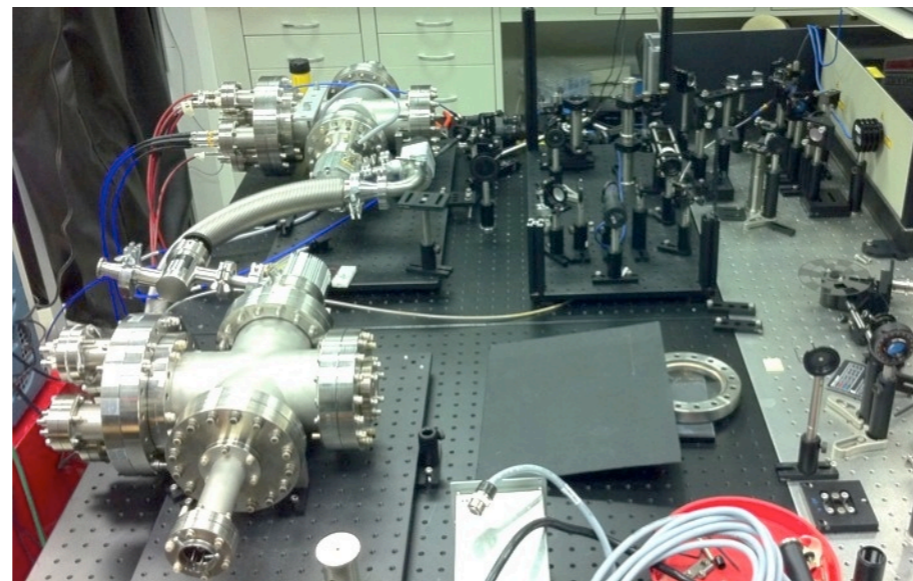
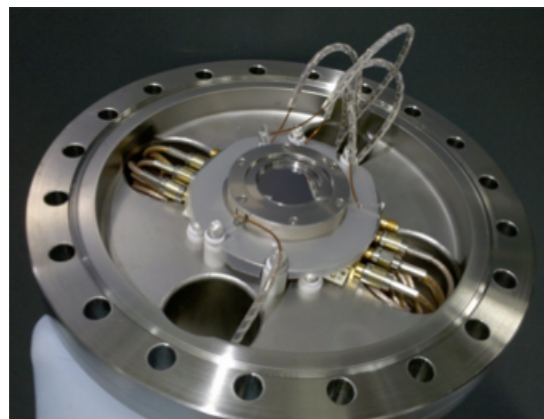


- Operational voltages
- Plate geometry (pore size, L/D)
- Chemistry (SEE, resistive layer)
- Plate quality
- Uniformity
- Noise
- Stability
- Plate resistance
- Saturation
- Relaxation time

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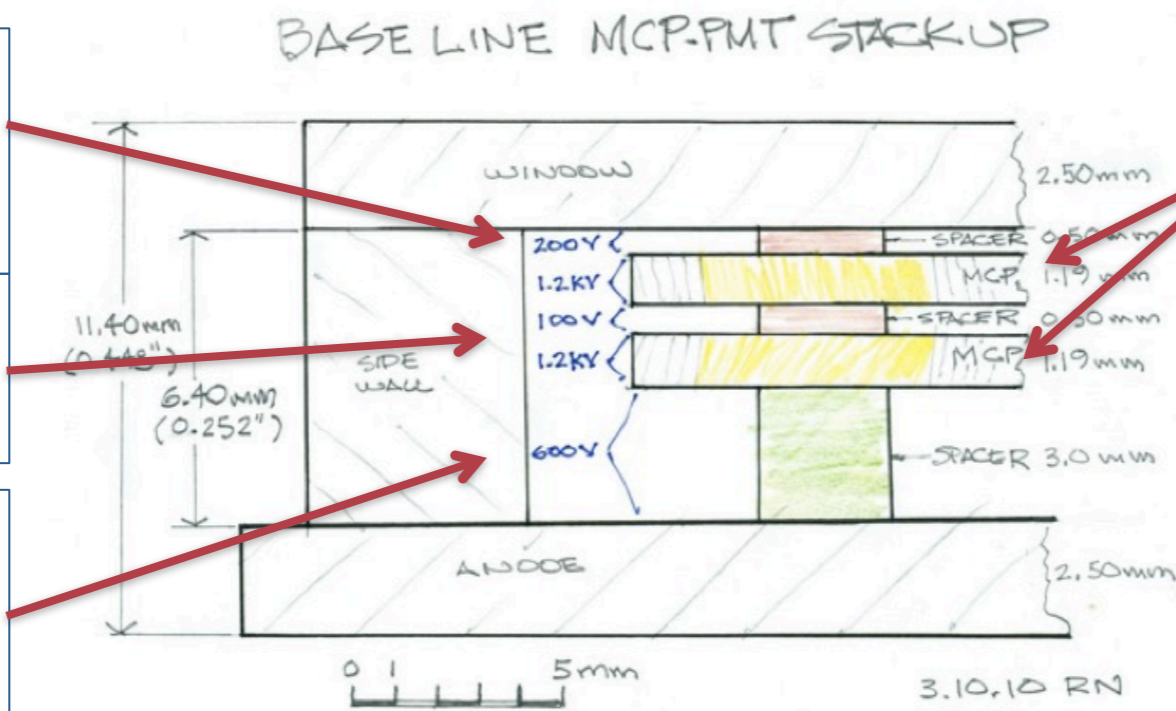
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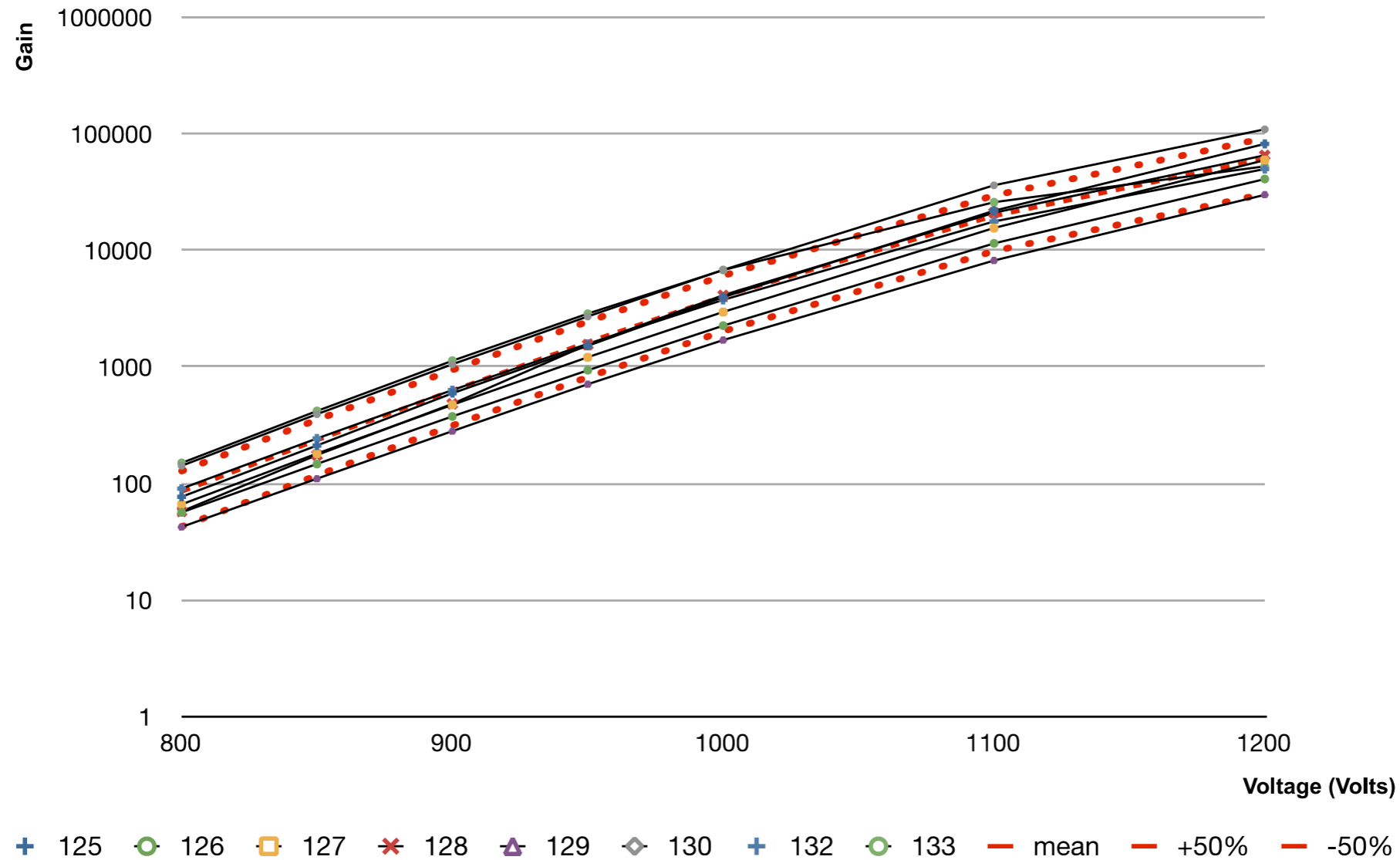
Operational voltages
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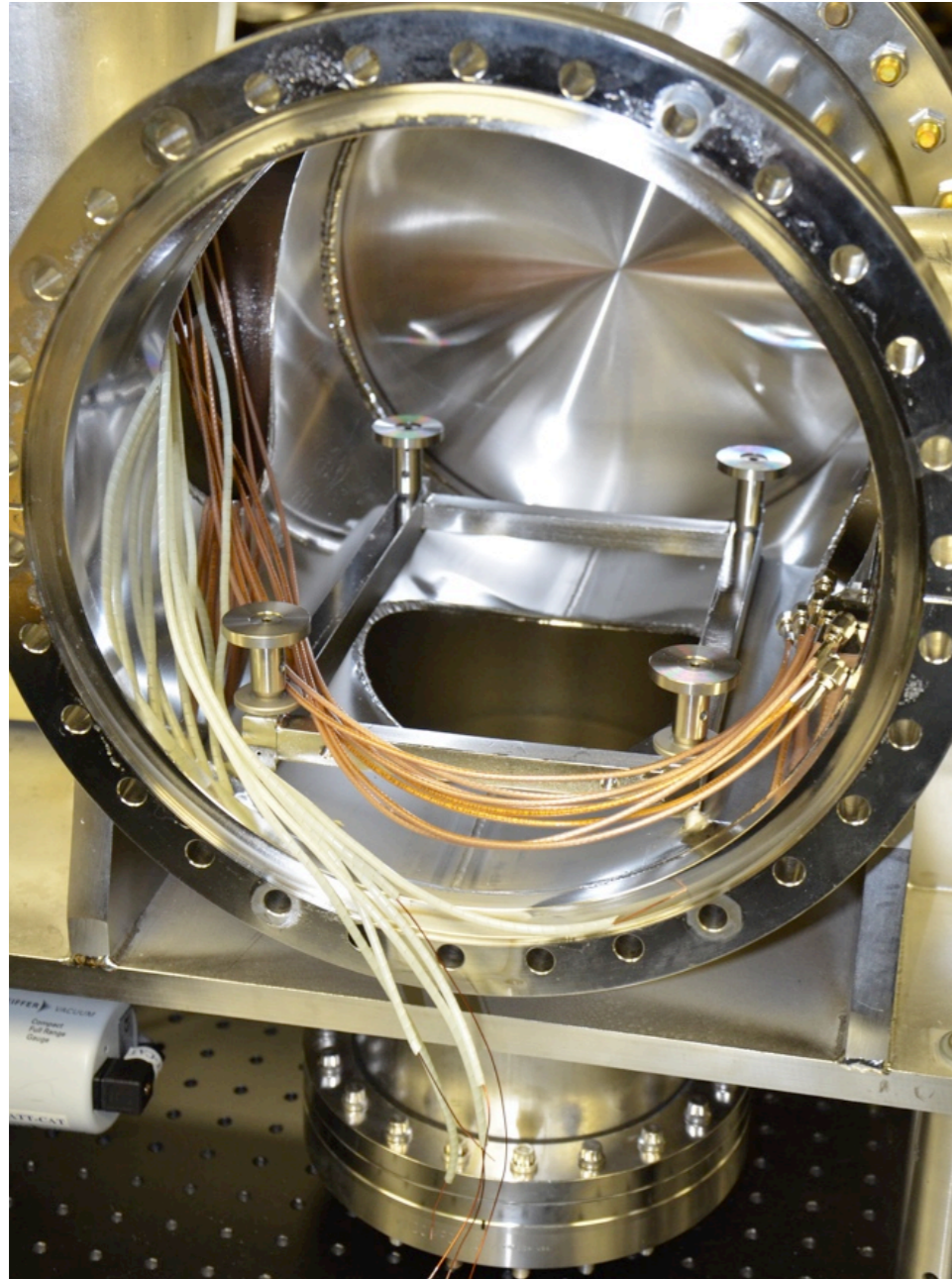
MCP Testing at Argonne -- “Mock Tile” MCPs

Gain Curves for Mock Tile MCPs

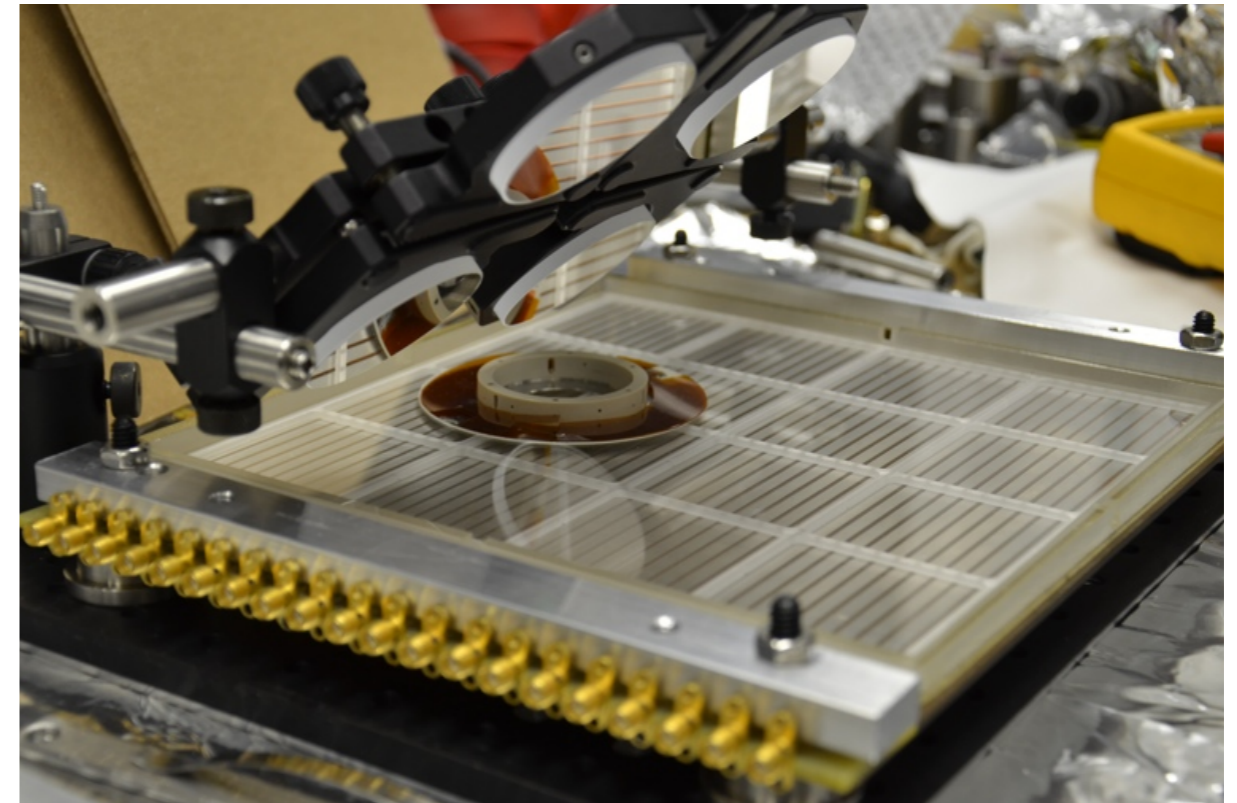


Eight 33mm MCP disks functionalized with identical “Chemistry 2” resistive coating and Al₂O₃ SEE layer

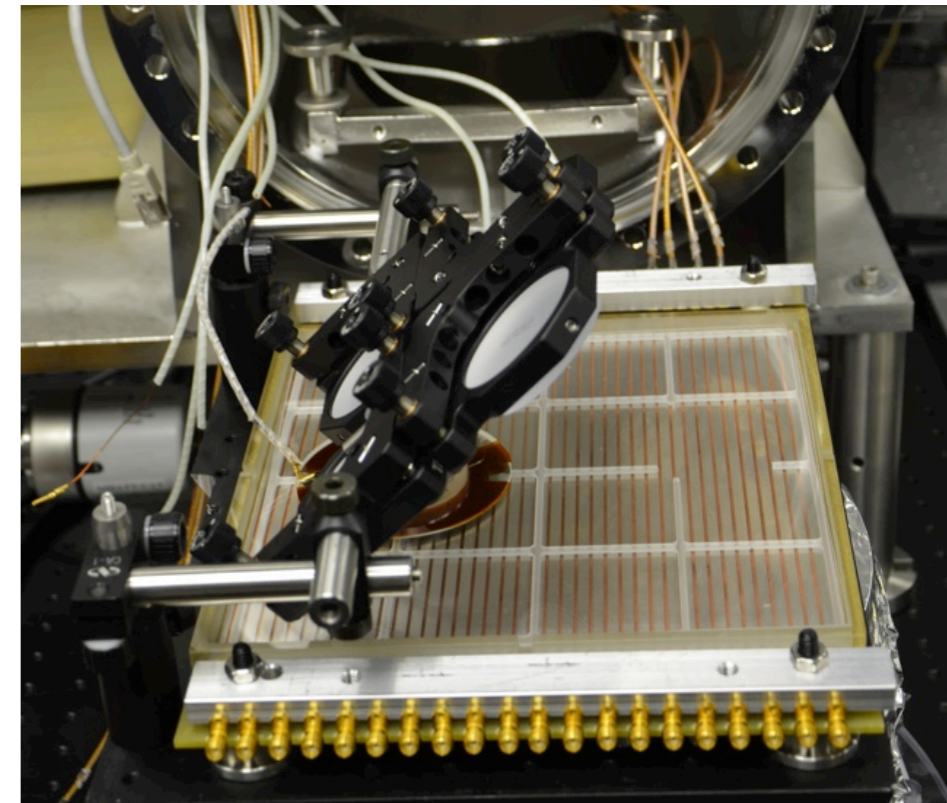
Commissioning of 8" Test Chamber at Argonne APS



8" MCP Vacuum Test Assembly

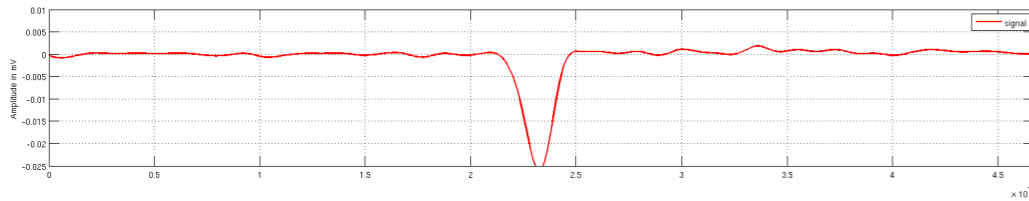
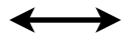


8" Tile base with 33mm MCP pair ready for insertion into chamber

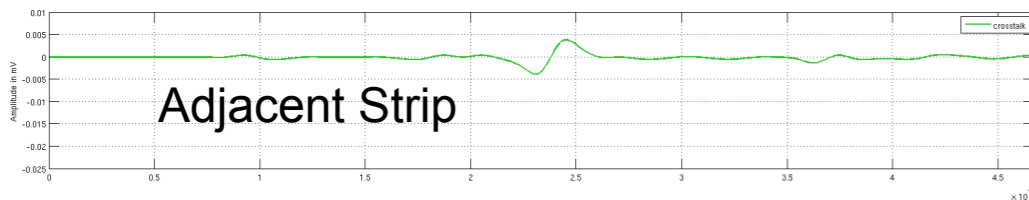


First Pulse Measurements with 8" Anode Strip Line

5 ns

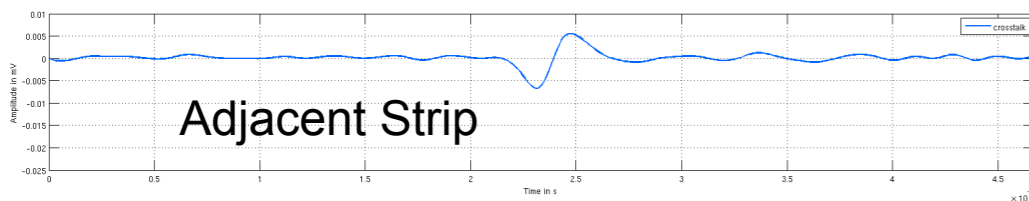


Signal



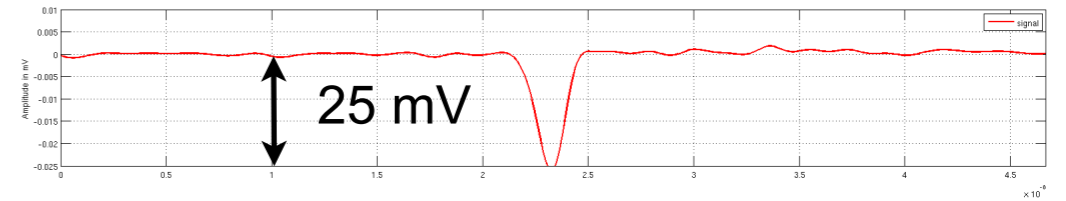
Adjacent Strip

Crosstalk

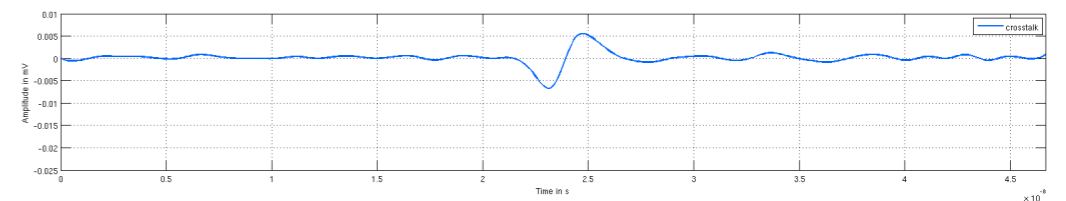
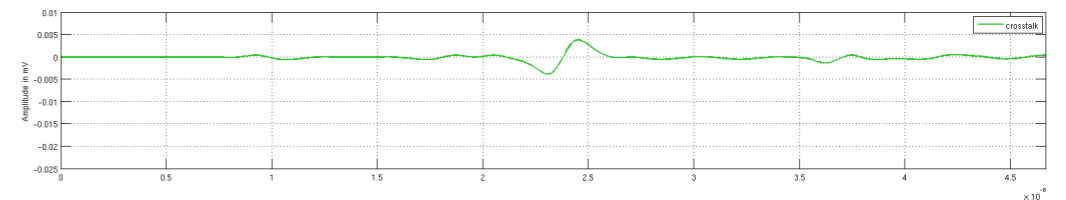


Adjacent Strip

Crosstalk

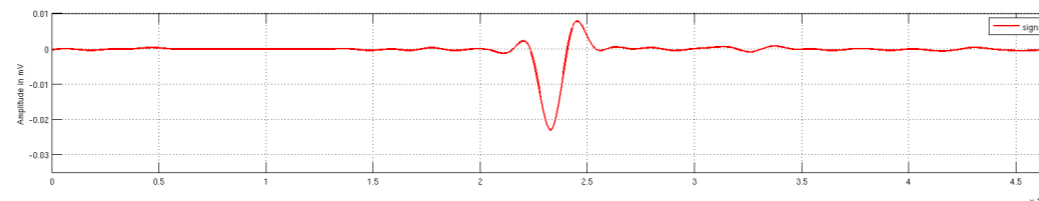


25 mV

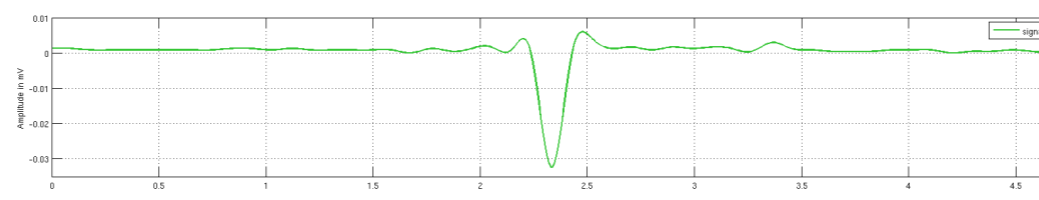


Signal

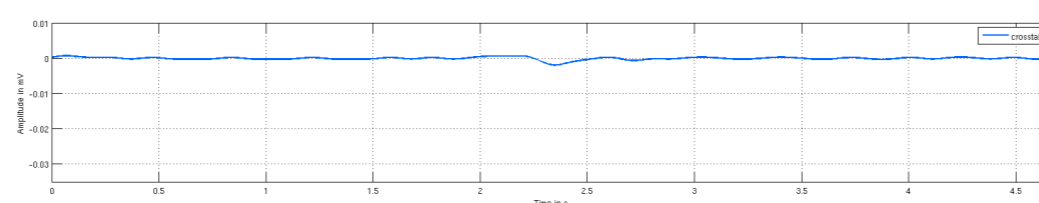
30 mV



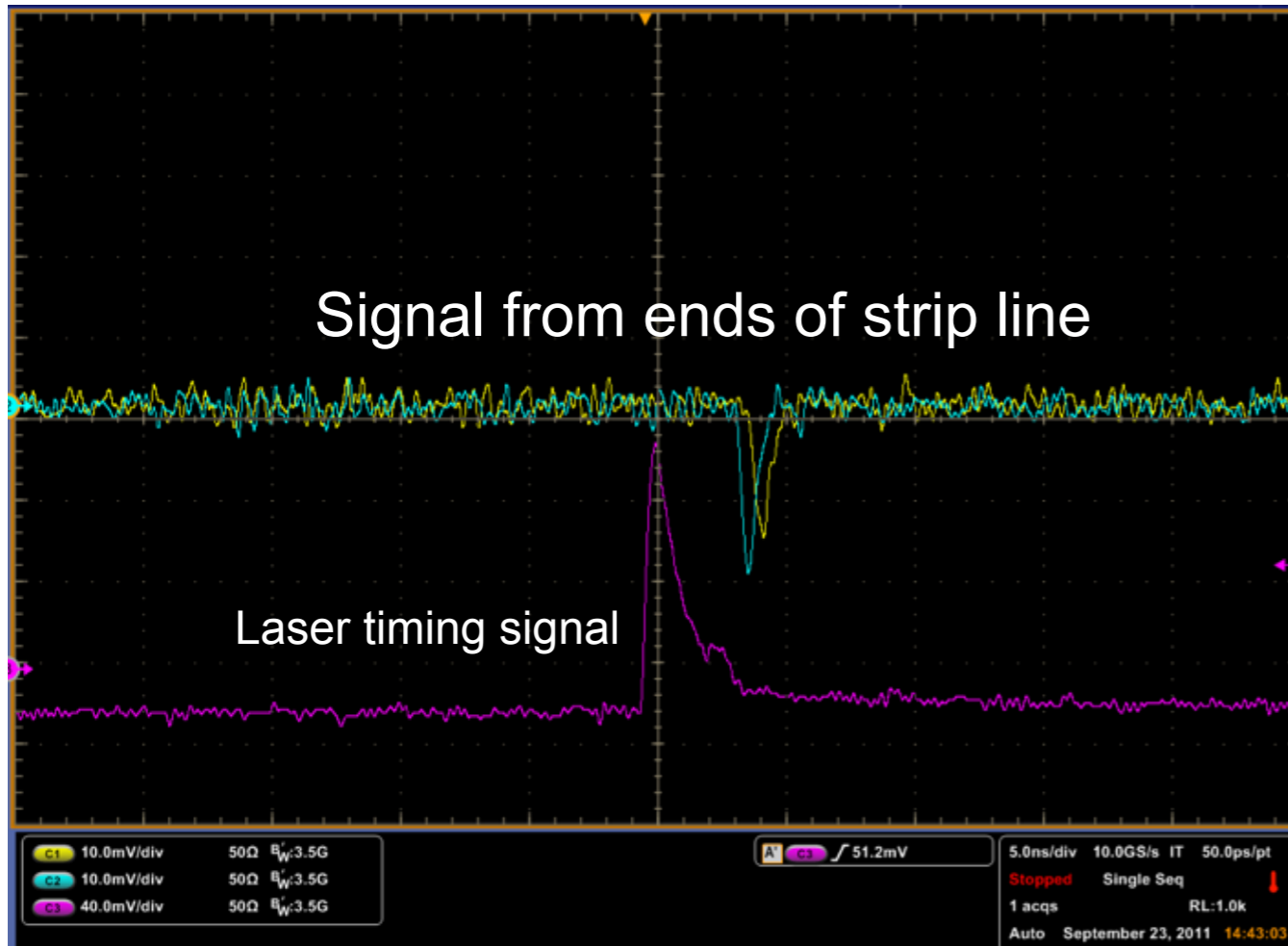
Signal



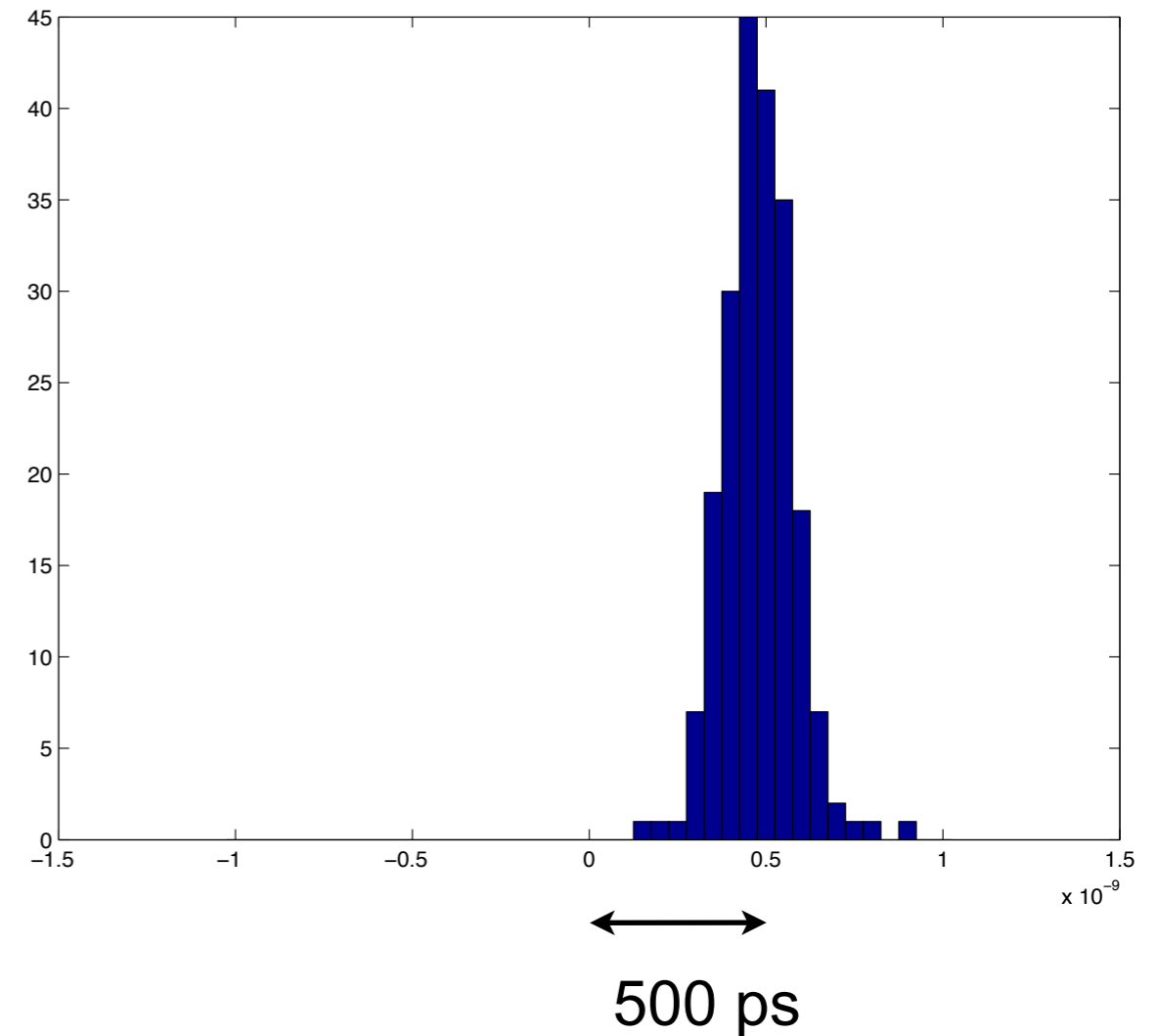
Crosstalk



First Pulses on 20cm × 20cm MCP Plate

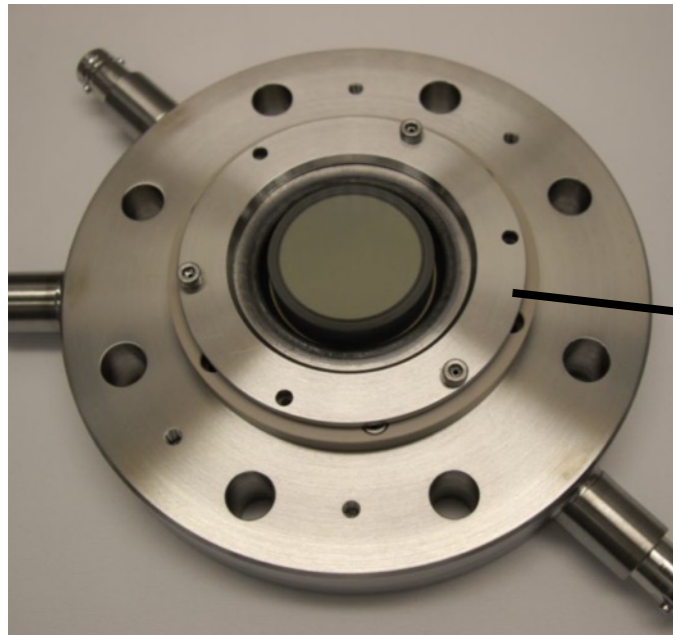


differential arrival time distribution

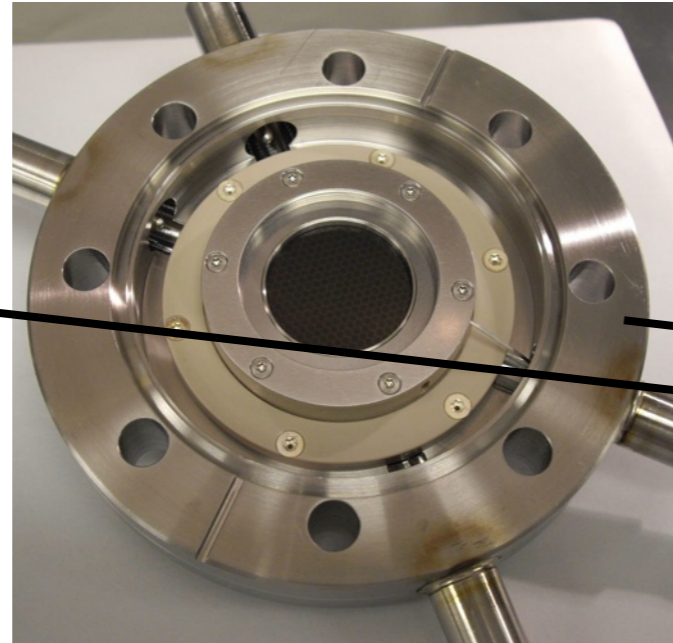


Simple soldered wire connection to strip line
Readout and differential timing with fast scope

MCP Testing at Space Sciences Lab (SSL)/Berkeley



25mm Phosphor on 4.5" CF Flange



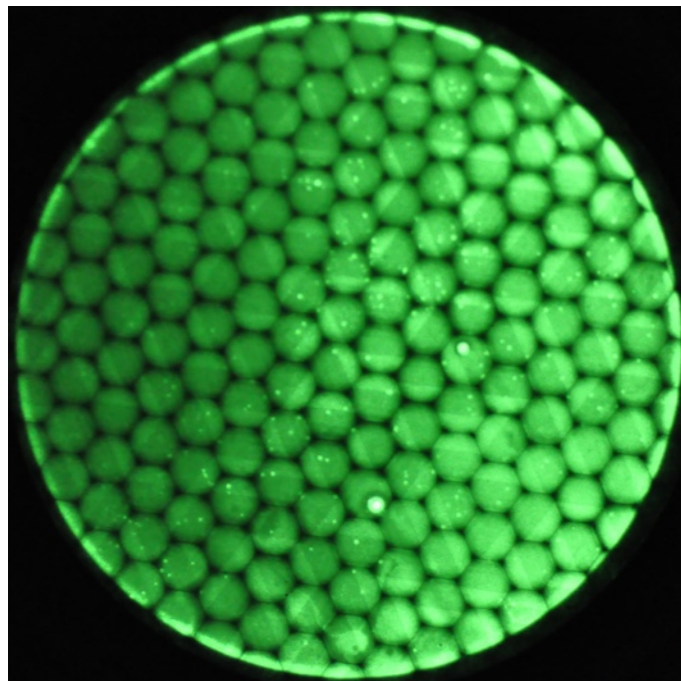
25mm Cross Strip Delay Line photon counting detector on 4.5" CF Flange



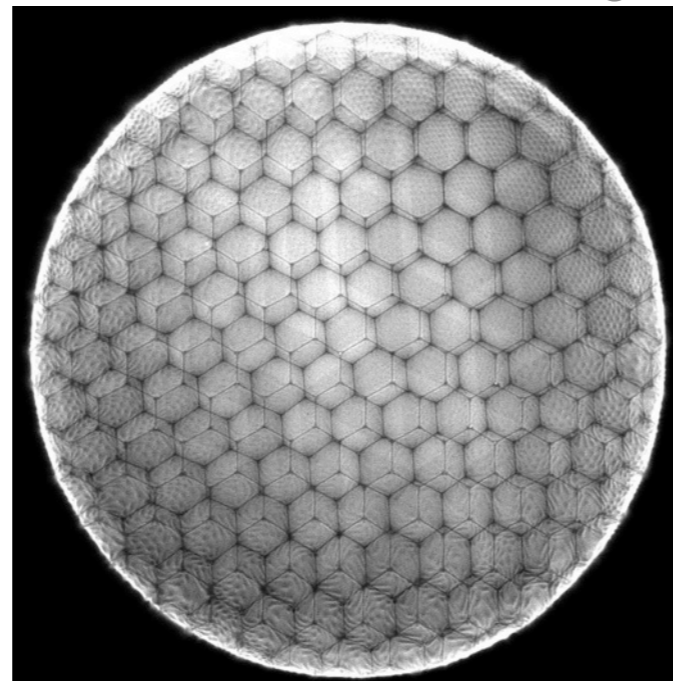
Double Chamber UHV Test Station

Amp/TDC and PC Acq/display for XDL

Nikon camera or electrometer for Phosphor



Single MCP Phosphor Image



Pair MCP XDL Image

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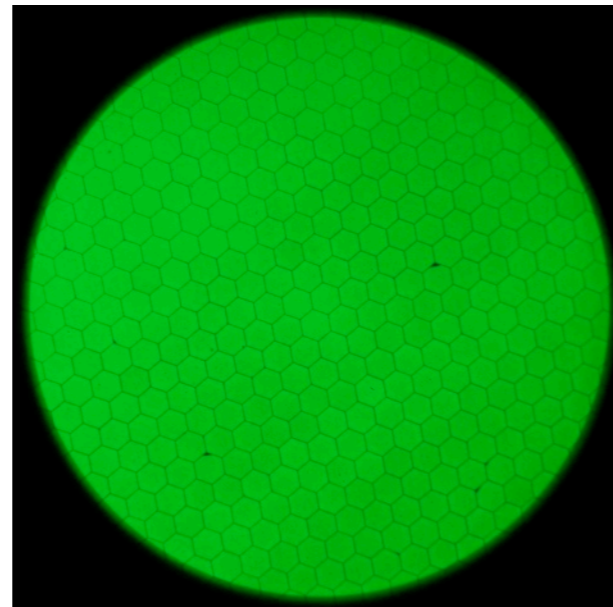
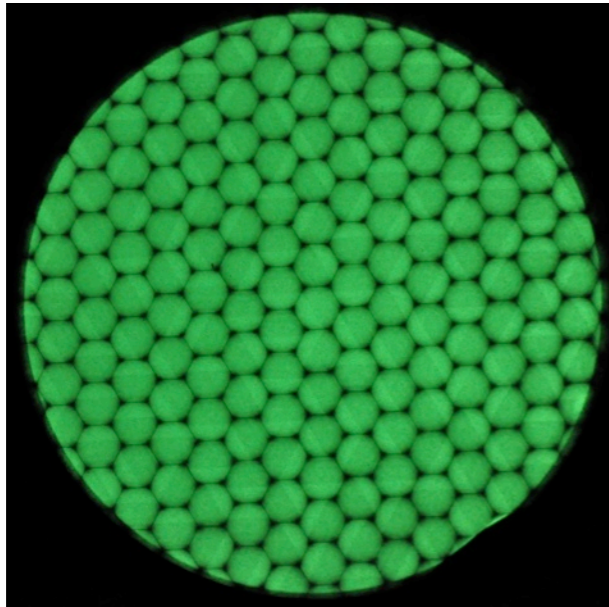


Improvement in Glass Capillary Array Fabrication

Early 2010

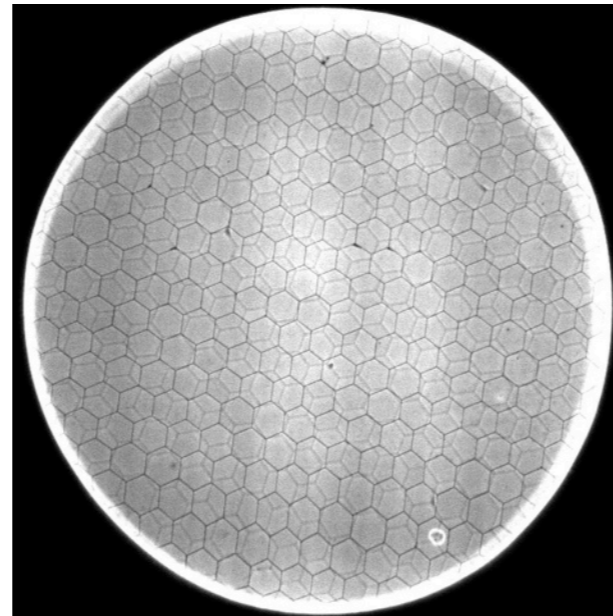
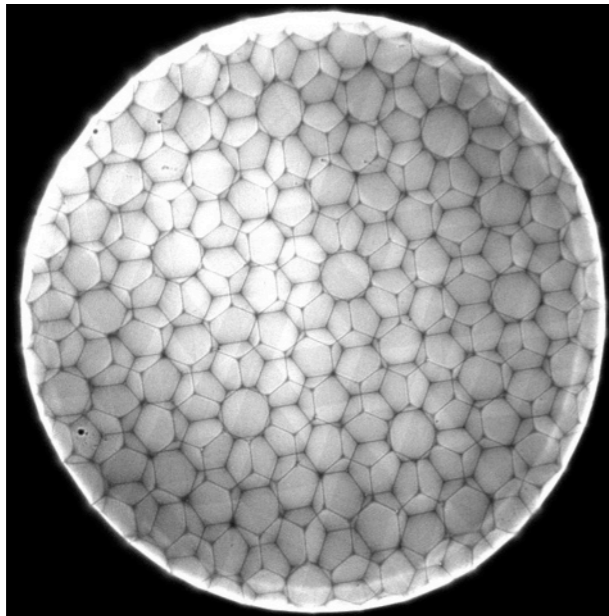
July 2011

1 MCP, Phosphor readout



UV 184nm illumination

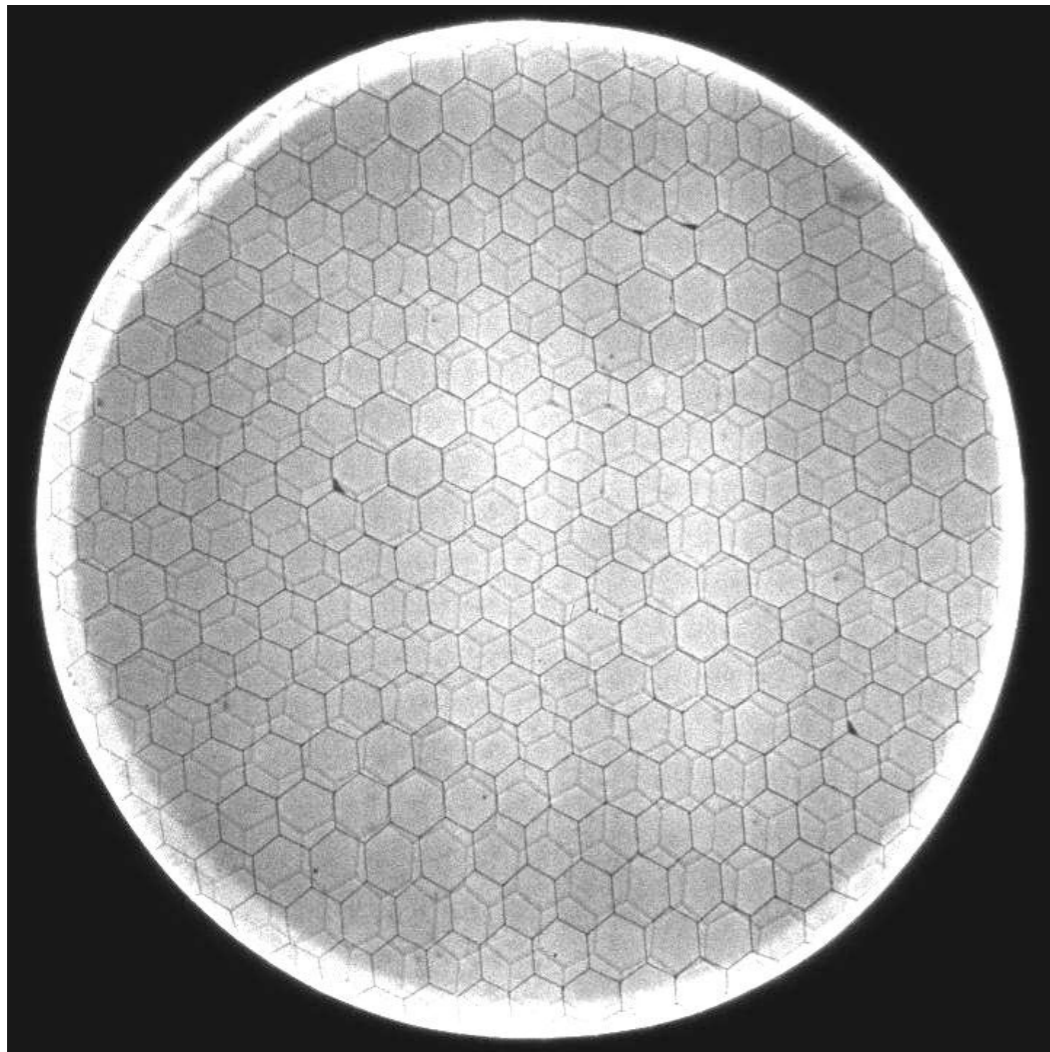
2 MCPs, Photon counting



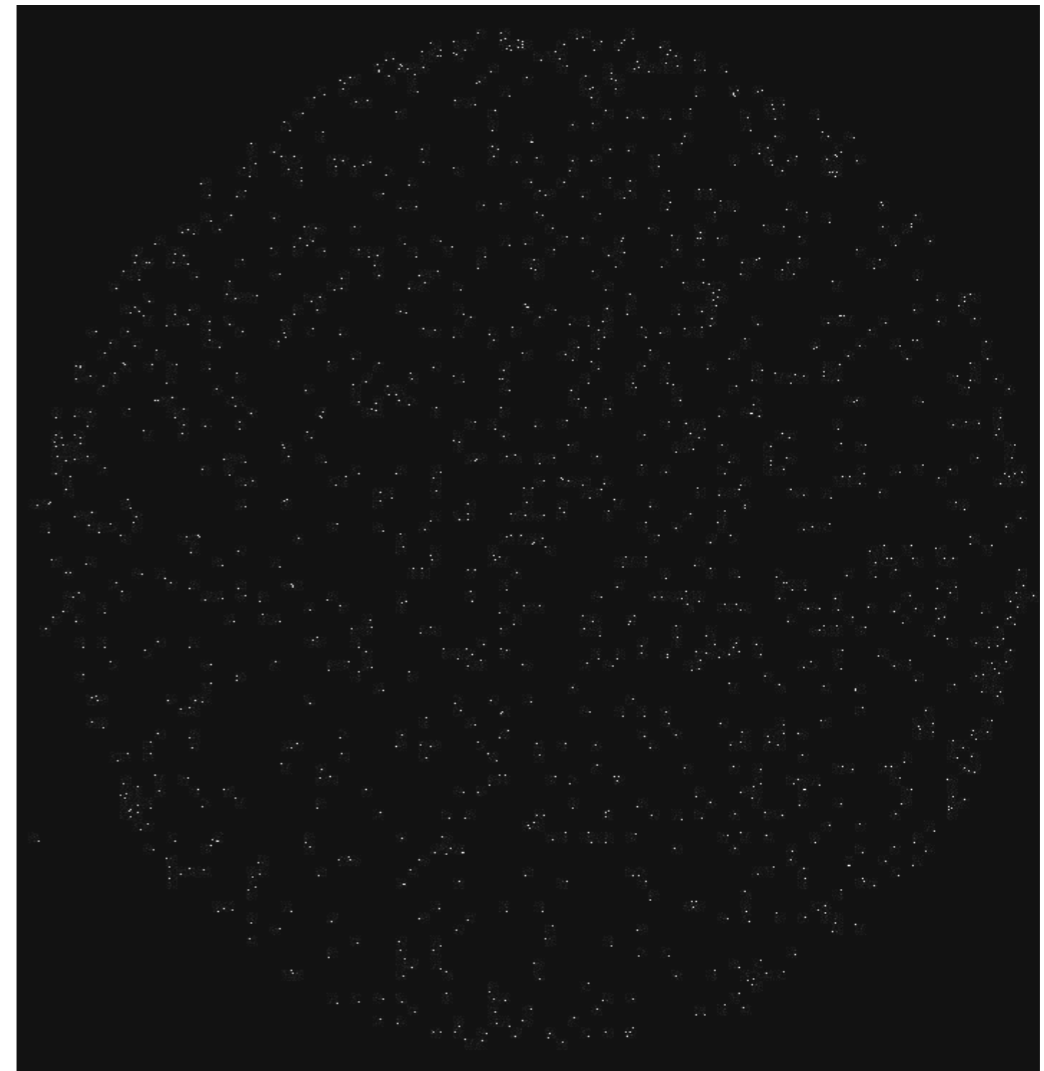
- 20 μm MCP, L/D = 60, 8° pore bias, 1000V applied to each MCP
- Imaging & gain comparable to commercial MCPs
- Sample performance shows dramatic improvement due to capillary process improvements

Argonne ALD MCP Pair Background Test

MCP pair, 20 μ m pores, 8 $^\circ$ bias, 60:1 L/d, 0.7mm gap with 300V bias



185nm UV illumination. Top MCP hex modulation (sharp) and faint bottom MCP modulation

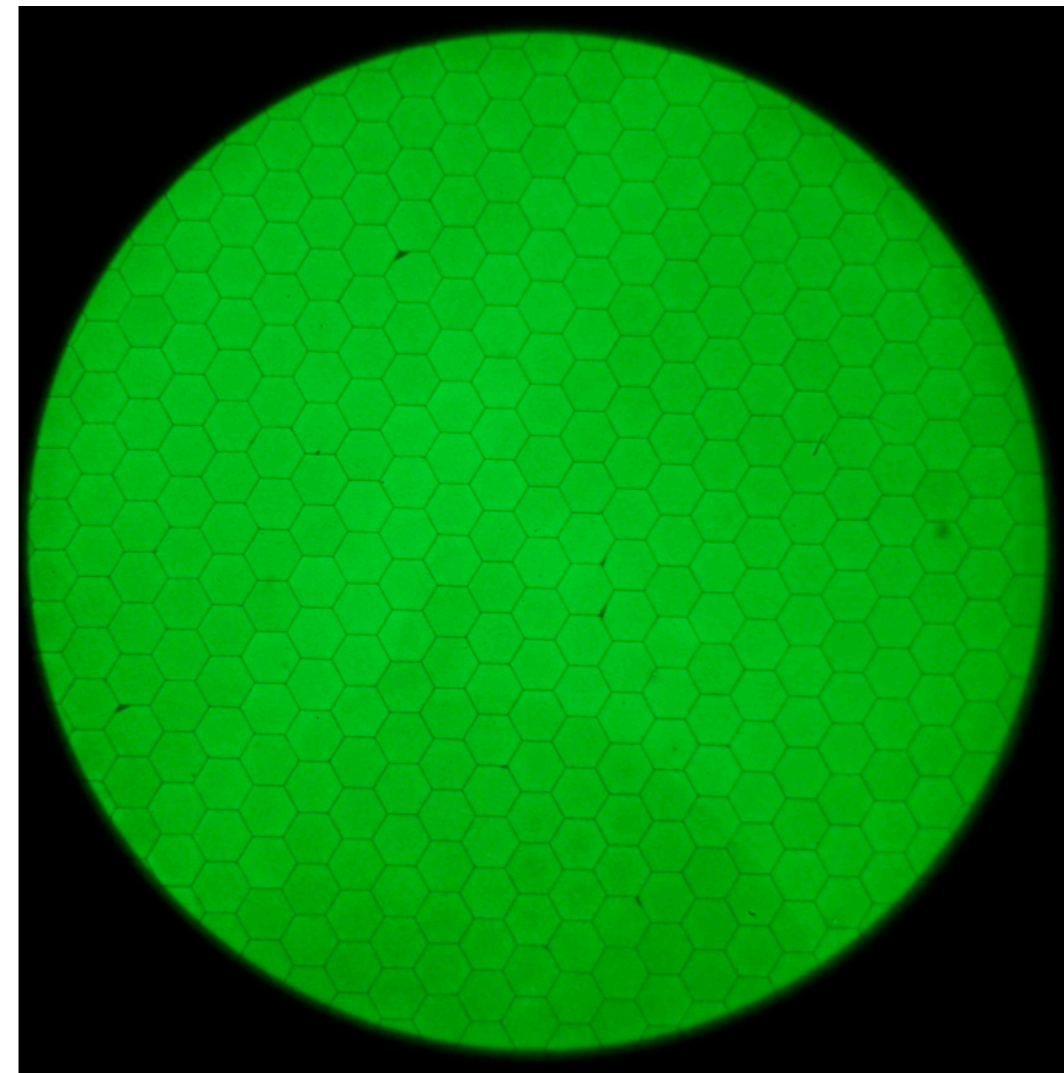


3000 sec background, 0.0845 events $\text{cm}^{-2} \text{sec}^{-1}$ at 7×10^6 gain, 1050V bias on each MCP

Robustness

MCP 162, 2nd Batch MCPs, 20 μ m

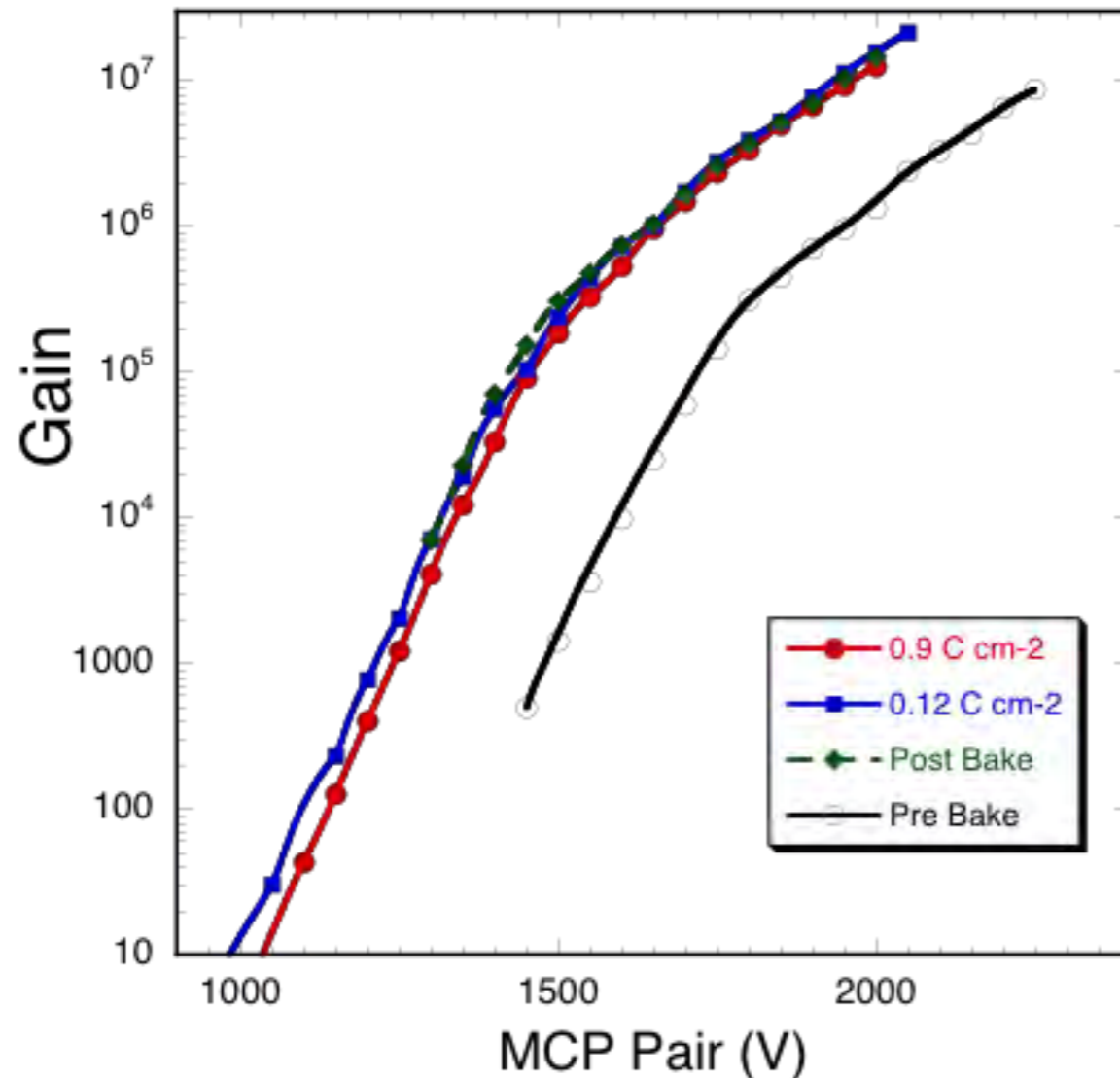
Breakdown event with a phosphor screen which essentially evaporated away the electrode on a part of MCP162.



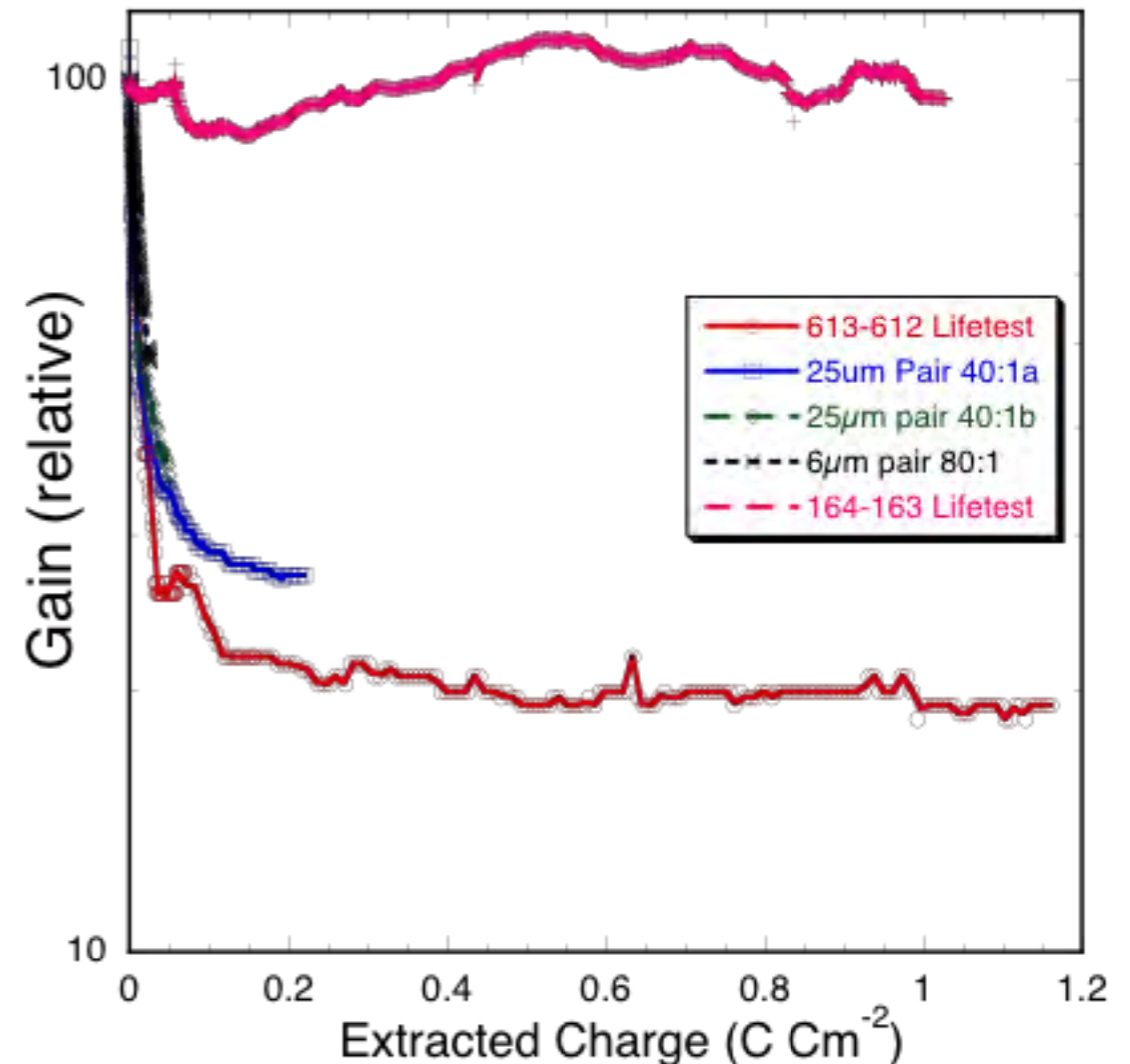
Inspection showed no melting of the pores.
Electroded on top of the damaged face and tested in phosphor detector – no sign of damage!
Any regular MCP would have been toast – melted!!!

33mm ALD MCP Pre-Conditioning Tests

Vacuum 350°C bakeout with RGA monitoring first, then UV flood low gain, then high current extraction “burn in” (1 – 3μA). **Most recent ALD formulation:- Gain increases by x10 during bake, after 1 C cm⁻² only few % gain change!**



Gain curves of MCP pair (20μm pore, 60:1 L/d, 8° bias) at stages during preconditioning. Outgas during burn-in < 4 x 10⁻¹⁰ torr H₂.

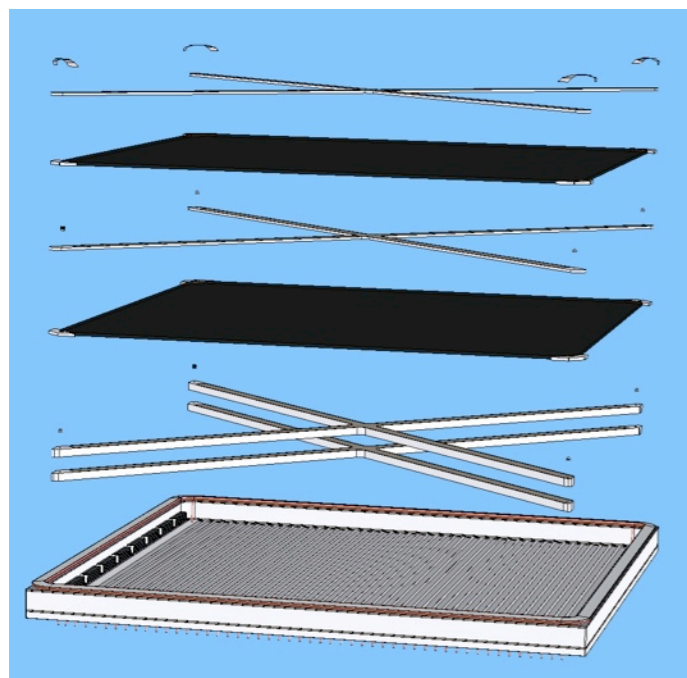


UV scrub of ALD MCP pairs 613-613 & 164-163, (20μm pore, 60:1 L/d, 8° bias) compared with conventional MCPs.

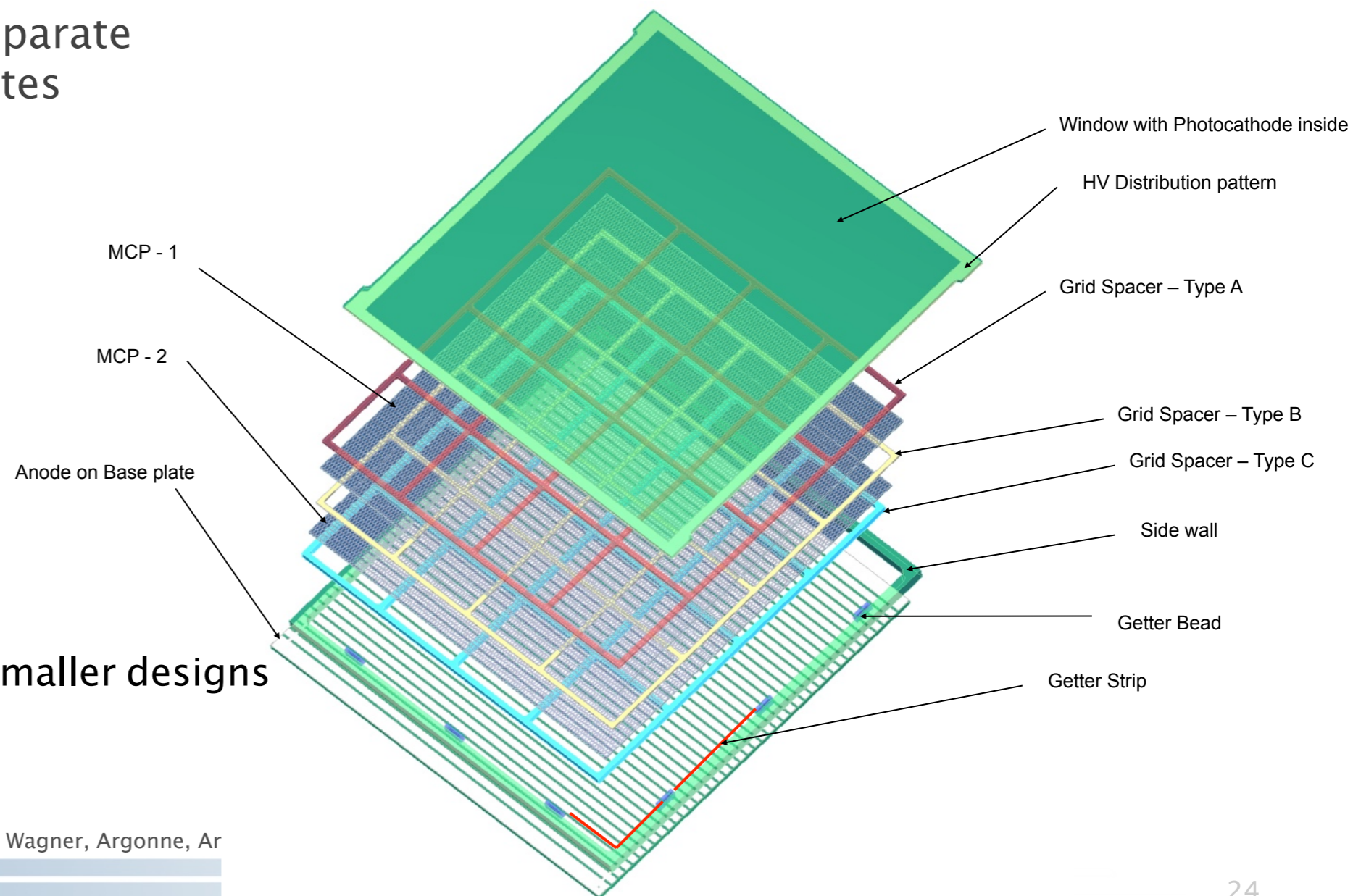
Hermetic Packaging

- ▶ For working MCP Photodetector, need to provide
 - Functionalized, Scrubbed MCP Plates
 - Vacuum tight housing
 - Bottom plate with anode strip lines
 - Sidewall
 - Top plate with photocathode
 - Getter strip for long term pumping
 - Support/Spacers to separate MCPs, bottom/top plates

Borosilicate all glass design:
 Frugal, innovative \Rightarrow higher risk
 No pin penetration into housing
 Under development at Argonne



Ceramic body:
 Expensive, brazed \Rightarrow proven in smaller designs
 HV & Signal via pins thru body
 SSL Design



Demountable 8" Tile Prototype



Inner, outer retainer rings for demountable O-ring seal

Inner, outer retainer rings for demountable O-ring seal

Leak checking of assembled demountable structure



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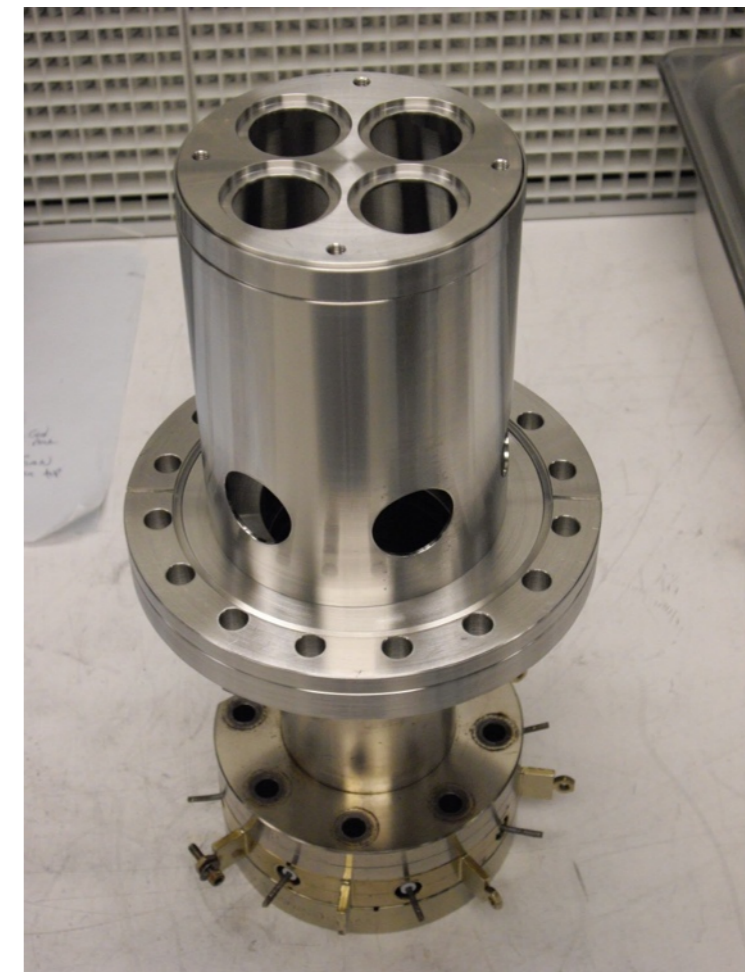
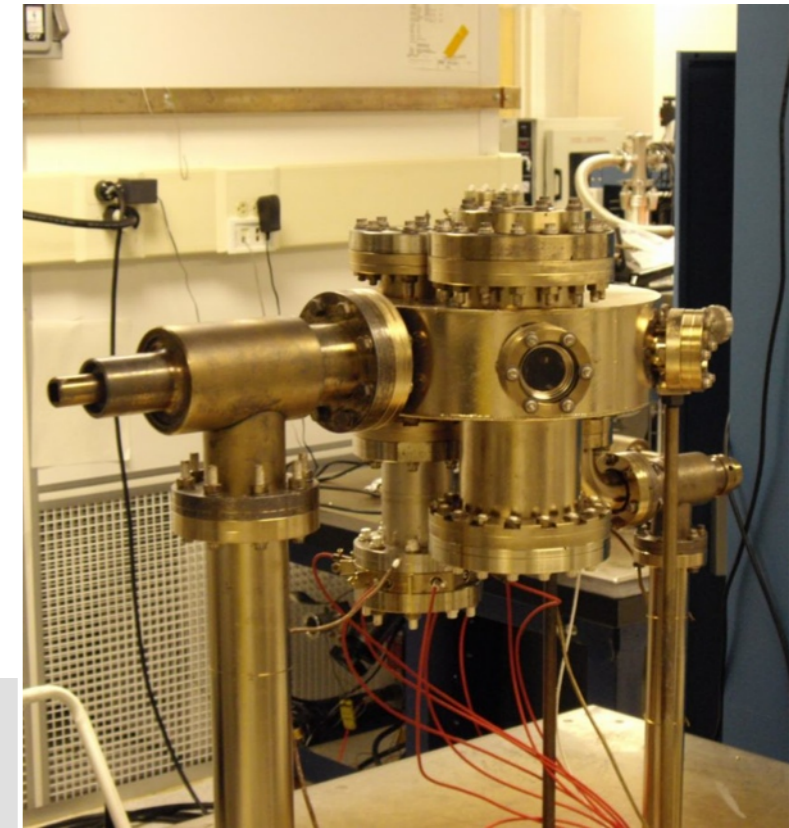
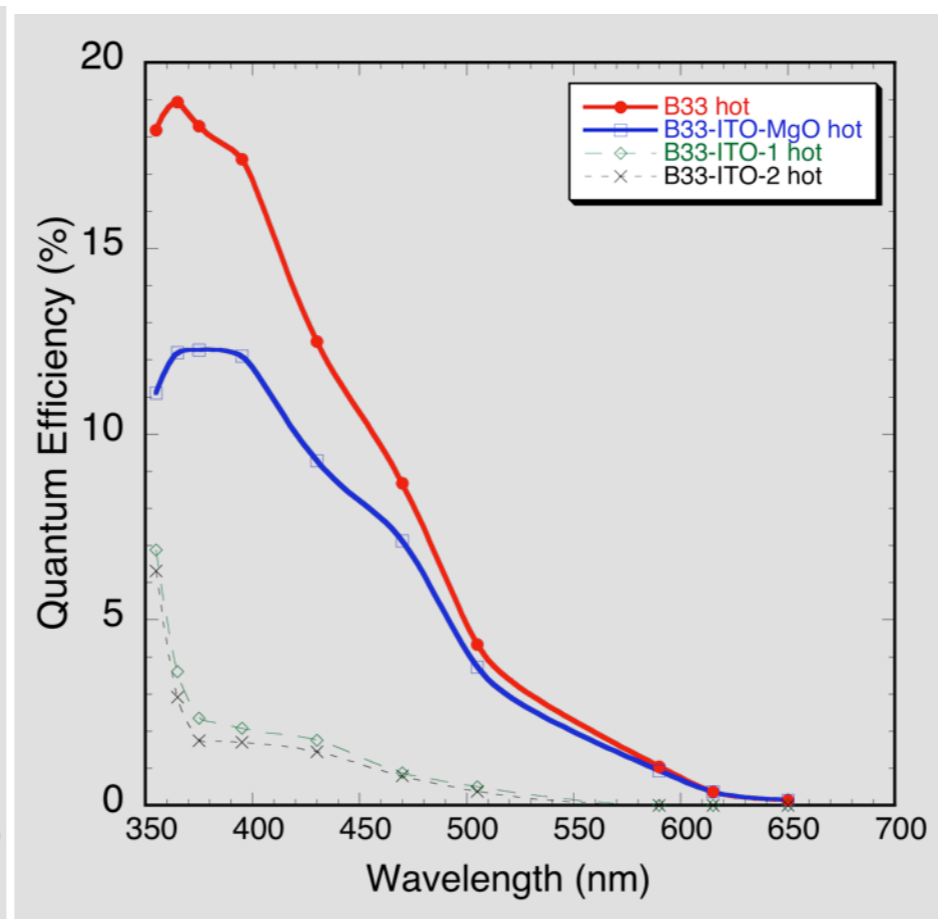
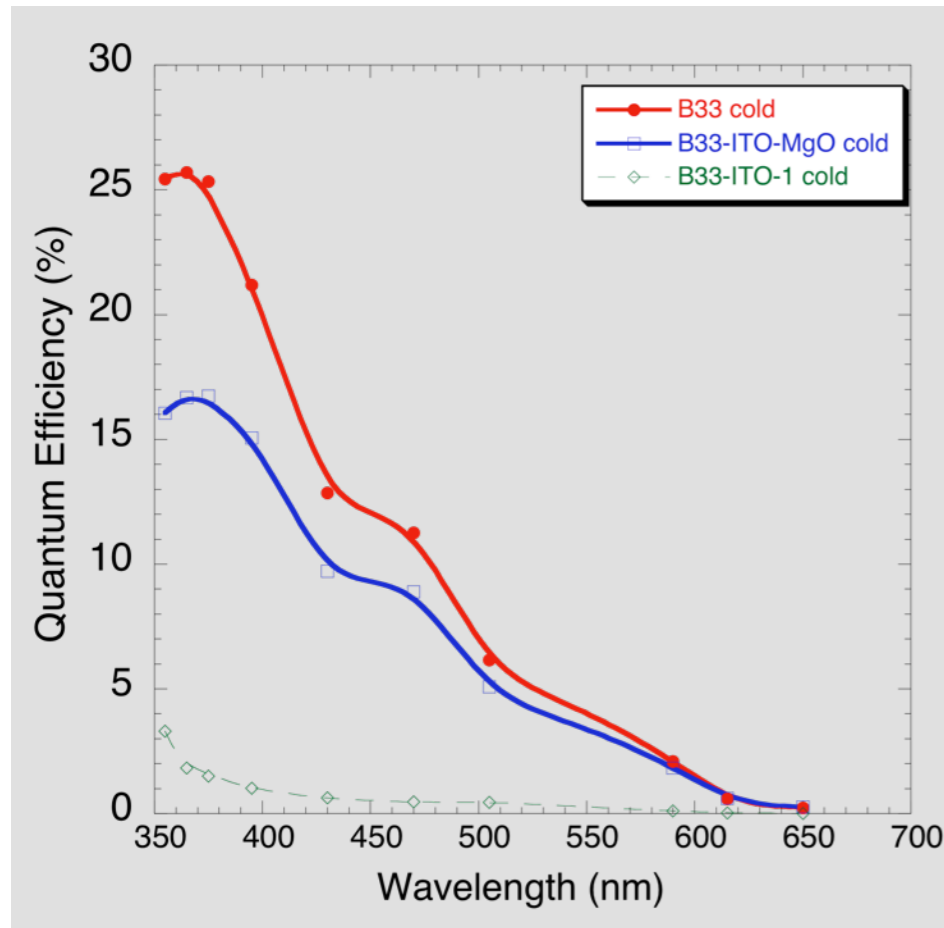


Photocathode Fabrication -- SSL

Cathode test run #6B, Na_2KSb cathode, Sb

B33, B33+ITO, B33+MgO/ITO substrates

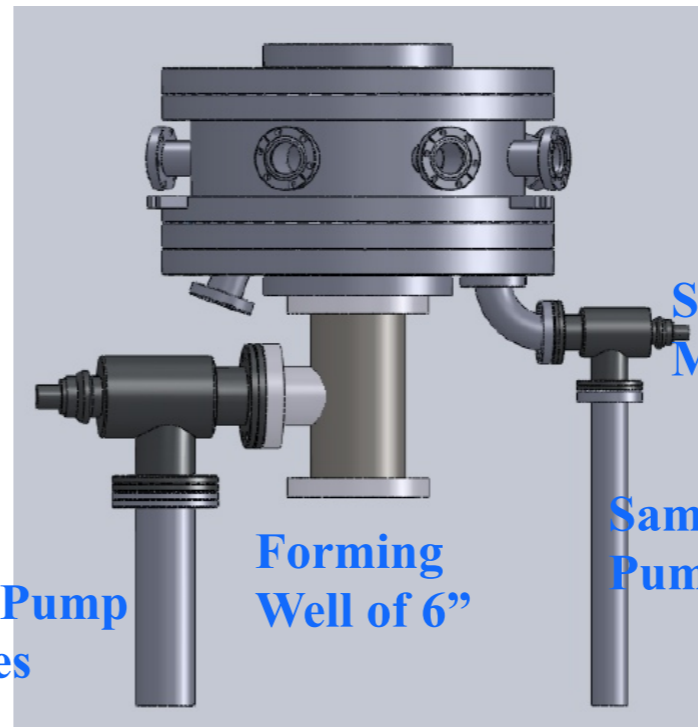
Substrates with ITO are very bad, ITO-MgO better, but not great



8.7" Photocathode & Seal Test Chamber



16.5" Flange
Chamber Access



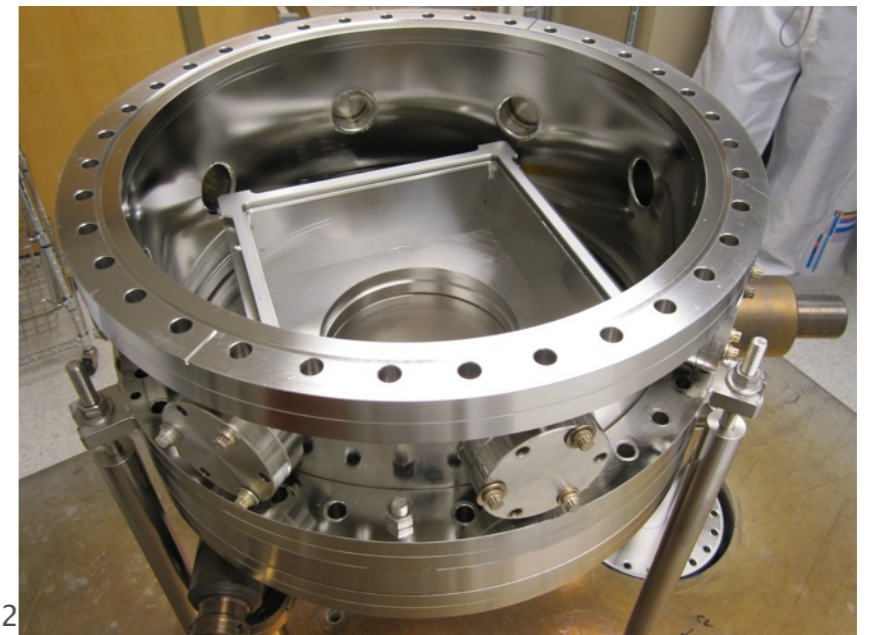
Same All-Metal Valves

Same Rough Pump Line

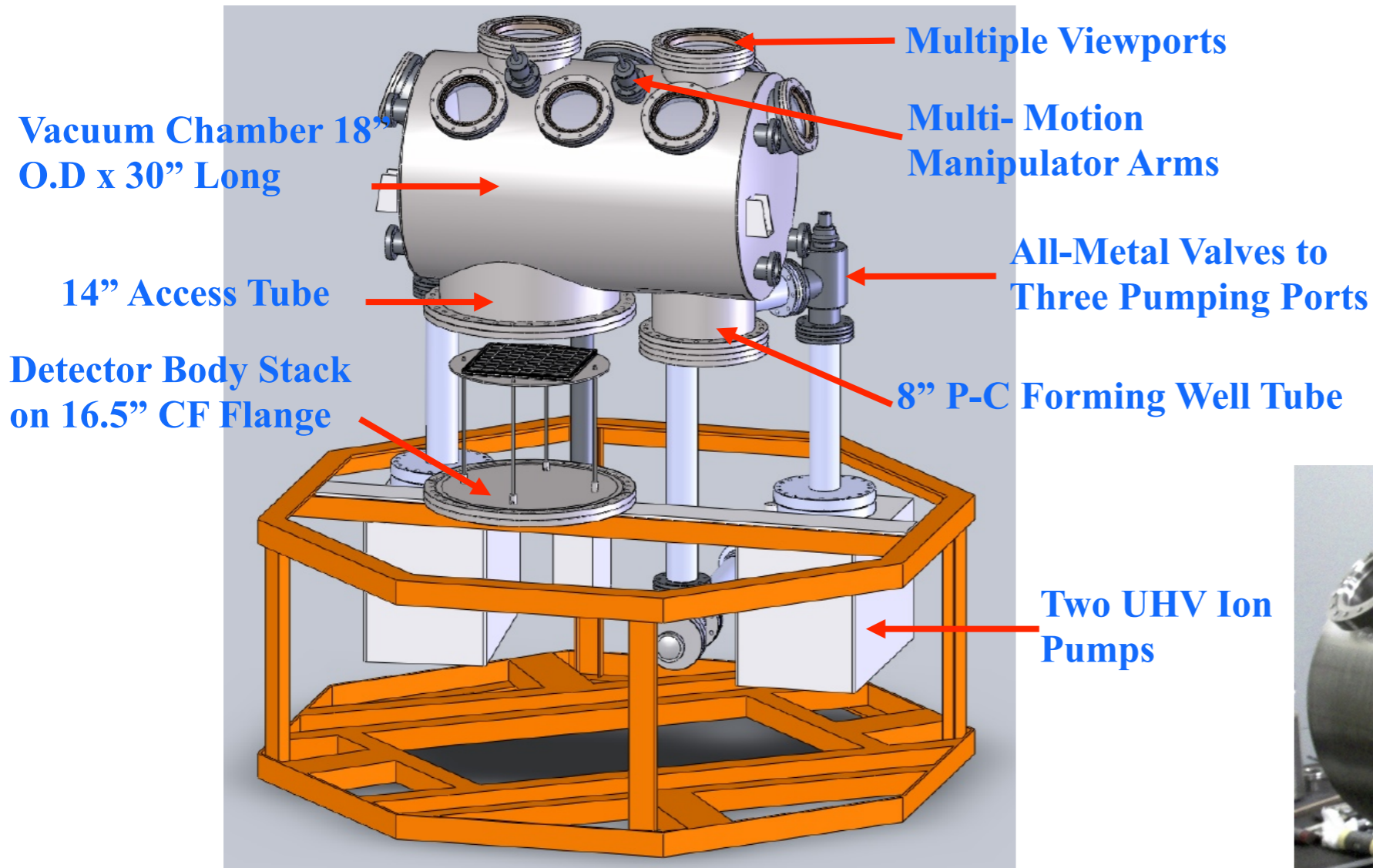
Ion Pump Lines

Forming Well of 6"

8.7" Photocathode/Seal Test Chamber



Large Process Chamber for Ceramic Tube Fabrication at SSL

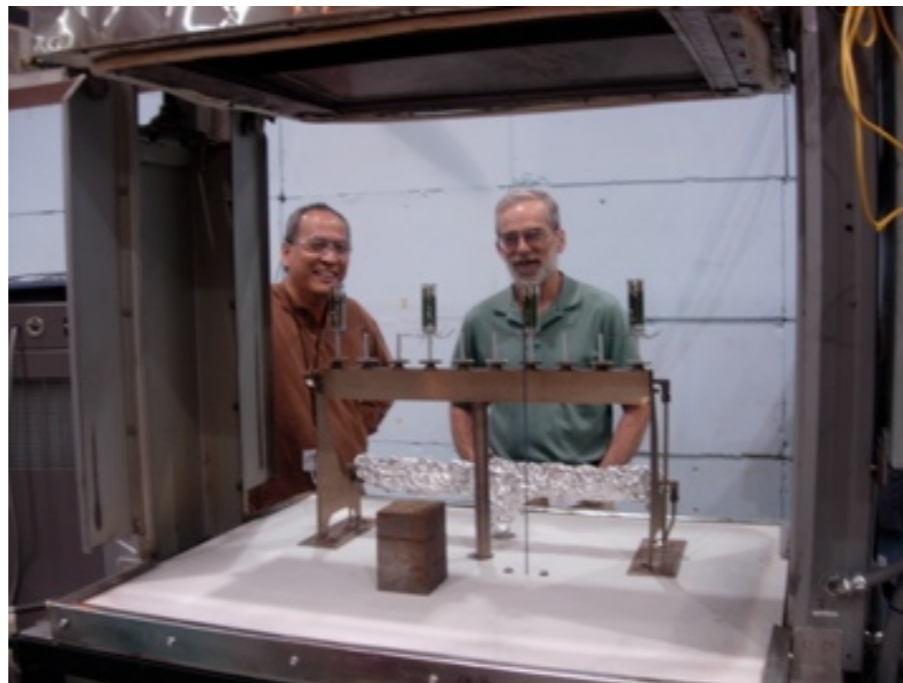


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Bialkali Photocathode Development at Argonne

- ▶ Shoot photocathode similar to traditional PMT method
 - metal beads activated by current heating
- ▶ Use glass containment vessel with bead support structure & detachable top window
- ▶ Learn method by making photocathodes on small PMTs
 - PMT processing equipment obtained from Burle Industries

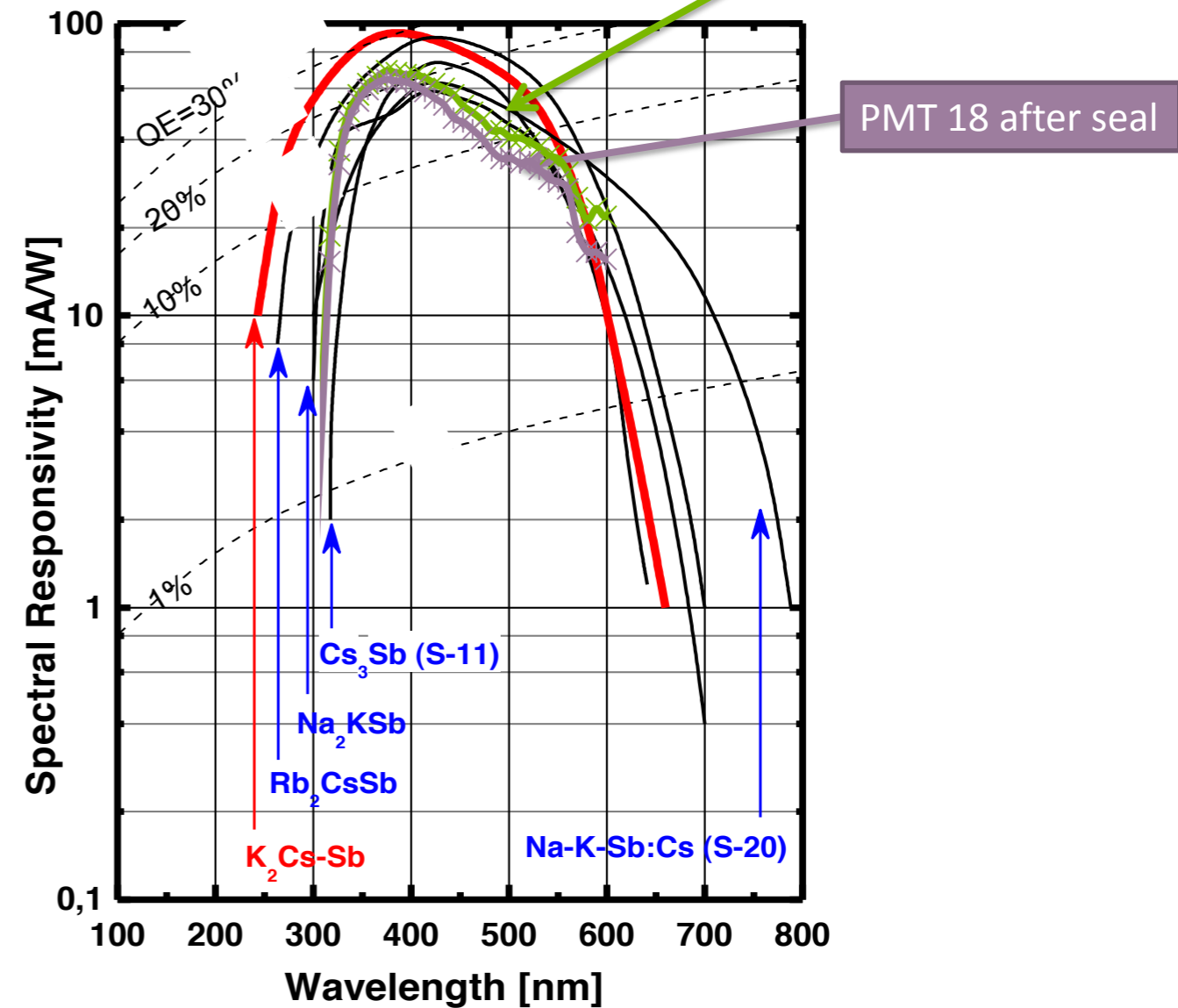
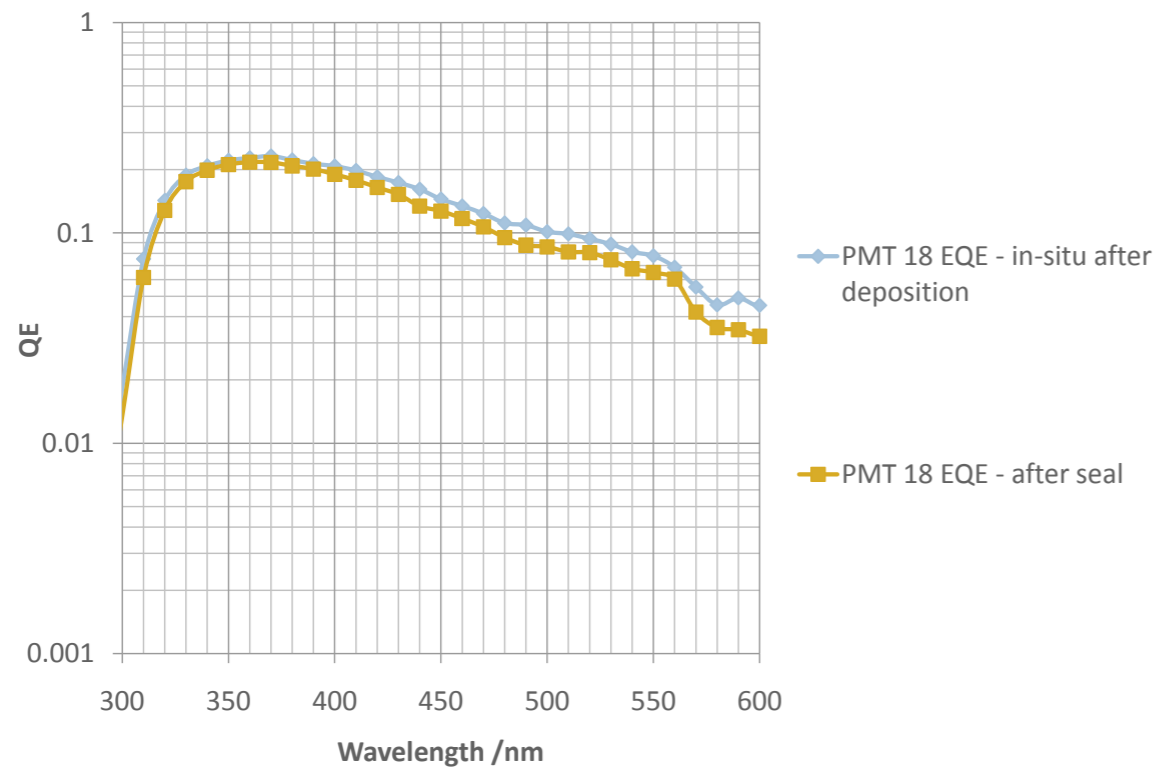


Towards Large Area MCP Photodetectors, R. Wagner, Argonne, Antiproton Physics Workshop, Fermilab, 20111118

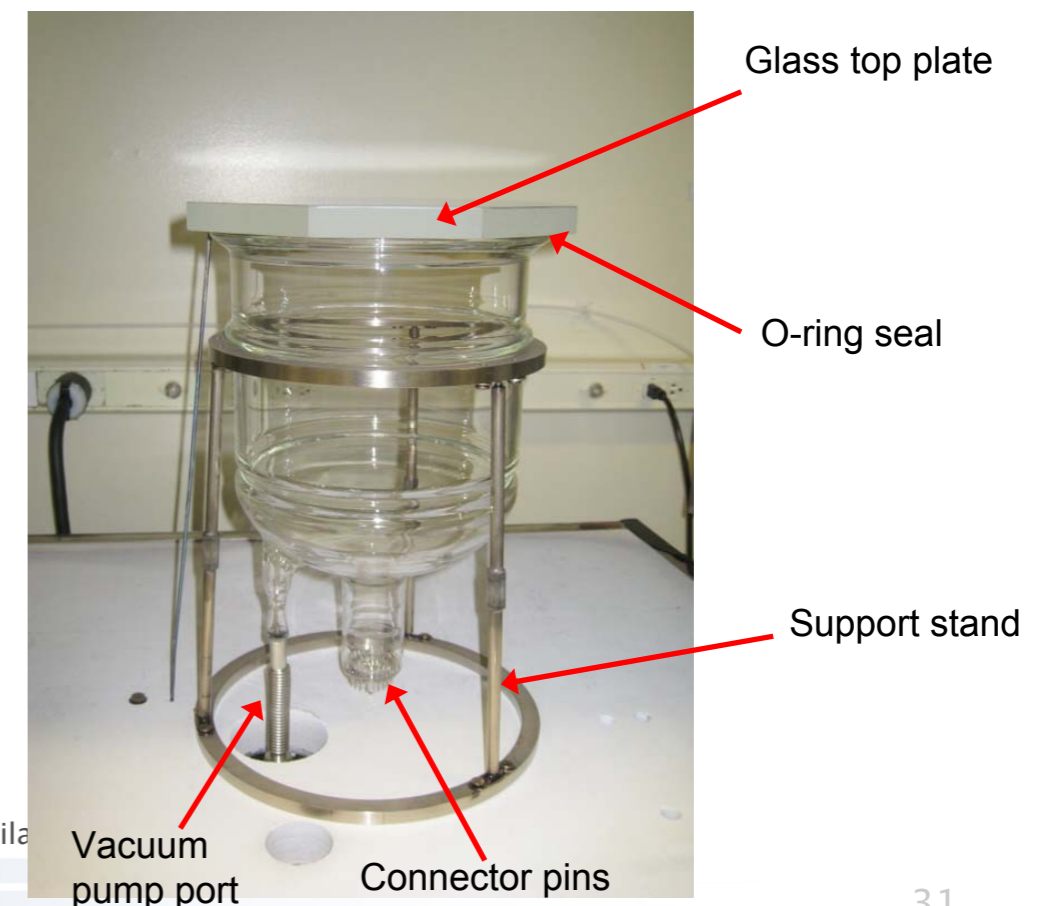
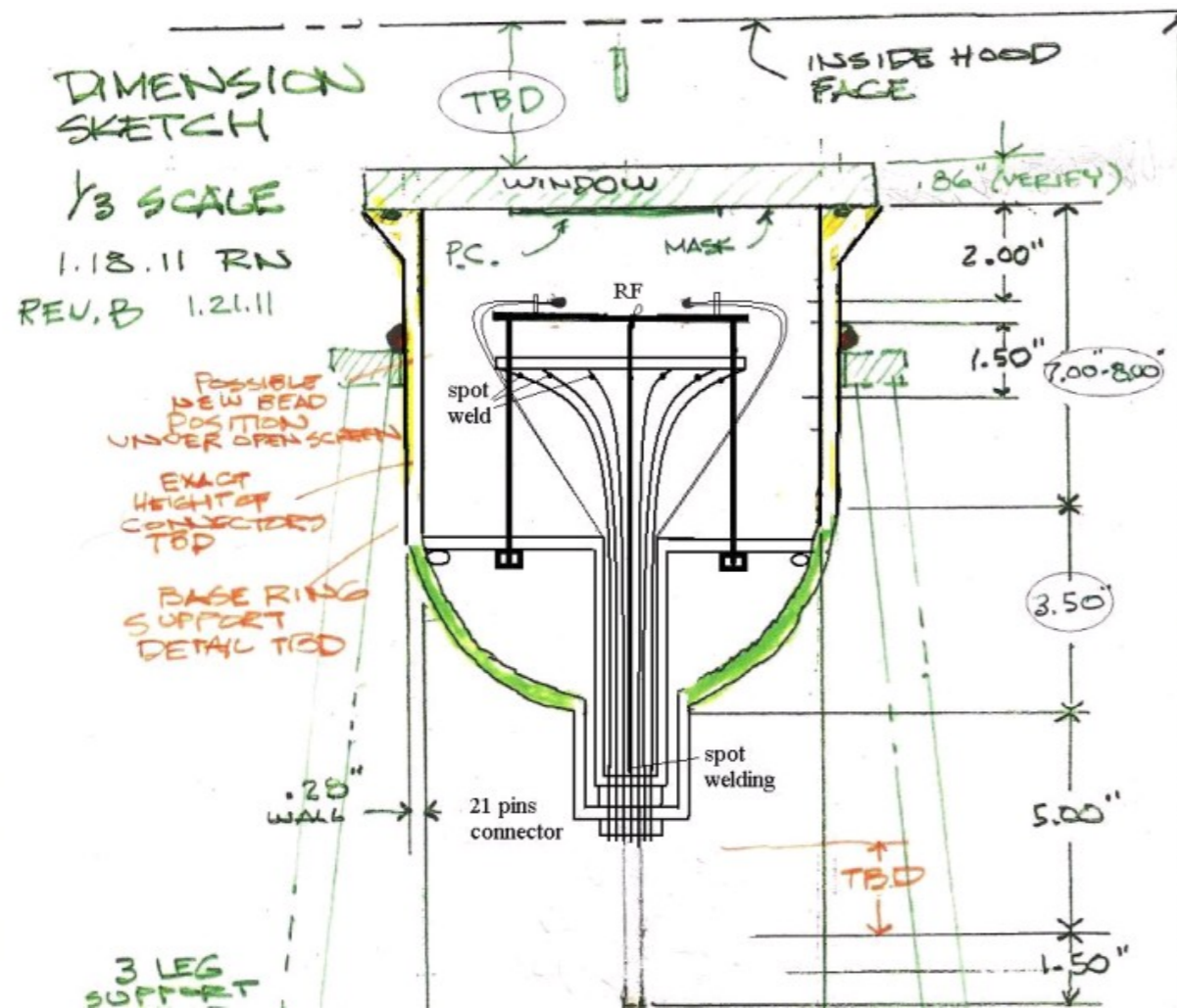


Results from Photocathode Growth in Burle Process Chamber

Spectral responsivity



Bialkali Photocathode -- Scale-Up to 4" Photocathode



Summary

- ▶ Large Area Microchannel Plate Photodetector project has completed 2nd year
- ▶ Many critical milestones achieved for detector realization
 - Signals acquired from full-sized tile base with 33mm MCP pair in 8" test ch.
 - ALD coatings of 33mm glass capillary disks producing gain $>10^6$ for MCP pair
 - Observation of gain from 8"×8" MCP
 - Production of detector quality 8"×8" glass capillary arrays
 - Developed 3 ALD resistive + 2 ALD emissive chemistries
 - Low temperature (120 °C) In(52)Sn(48) seal made on 1" sidewall/window
 - Readout ASIC for picosecond resolution fabricated & tested (4th gen. chip due in October)
- ▶ Mature mechanical designs for hermetically sealed tube
 - Proven design in ceramic by SSL
 - Well-advanced inexpensive glass design -- hermetic prototypes
- ▶ Facility for 8"×8" photocathode fabrication and study near completion at SSL
 - Full-size process chamber installed, near commissioning
- ▶ Tile production facility for All-Glass MCP-PMT in design at Argonne

Visit our web site for more information:

<http://psec.uchicago.edu>

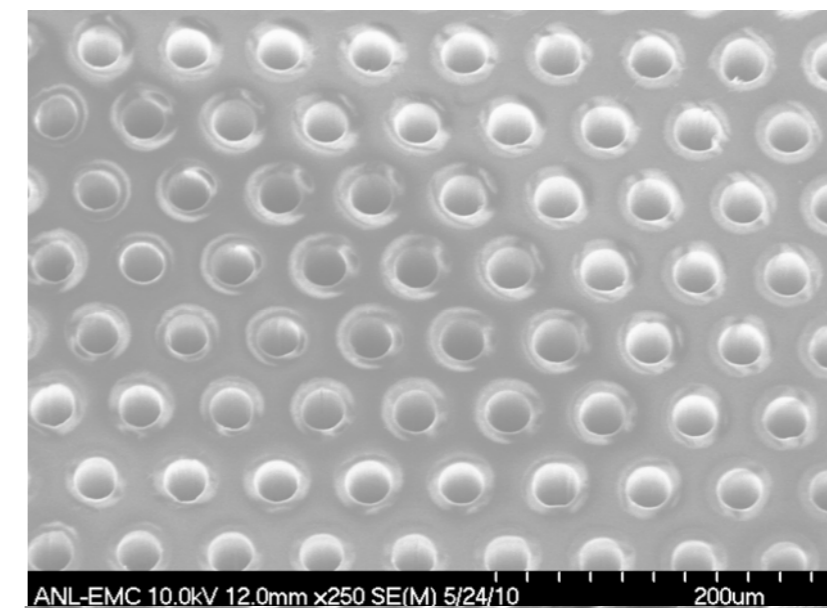
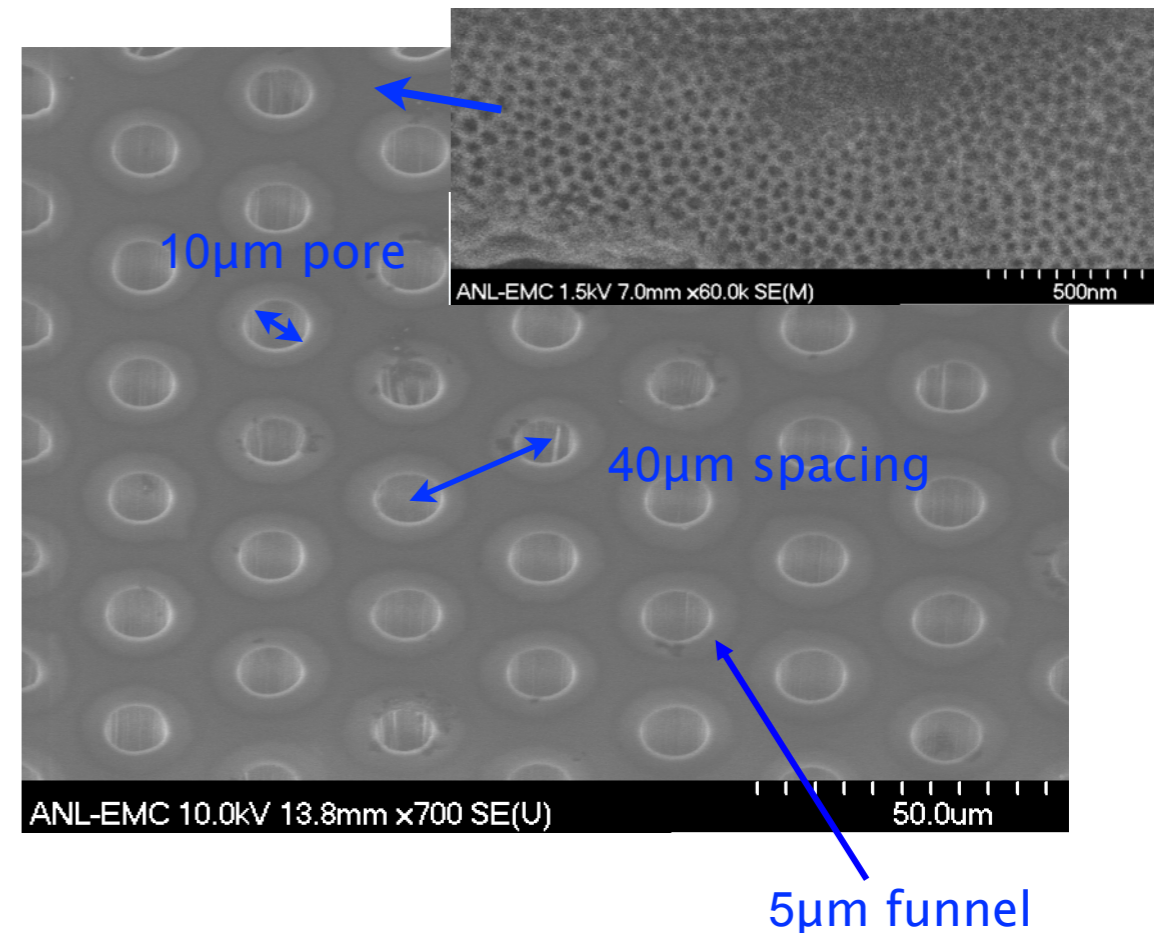
("Blog" and "Library" links are a good starting place)

BACKUP SLIDES



Anodic Aluminum Oxide (AAO) Development

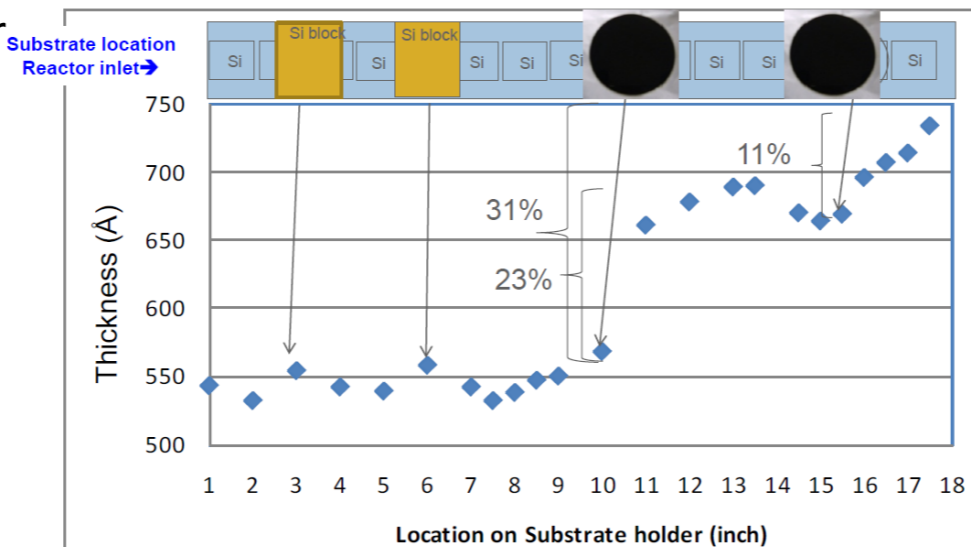
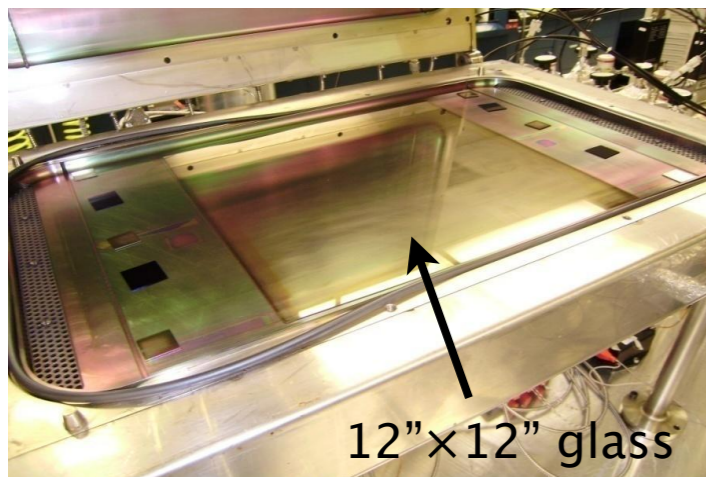
- ▶ Self-ordering fabrication of pore structure in aluminum by anodization
- ▶ Alternative to glass capillary MCP
- ▶ Argonne AAO fabrication is 2-step
 - Form 10nm pore matrix through anodization (more “natural” size for process)
 - Pattern and etch 2–10 μm pore via photolithography
 - Initial 10nm pore structure enables uniform etch larger diameter pores
- ▶ Development at Argonne is very successful
 - Now producing pores with funneled pores
 - Potential for large effective open area ratio
 - Addresses first-strike problem
 - Possible future generation of MCP with Photocathode coated on funnel via ALD



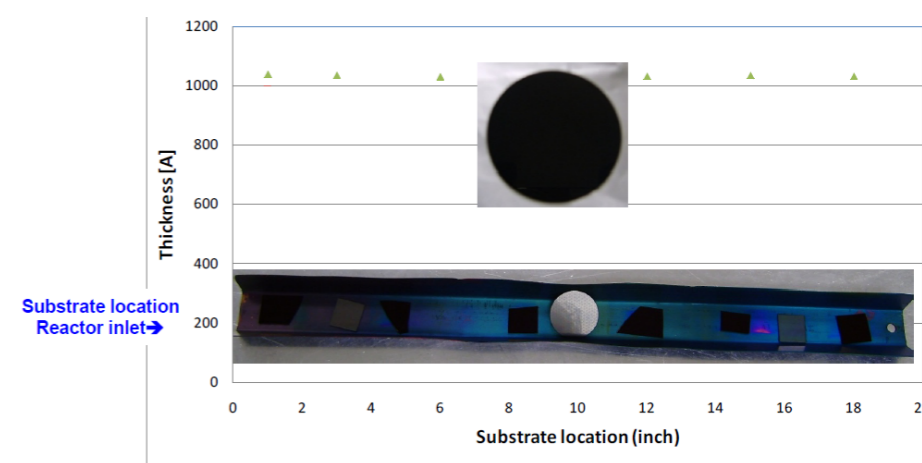
32.8mm AAO test substrate
20 μm pore, L/D~10, 23% open area

Scale-up to Large Surface Area

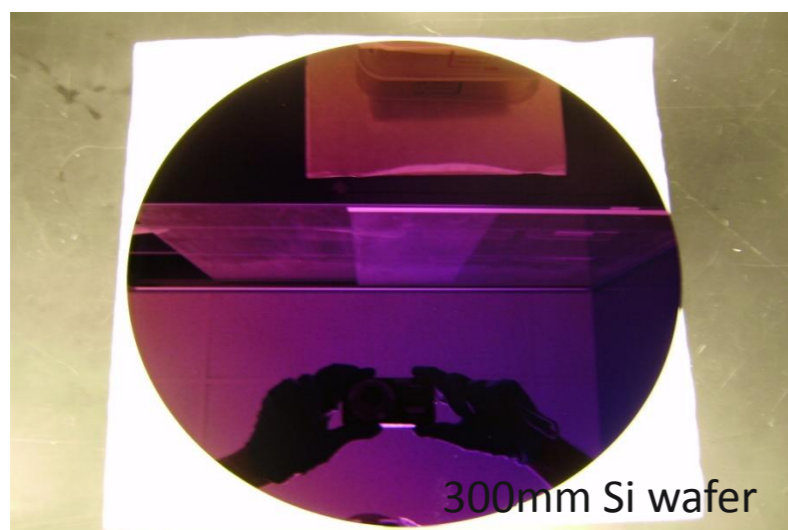
Process scale-up on large reactor



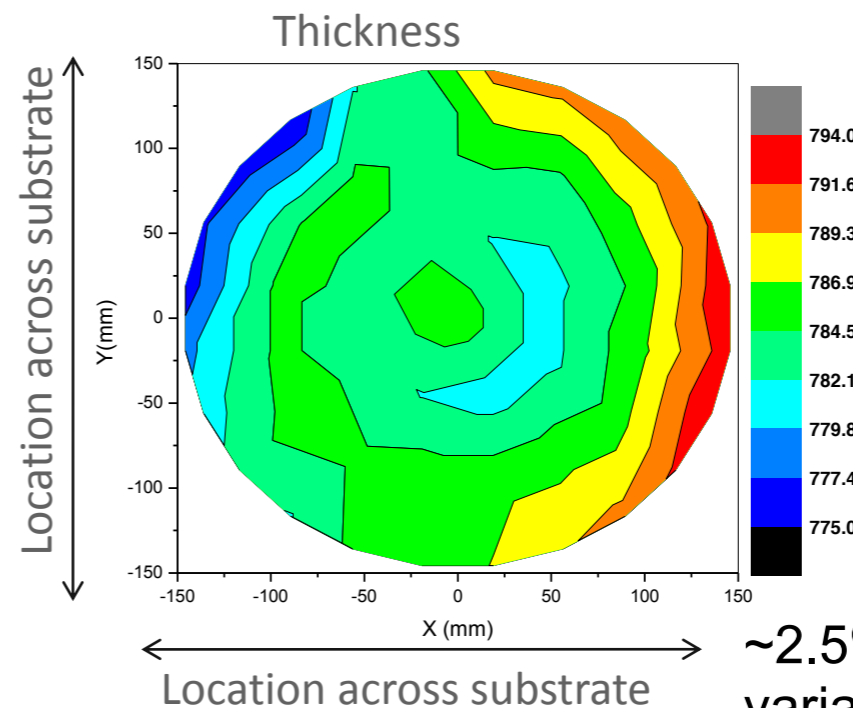
Chemistry #1:
 1% thickness increase across Si wafers
 Up to 30% increase after MCP locations



Chemistry #2:
 No thickness increase near MCP
Uniformity, scaling ease in ALD
 are process dependent



300mm Si wafer coated with Chemistry #2



~2.5% thickness variation across wafer



Scale-Up of ALD Processing -- Beneq Reactor

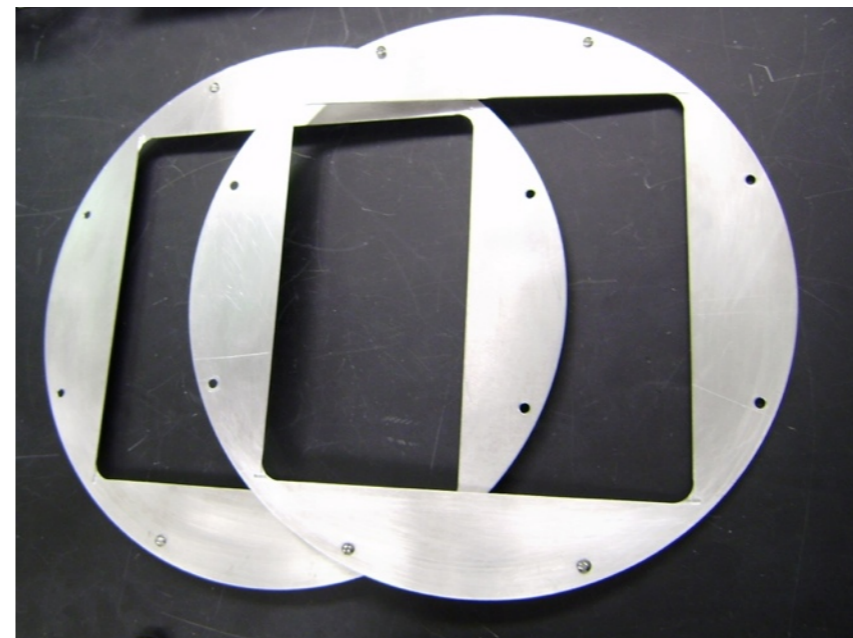
Arrived 18 May 2010

Studying ALD on Large Surface Areas

- 33mm disk surface area is 0.13m^2
- 8"x8" surface area is 6.4m^2
- 20 MCPs area is 129m^2



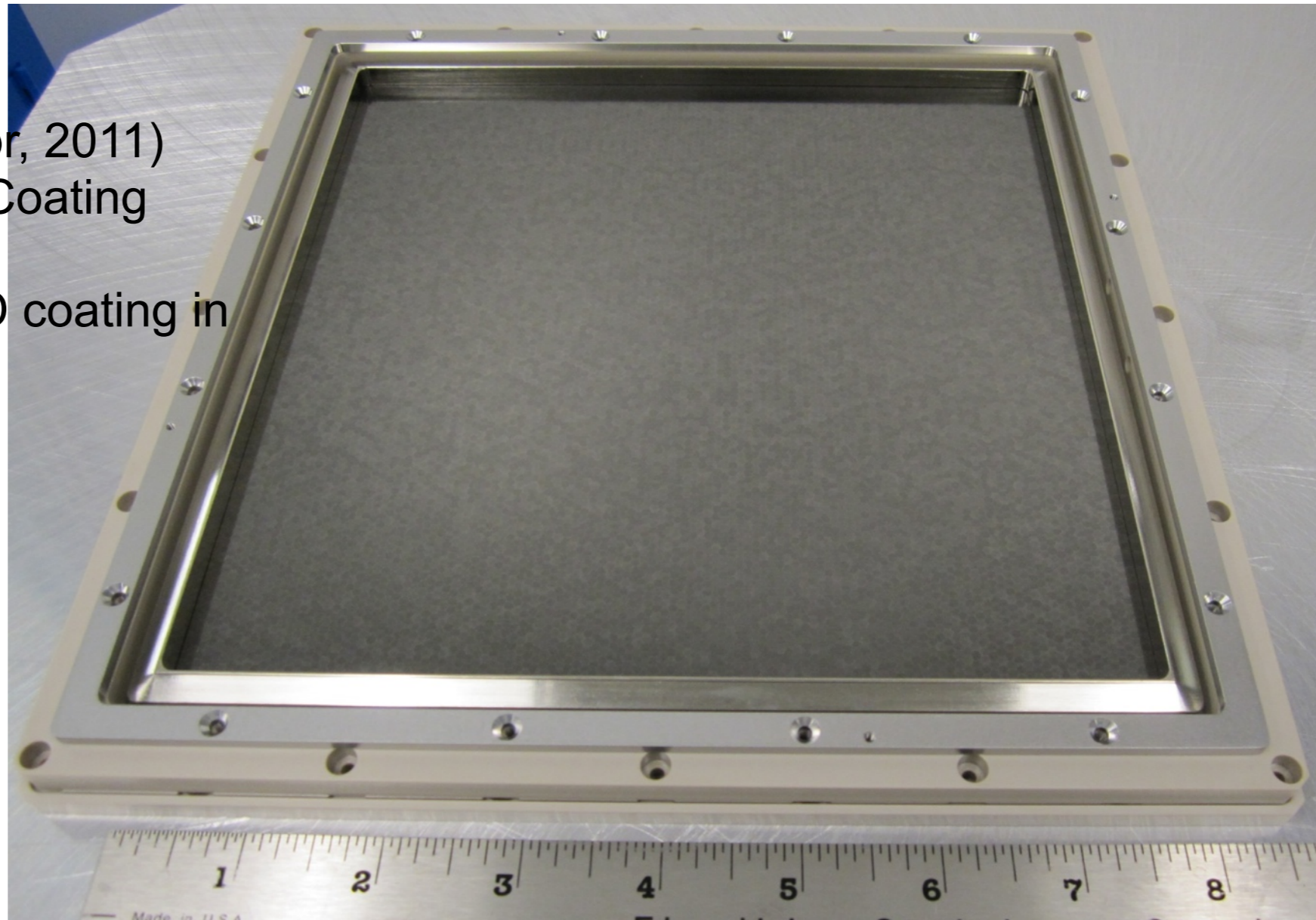
Stackable 20cm × 20cm plate holders for multiple plate coating in Beneq Reactor



8"×8" MCP Plate Testing at SSL

ALD Coated 8"×8" 20 μ m MCPs
1st production quality plates (Apr, 2011)
Develop process for Resistive Coating

Tuning parameters now for ALD coating in
Beneq reactor



8" electroded MCP in the open face test detector.

MCP #3 and MCP #2 have been electroded on both sides with 1700 \AA inconel.
#2 is 31k Ω and #3 is 3M Ω in air - and vacuum (Needs to be \sim 10-30M Ω).

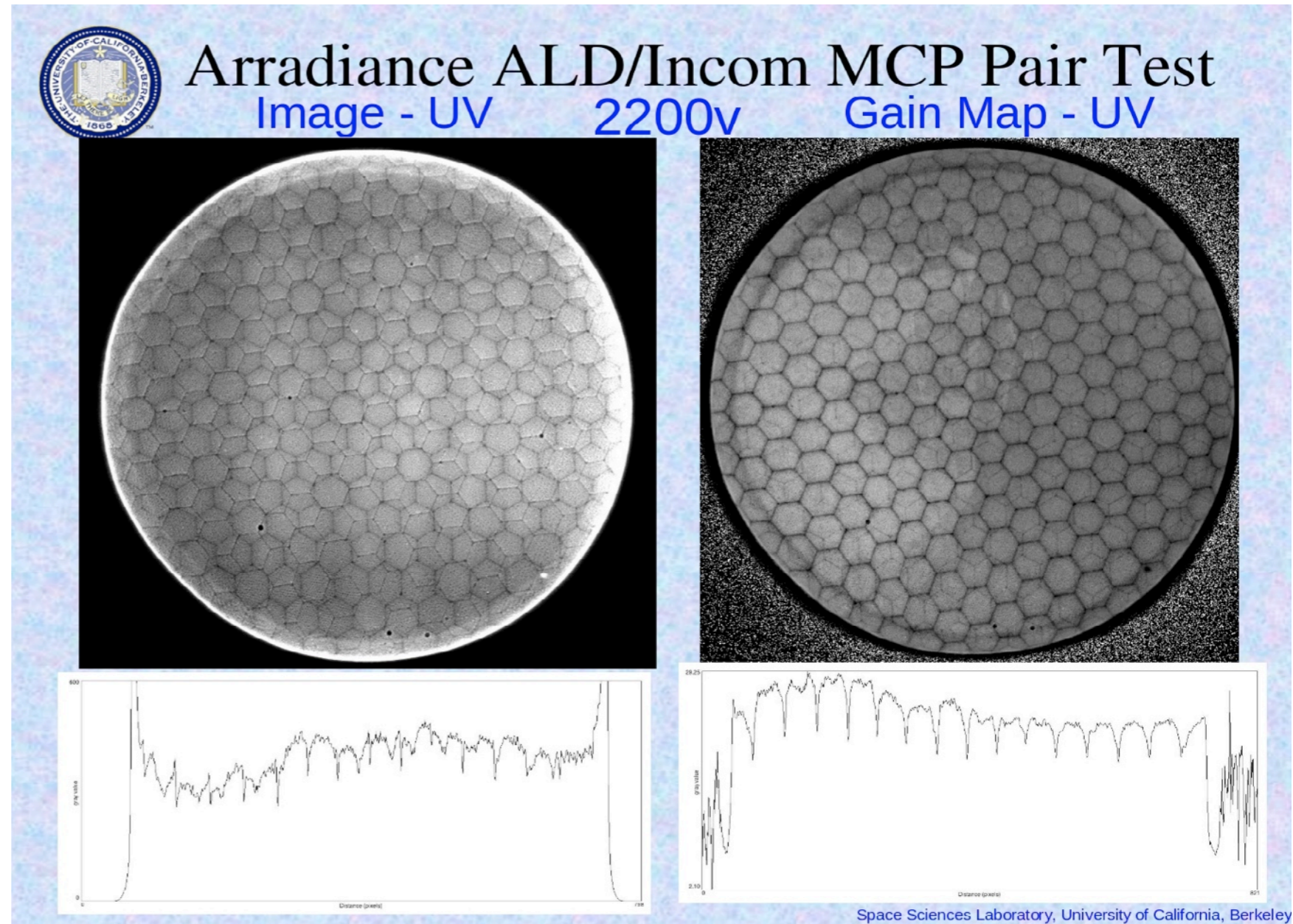
Visual Study of ALD Coated MCP at SSL

Glass capillaries coated by Arradance, Inc.

Pair test at Space Sciences Lab/UC-Berkeley

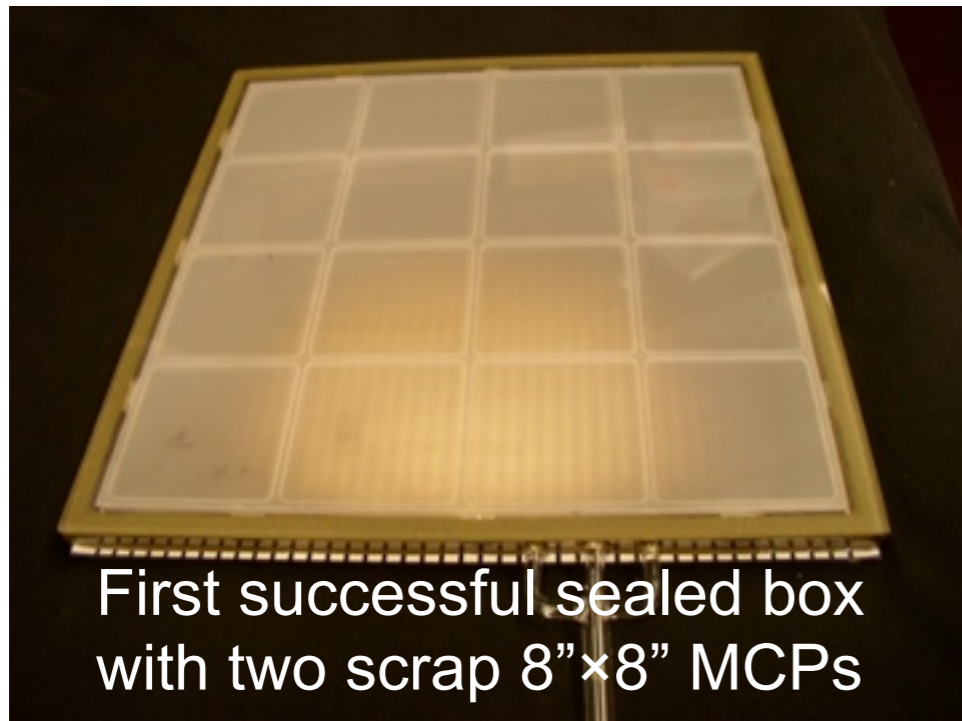
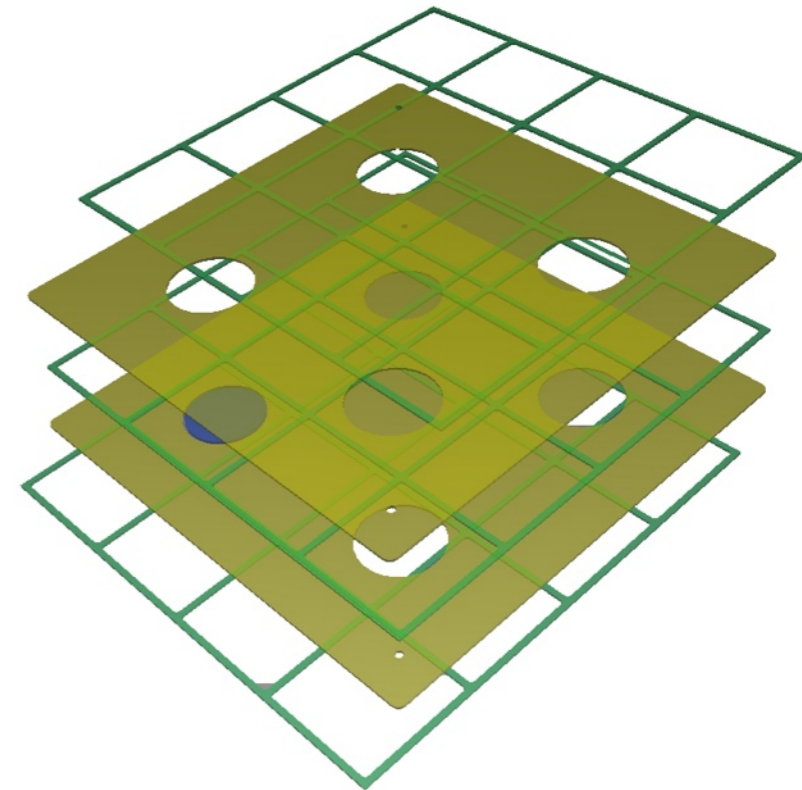
Electron map of MCP

“Multi” boundaries visible, fade at higher gain

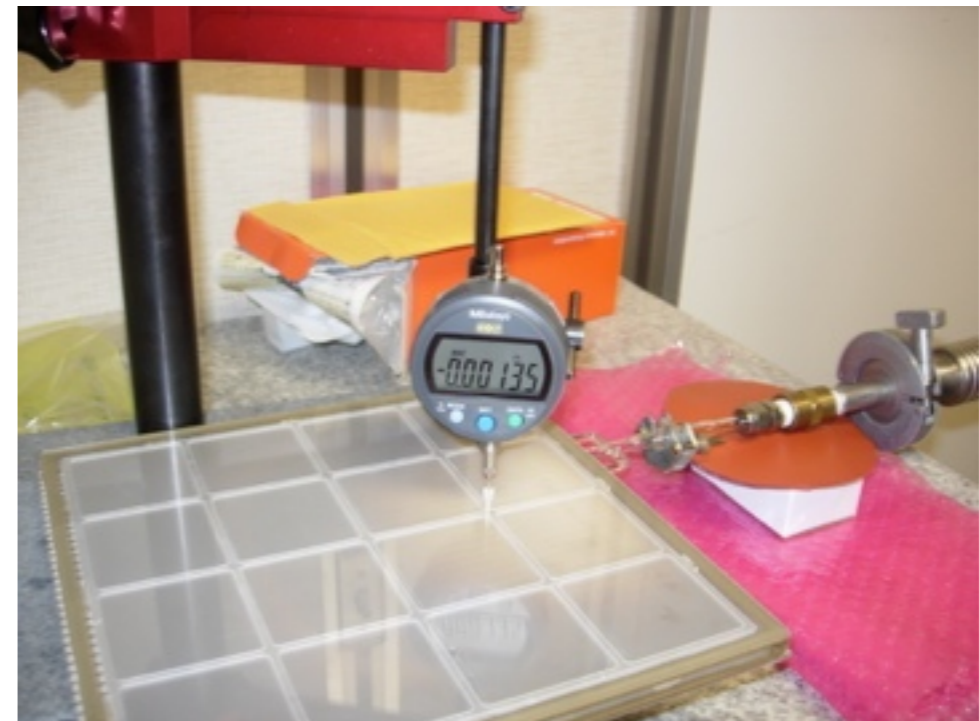


Mock Tile Fabrication

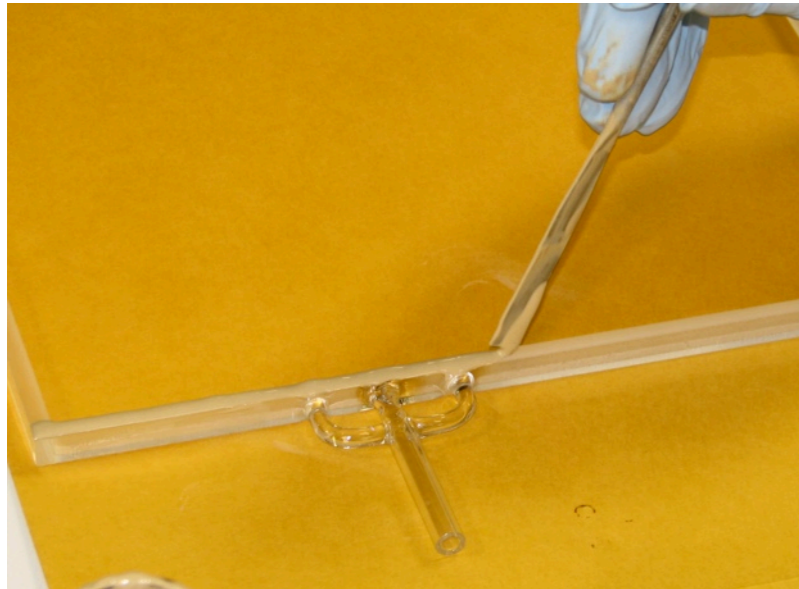
- ▶ Short-cut to testing full assembled large area MCP-PMT
- ▶ Glass 8"×8" Mock MCP w/4 holes for 33mm functional MCP pairs
- ▶ Use tile bases with pump-out port on sidewall & standard anode bottom plate
- ▶ Top window with Al photocathode
- ▶ Top seal with glass frit (like bottom seal)



First successful sealed box with two scrap 8"×8" MCPs



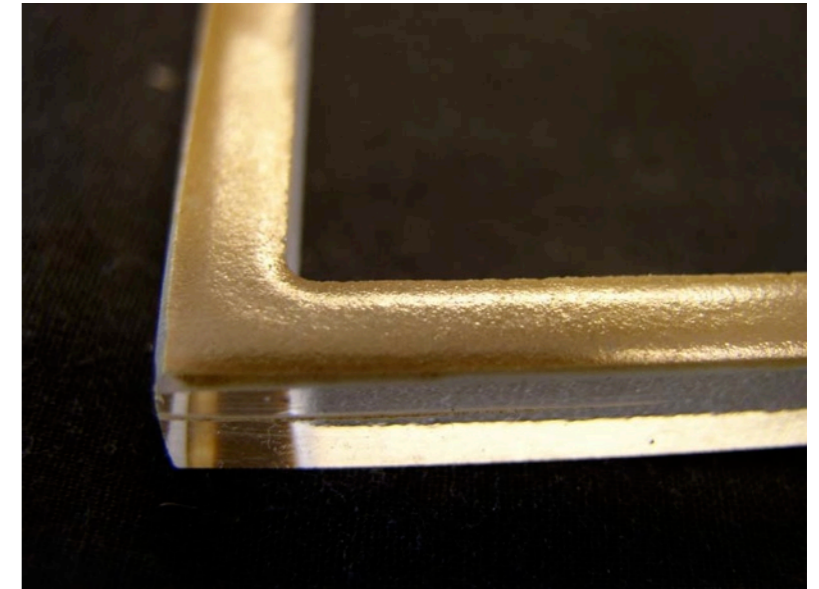
Mock Tile Fabrication -- Tile Base



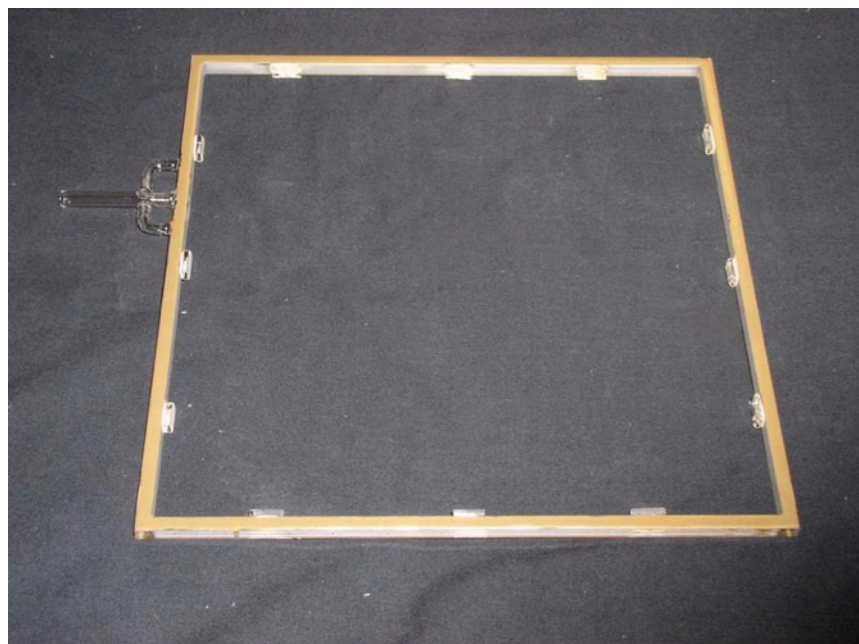
Apply Frit Paste to Sidewall



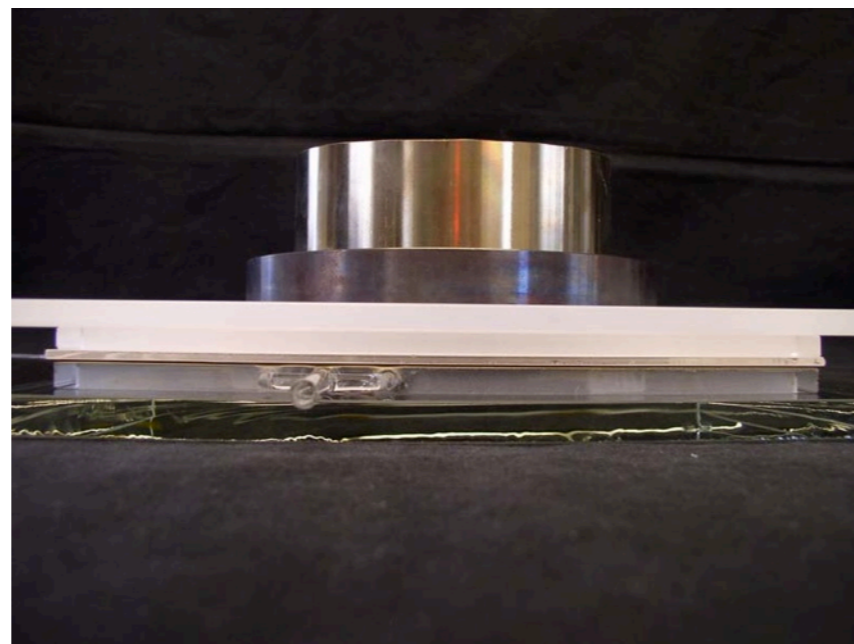
350°C Fire to Dry Paste



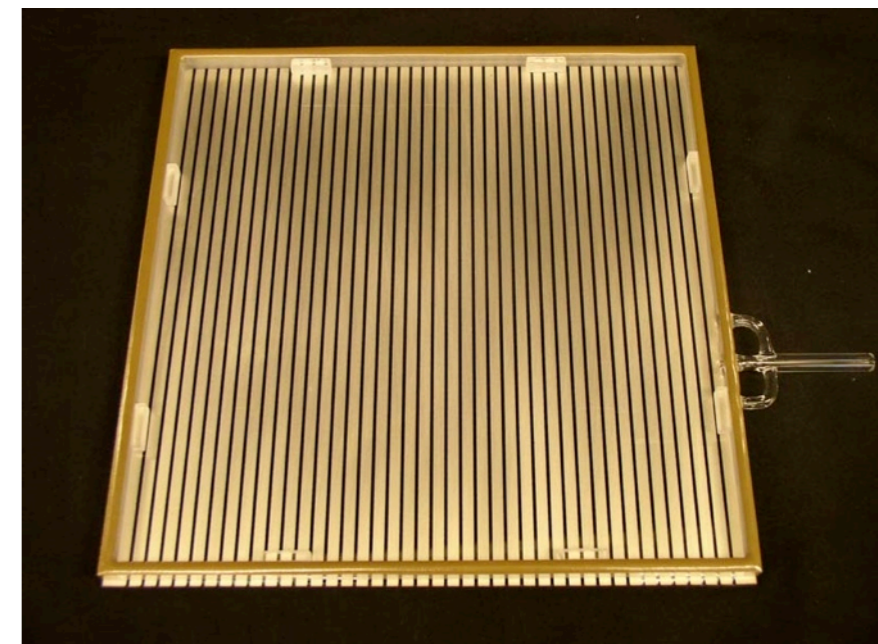
470°C Fire to Glaze



Attach Getter Holders
Silver Ink Frit @ 350°C



470°C Fire to
Bond Anode Plate

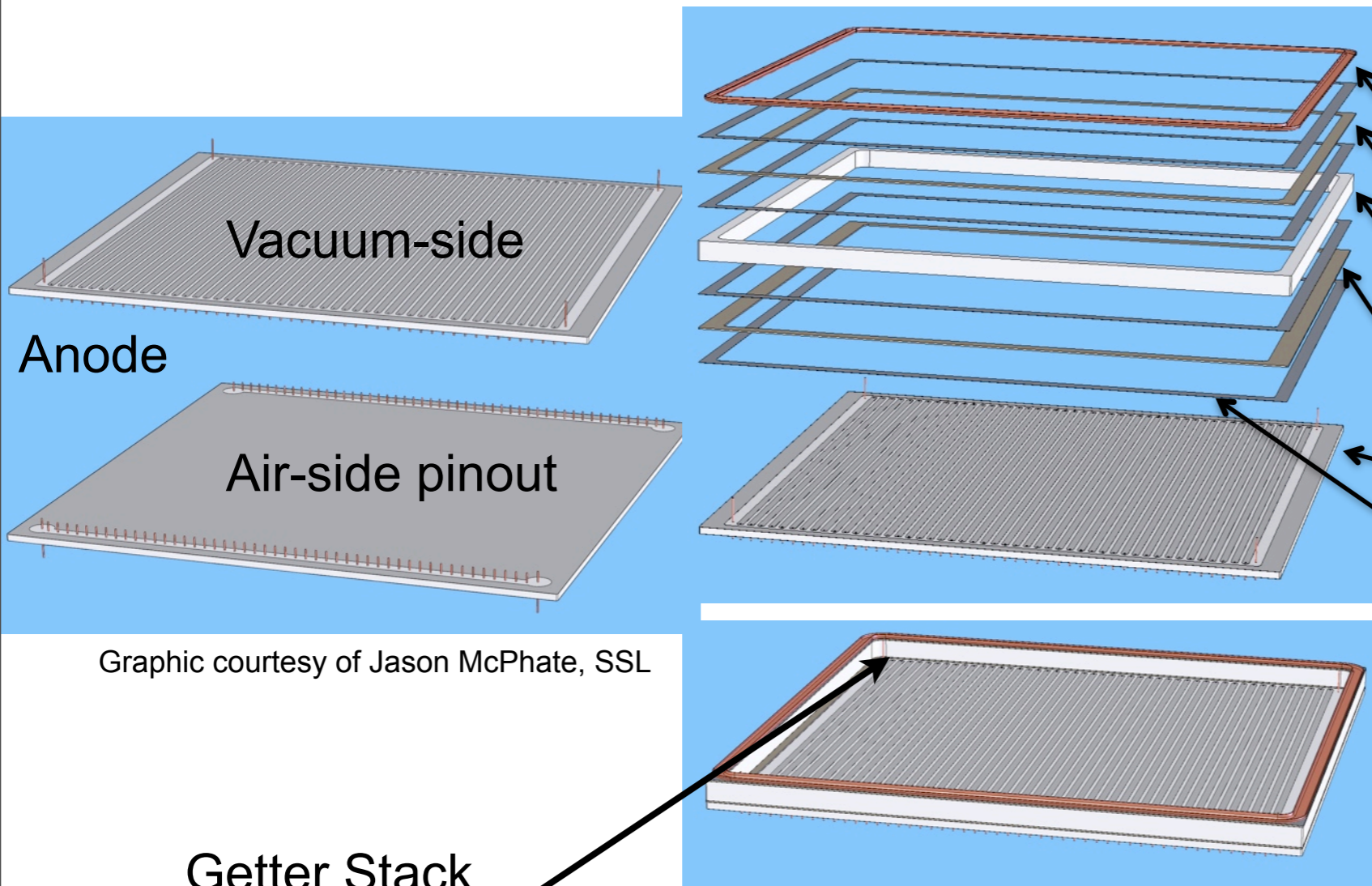


Completed Tile Base
w/Vacuum Tight Bond

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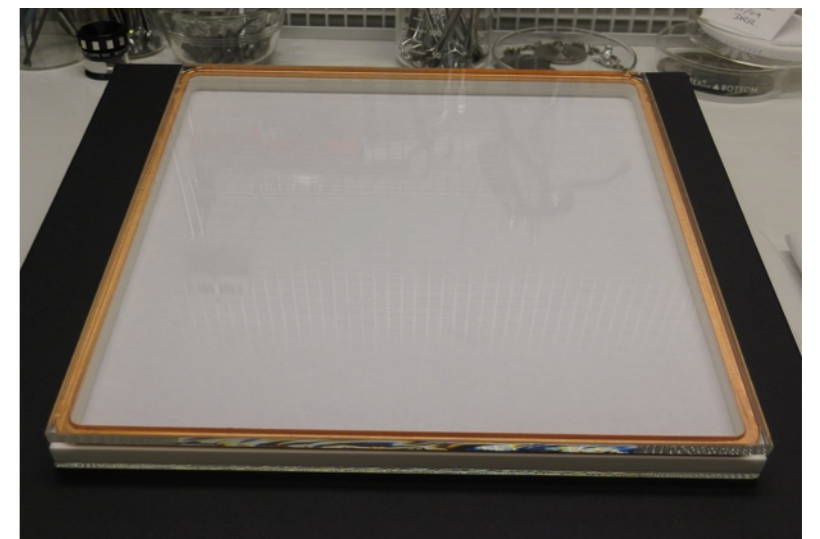
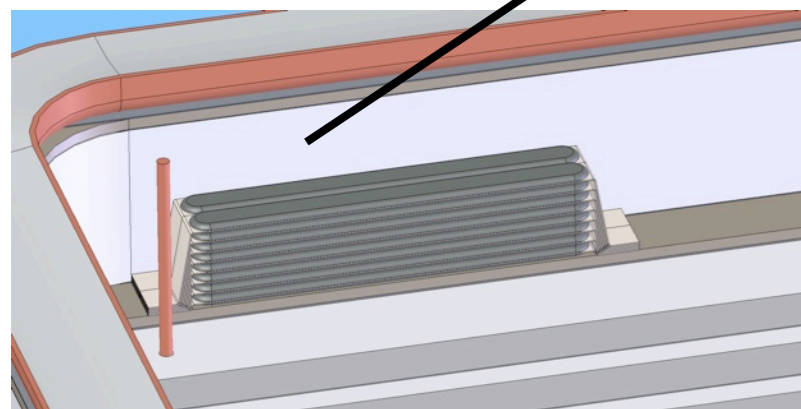


Ceramic Body Design -- SSL



- Single step braze
- Stamped OFHC Cu or Kovar indium well
- Kovar intermediary flange
- Alumina wall
- Kovar getter flange
- HiTemp, CuSil brazed anode
- InCuSil braze alloy (750°C braze)
- Avoids remelt of anode CuSil
- Four braze joints in final assembly

Graphic courtesy of Jason McPhate, SSL

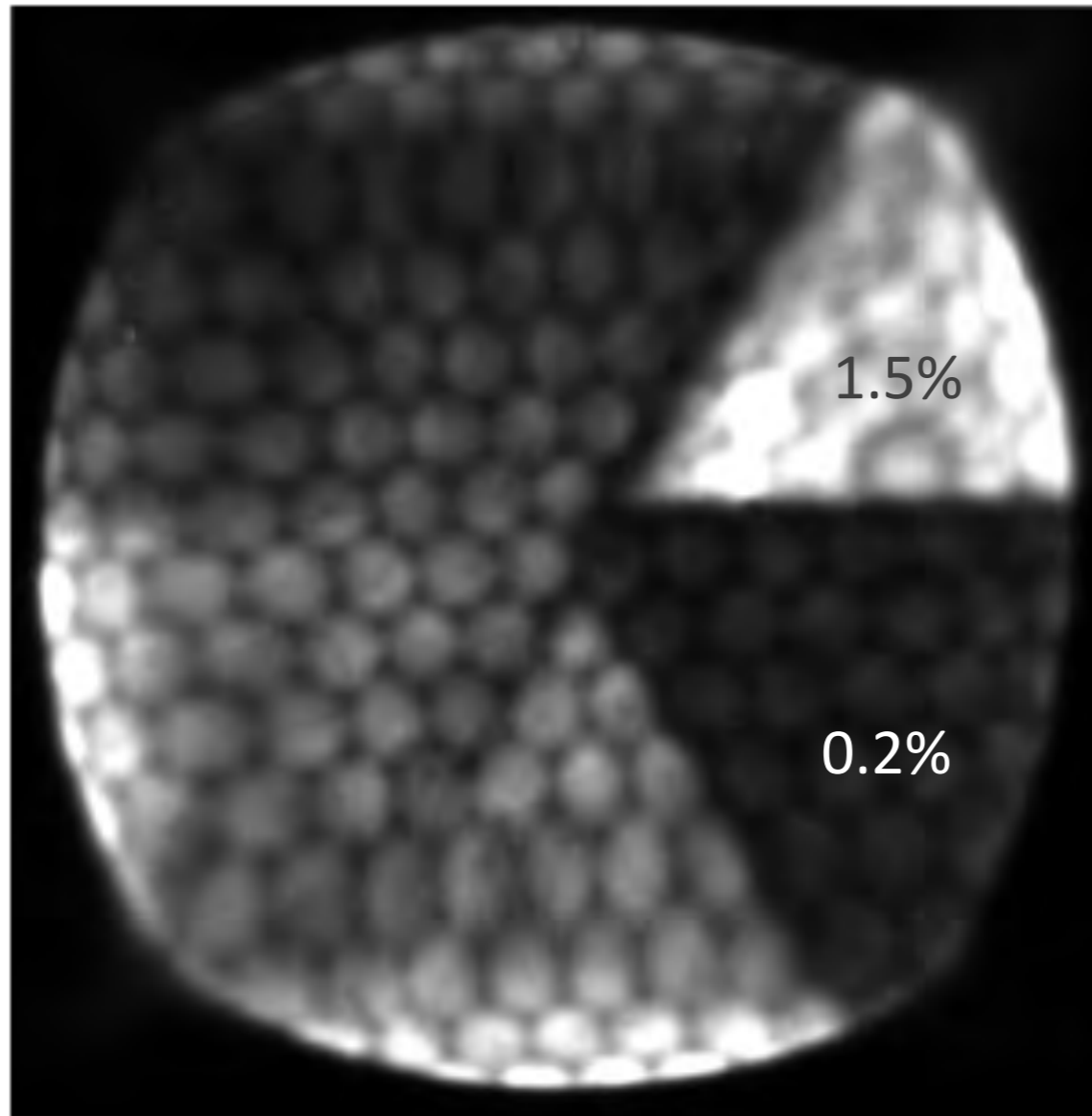


Illustrative Tube Stack

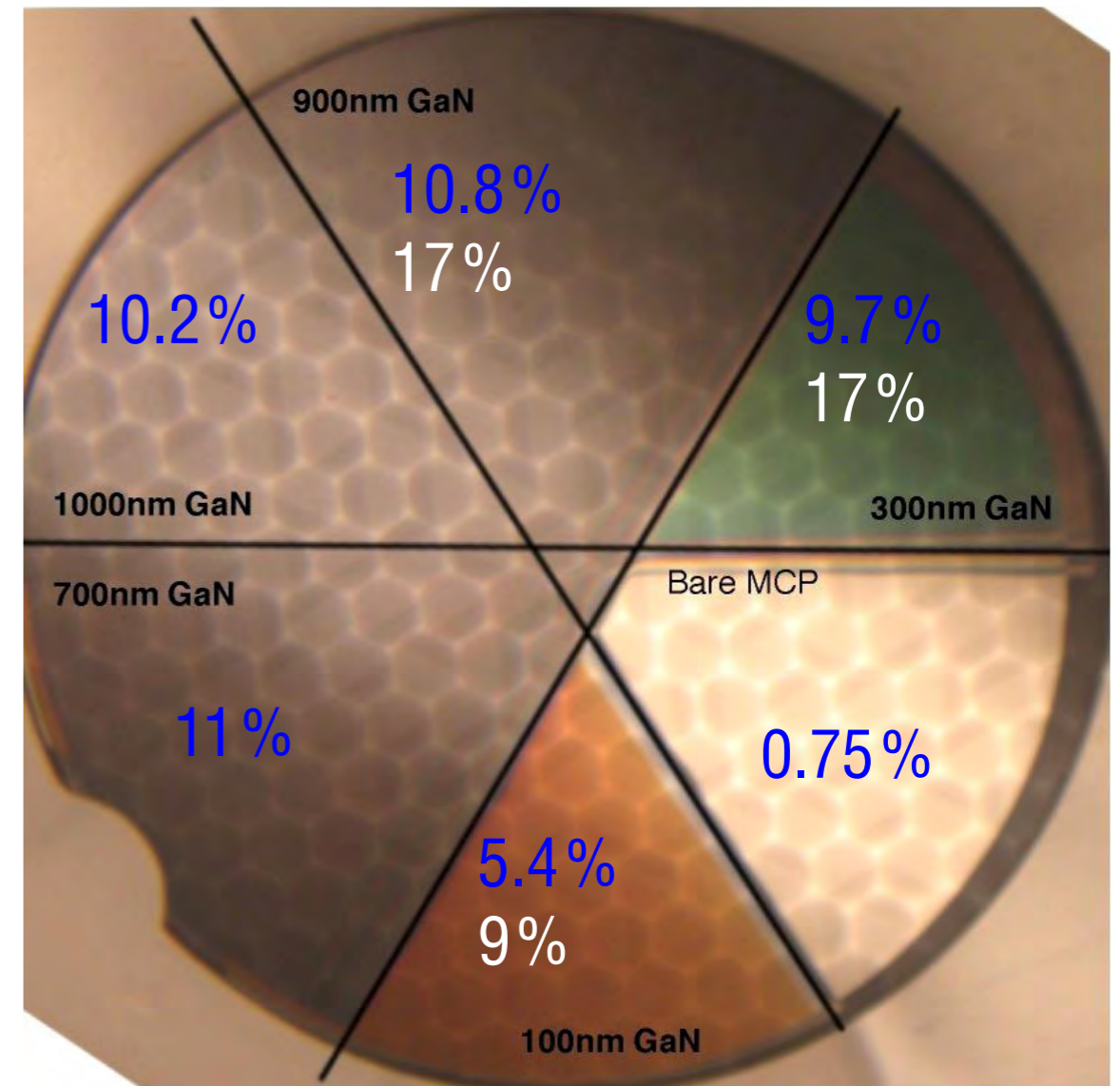
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Opaque GaN Deposited on 33mm ALD MCP

Borosilicate/ALD MCP coated by MBE with P-doped GaN/AlN of various thicknesses (amorphous/polycrystalline) and tested in a photon counting imaging detector

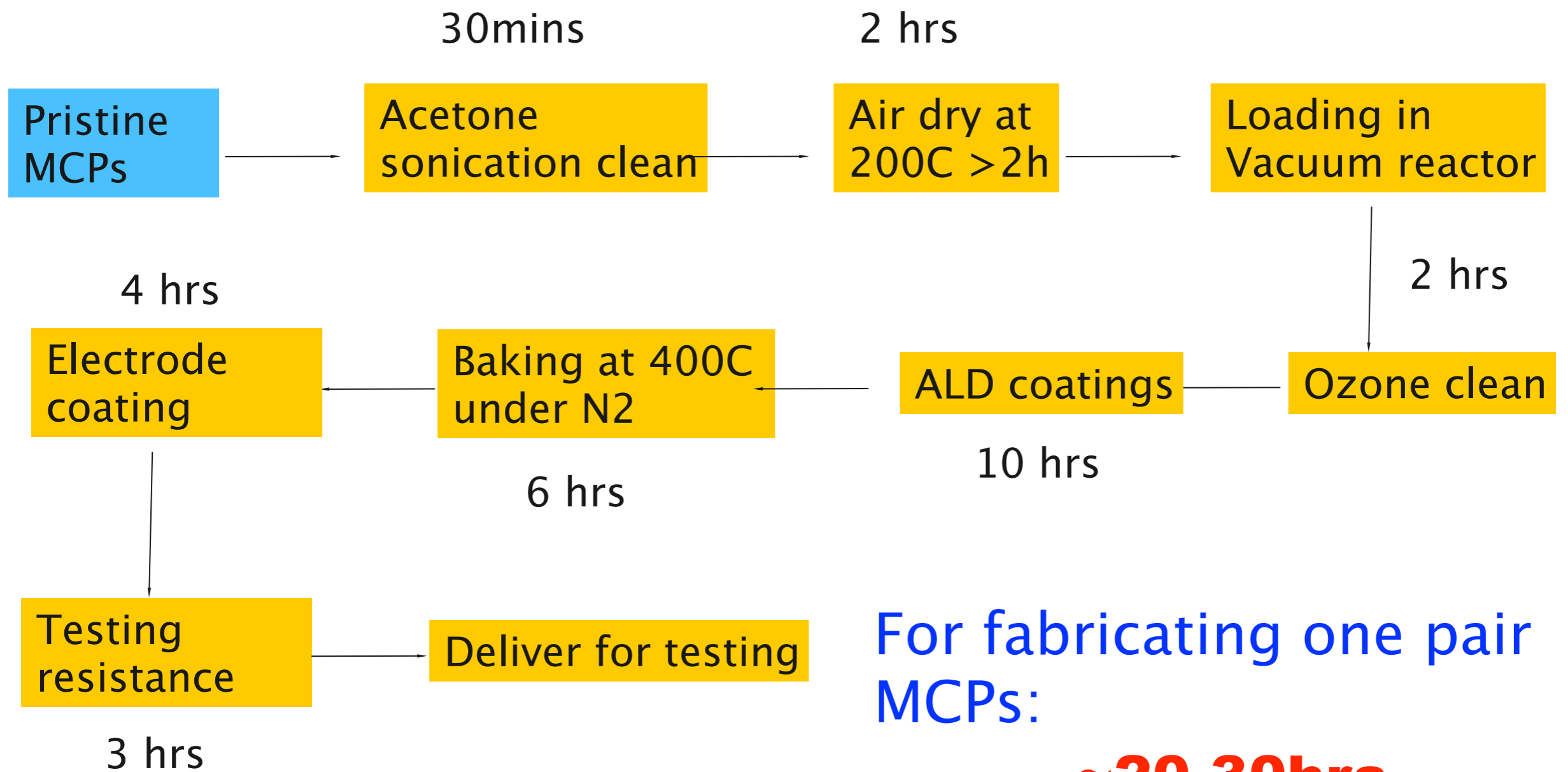


Integrated photon counting image using 184 nm UV shows unprocessed GaN layer response vs bare MCP.



QEs (@214nm UV) measured after Cs. 10° (blue) or 45° (white) graze angle. Typical QE- thickness asymptote for opaque cathode.

General procedures for Fabrication of MCPs



For fabricating one pair MCPs:

~20-30hrs

if everything is right

courtesy Qing Peng, Argonne ALD Group